
Universal Serial Bus 2.0 Hub Compliance Test Procedure

Introduction

The USB-IF Hi-Speed Electrical Test Procedures are developed by the USB 2.0 Compliance Committee under the direction of USB-IF, Inc. There are three Hi-Speed Electrical Test Procedures.

- The Host Hi-Speed Electrical Test Procedure is for EHCI host controllers.
- The Hub Hi-Speed Electrical Test Procedure is for hi-speed capable hubs.
- The Device Hi-Speed Electrical Test Procedure is for hi-speed capable devices.

The Hi-Speed Electrical Compliance Test Procedures verify the electrical requirements of hi-speed USB operation of these devices designed to the USB 2.0 specification. In addition to passing the hi-speed test requirements, hi-speed capable products must also complete and pass the applicable legacy compliance tests identified in these documents in order to be posted on the USB-IF Integrators List and use the USBIF logo in conjunction with the said product (if the vendor has signed the USB-IF Trademark License Agreement). These legacy compliance tests are identified in the Appendix B Legacy USB Compliance Test s section in this document.

Purpose

This USB-IF Hi-Speed Electrical Test Procedure documents a series of tests used to evaluate USB peripherals and systems operating at high speed. These tests are also used to evaluate the Hi-Speed operation of USB silicon that has been incorporated in ready-to-ship products, reference designs, proofs of concept and one of a kind prototypes of peripherals, add-in cards, motherboards, or systems. This test procedure makes reference to the test assertions in the USB-IF USB 2.0 Electrical Test Specification, Version 1.00.

This Hub Hi-Speed Electrical Test Procedure is one of the three USB-IF Hi-Speed Electrical Compliance Test Procedures. The other two are the Host Hi-Speed Electrical Test Procedure and Device Hi-Speed Electrical Test Procedure. The adoption of the individual procedures based on the device class makes it easier to use.

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Revisions

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1. Equipment Required

The commercial test equipment listed here are base on positive experiences by the USB-IF members in executing the USB Hi-Speed electrical tests. This test procedure is written with a set of specific models that were used to develop this procedure. In time, there will be other equivalent or better test equipment suitable for use. Some minor adaptation of the procedure will be required in those cases.

Digital Oscilloscope System

- Yokogawa DL9240 or DL9240L
(* Requires the either /C8 or /C10 main unit option, and either /P2 main unit option or the model 701934 probe power supply.)
- Yokogawa PBA2500 Probe: qty = 2
(for the Legacy USB Compliance Test: qty = 3)
- Yokogawa PBA2500 Probe and its attachment: qty = 2sets
(for the Legacy USB Compliance Test: qty = 3sets)
- Yokogawa PBD2000 Probe: qty = 2
- Yokogawa PBD2000 Probe and its attachment: qty = 2sets
- Yokogawa 701932 or 701933 Current Probe: qty = 1 (Legacy USB Compliance Test)
- Yokogawa PB500 Passive Probe: qty = 2 (Legacy USB Compliance Test)

3 ½ Digital Multimeter

- Yokogawa Meter & Instrument 733 or 734, or equivalent
- Mini-clip DMM lead, one each in black and red

Digital Signal Generator (Either One or the Other can be used)

- 81130A Pulse/Pattern Generator (Agilent)
 - The DSG consists of an Agilent 81130A Pulse/Pattern Generator with 2 channels of Agilent 81132A (660 MHz) option.
 - 1 MB Memory card option for 81130A (option UFJ)
 - 6 dB attenuator (Agilent 8493C opt 006) for scaling the DSG output voltages needed for the receiver sensitivity test, qty = 2
 - 50-ohm coaxial cable with SMA connectors at both ends (Agilent 8120-4948 or equivalent), qty = 2

The device referred to in this manual is the Tektronix DG2040 Data Generator
- DG2040 Digital Signal Generator (Tektronix)
 - 5×attenuator - for scaling the DSG output voltage needed for receiver sensitivity test, qty =2
 - 50-ohm coaxial cable with SMA connectors at both ends, qty =2

Hi-Speed USB Electrical Test Fixtures

- Yokogawa USB 2.0 Test Fixture, qty =1
- 5 V Test Fixture Power Supply, qty =1 (* included with Yokogawa USB 2.0 Test Fixture)

Miscellaneous Cables

- 1 m USB-IF compliant USB cable, qty = 1
(for the Legacy USB Compliance Test: qty = 5)
- 5 m USB-IF compliant USB cable, qty = 6 (Legacy USB Compliance Test)
- Modular AC power cord, qty = 1

Hi-Speed USB Test Bed Computer

This is the computer that hosts a USB 2.0 compliance host controller for the Hi-Speed hub or device electrical test, or serves as a test bed host for a USB 2.0 host controller under test. The OS on this computer is Windows 2000 or XP Professional. Please refer to the Hi-Speed Electrical Test Setup Instruction for steps to configure this computer.

USB Hub (Legacy USB Compliance Test)

- Full-Speed USB-IF compliant USB Hub, qty = 1
- Hi-Speed USB-IF compliant USB Hub, qty = 3

USB Device

- Full-Speed USB-IF compliant PC Camera, qty = 1 (Legacy USB Compliance Test)
- USB-IF compliant Mouse, qty = 1 (Legacy USB Compliance Test)
- USB-IF compliant High-Speed Device, qty = 1

1.1. Equipment Setup

1.1.1. DL9240/DL9240L Digital Oscilloscopes

1. Connect the PBD2000 Differential Probe to CH1 of the oscilloscope.
2. Place the attachment on the tip of the differential probe.
3. Connect the PBA2500 Active Probe to CH2 and CH3 of the oscilloscope.
4. Turn ON the power to the oscilloscope and allow a 30-minute warm-up prior to use.

1.1.2. Differential Probe

For information on adjusting the offset voltage remaining after warm-up (residual offset voltage), see "PBD2000 Differential Probe User's Manual" (IM701923-01E).

Note

- In certain test situations, there may not be a ground connection between the oscilloscope and the hub under test (DUT). This may lead to the signal being seen by the differential probe to be modulated up and down due to the mid-frequency switching power supply. Connecting the oscilloscope ground to the hub under test (DUT) ground will be required to establish a common ground reference.
 - Phase-correct the probe if necessary.
-

1.1.3. Pulse/Pattern Generator

The Pulse/Pattern Generator is necessary to perform the receiver sensitivity test. For energy conservation considerations, one may choose to turn on the Digital Signal Generator about 15 minutes prior to performing the measurement

1.2 Operating Systems, Software, Drivers, and Setup Files

1.2.1. Operating Systems

Microsoft Windows 2000 or XP Professional is required on the Hi-Speed Electrical Test Bed Computer. Please refer to the Hi-Speed Electrical Test Setup Instruction for steps to configure these computers.

1.2.2. Special Purpose Software

The following special purpose software is required.

- **Yokogawa USB Compliance Test Software (busXplorer-USB)**
To be used in the Hi-Speed Electrical Test Bed Computer.
- **Hi-Speed Electrical Test Tool Software (USBHSET)**
To be used in the Hi-Speed Electrical Test Bed Computer.

Note

Hi-Speed Electrical Test Tool (USBHSET) is official analysis tool of USB-IF and downloadable from the following USB-IF site.

<http://www.usb.org/developers/tools>

- **Proprietary EHCI Driver Stack**

The Hi-Speed Electrical Test Tool software requires the use of a proprietary EHCI driver stack. The use of this proprietary EHCI driver stack facilitates the electrical testing that requires direct control of the command registers of the USB EHCI host controllers. The end result much more robust test bed environment. Since the proprietary EHCI driver stack is designed for debug and test validation purposes, this driver stack does not support the normal functionality as found in the EHCI drivers from Microsoft (or the device vendor). An automatic driver stack switching function has been implemented into the Hi-Speed Electrical Test Tool for easy switching between the proprietary EHCI driver stack and that from Microsoft. Upon invocation of the HS Electrical Test Tool software, the driver stack will automatically switch to the Intel proprietary EHCI driver stack. Upon exit of the HS Electrical Test Tool software, the driver stack will automatically switch to the Microsoft EHCI driver stack.

- **USB Electrical Analysis Tool (USBET)**

To be used in the Hi-Speed Electrical Test Bed Computer.

Note

USBET is official analysis tool of USB-IF and downloadable from the following USB-IF site.

<http://www.usb.org/members/compliance>

(USBET is available only for member of USB-IF.)

Please refer to the Appendix C USB Electrical Analysis Tool (USBET) for details.

Please refer to the Hi-Speed Electrical Test Setup Instruction for steps to configure these computers.

1.2.3. Test Equipment Setup Files

Setup file for DL9240/DL9240L is available at the following site.

http://www.usb.org/developers/docs#comp_test_procedures

No setup file is needed for DL9240/DL9240L if the Yokogawa USB Compliance Test Software (busXplorer-USB, Type 701985/F30) is installed on the Test Bed Computer

Setup file for DG2040 can be obtained by extracting 'USBHSET.EXE'.

For details about 'USBHSET.EXE', please refer to the following web site.

http://www.usb.org/developers/docs#comp_test_procedures

2. Test Procedures

2.1. TEST Record

Appendix A contains the test result entry form for this test procedure. Please make copies of Appendix A for use as test record documentation for compliance test submission. All fields must be filled in. Fields not applicable for the device under test should be indicated as N/A, with an appropriate note explaining the reason. The completed test result shall be retained for the compliance test submission.

In addition to the hardcopy test record, the electronic files from the signal quality, and power delivery (inrush, drop and droop) shall be retained for compliance test submission.

2.2. Vendor and Product Information

Collect the following information and enter into a copy of the test record in Appendix A before performing any tests.

1. Test date
2. Vendor name
3. Vendor address, phone number, and contact name
4. Test submission ID number
5. Product name
6. Product model and revision
7. USB silicon vendor name
8. USB silicon model
9. USB silicon part marking
10. USB silicon stepping
11. Test conducted by

2.3. Hi-Speed Mode Compatible Device Electrical Tests

Perform the following twelve tests.

- Hub Hi-Speed Signal Quality, Upstream Facing Port (EL_2, EL_46, EL_6, EL_7)
- Hub Hi-Speed Signal Quality, Downstream Facing Port (EL_2, EL_3, EL_6, EL_7)
- Hub Jitter, Downstream Facing Ports (EL_47)
- Hub Disconnect Detect (EL_36, EL_37)
- Hub Packet Parameters, Upstream Facing Port (EL_21, EL_22, EL_25)
- Hub Receiver Sensitivity, Upstream Facing Port (EL_16, EL_17, EL_18)
- Hub Repeater Test, Downstream Facing Ports (EL_42, EL_43, EL_44, EL_45, EL_48)
- Hub Repeater Test, Upstream Facing Port (EL_42, EL_43, EL_44, EL_45)
- Hub CHIRP Timing, Upstream Facing Port (EL_28, EL_29, EL_31)
- Hub Suspend/Resume/Reset Timing, Upstream Facing Port (EL_27, EL_28, EL_38, EL_39, EL_40)
- Hub Test J/K, SE0_NAK, Upstream Facing Port (EL_8, EL_9)
- Hub Test J/K, SE0_NAK, Downstream Facing Ports (EL_8, EL_9)

Perform all these tests and record the measurements and summarized PASS/FAIL status in Appendix A.

2.4. Legacy USB Compliance Tests

In addition to the hi-speed electrical tests described in this document, the device under test must also pass the following compliance tests applicable to hi-speed capable devices:

- Upstream Inrush current
- Downstream Droop
- Drop
- Downstream Full speed/Low Speed signal quality
- Upstream Full speed signal quality
- Backdrive Voltage
- Interoperability
- Average Current Draw
- Device Framework

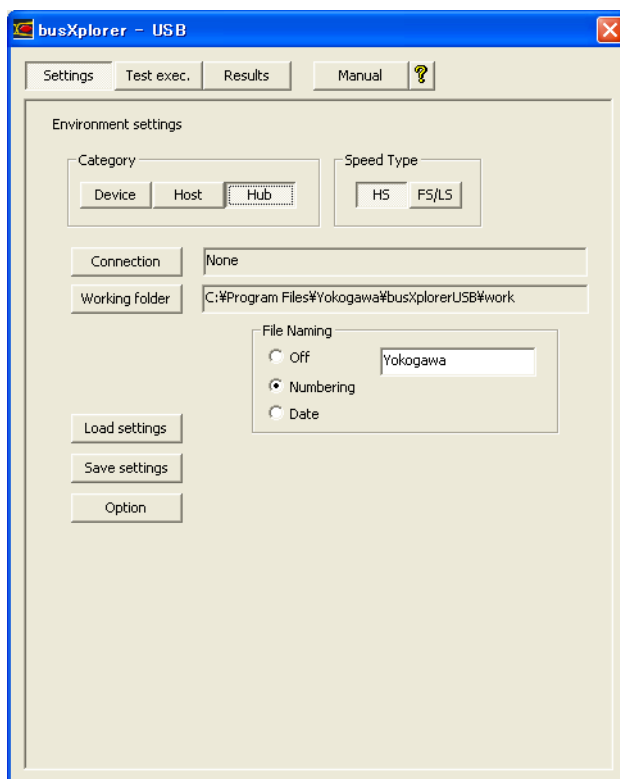
Perform all these tests and record the measurements and summarized PASS/FAIL status in Appendix A.

Note

This manual describes Hi-Speed electrical tests and legacy USB compliance tests(Appendix B Legacy USB Compliance Test), but does not describe interoperability test, average current draw test, and device framework test. For these test procedures, see “USB-IF Full and Low Speed Compliance Test Procedure” (available at: <http://www.usb.org/developers/>) issued by the USB-IF.

2.5. Starting the USB Compliance Test Software

1. Start the busXplorer-USB.
The environment settings dialog box as shown below opens.

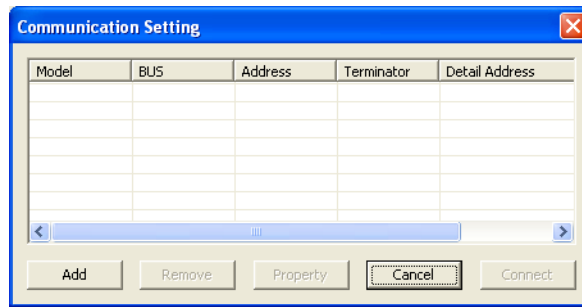


Note

This manual does not describe all of the functions of the busXplorer-USB. For functions not described herein (such as operation of the results display button), see "USB Compliance Test Software busXplorer-USB User's Manual" (IM701985-61E).

2. Click the **[Hub]** button under Test Category in the environment settings.
3. Select the test items to execute under Speed Type according to the hub under test(DUT).
 - Select HS and execute the test. All electrical tests are performed.
 - If you select FS/LS and execute the test, only the tests required for FS/LS are executed.
4. Connect the test bed computer and digital oscilloscope via Ethernet.
5. Turn ON the power to the digital oscilloscope.

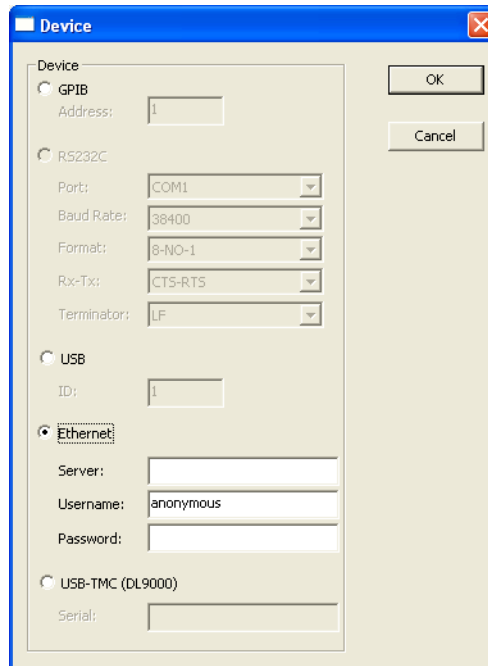
-
6. Click the **[Connection]** button in the dialog box.
The connection settings dialog box is displayed.



Note

If connection destinations are already registered, they are displayed in a list. If the digital oscilloscope to use appears in the list, select it, then click the **[Connect]** button to start establishing communication with the digital oscilloscope.

7. Click the **[Add]** button.
The connection method selection dialog box in the figure below opens.



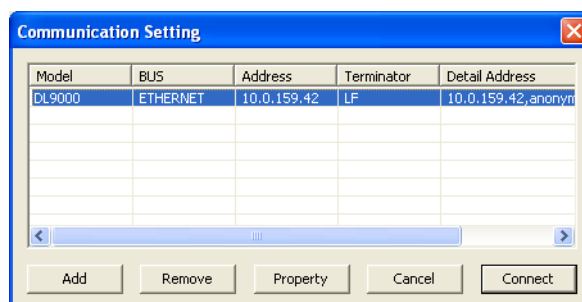
Note

The busXplorer-USB supports Ethernet only.

8. Select Network, enter the IP address of the digital oscilloscope in the Server box, then click the **[OK]** button.
Enter the user name and password if required.

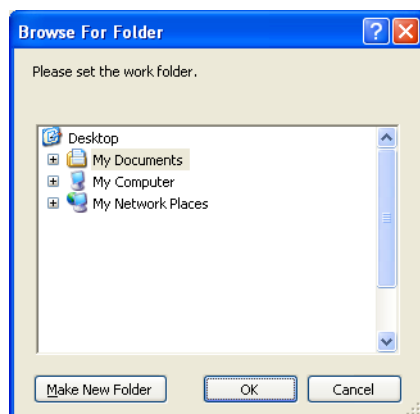
9. A connection settings dialog box is displayed. Select the digital oscilloscope then click the **[Connect]** button.

- If you select a connection destination in the list and click Properties, the connection method selection dialog box appears allowing you to change settings.
- If you select a connection destination in the list and click Delete, the selected connection destination is deleted.
- The maximum number of connection destinations that can be registered is 16.



10. Click the **[Working folder]** button.

A dialog box for browsing folders is displayed.



11. Specify a working folder and click the **[OK]** button.

The following data are saved in the working folder.

- Test results files in HTML format
These are displayed by clicking the [Detail] button in the test results display dialog box.
- Digital oscilloscope screen image data
These are displayed by clicking the [Image] button in the test results display dialog box.
- Waveform data captured by Digital oscilloscope

File names are automatically assigned to data files. To set a file name, choose Fix in the File Naming box, and enter a file name in the box (of up to twenty alphanumeric characters).

Note

- Environment settings can be saved and recalled. To save settings, click the [Save settings] button to display a dialog box for entering a file name and save location. To load settings, click the [Load settings] button to display a dialog box for opening previously saved settings files.
- To save or change the display color or format of the waveform data displayed by the busXplorer-USB, click the [Option] button, then modify settings as needed.

2.6. Hub Hi-Speed Signal Quality, Upstream Facing Port (EL_2, EL_46, EL_6, EL_7)

- **USB 2.0 Electrical Test Specification**

- EL_2

A USB 2.0 Hi-Speed transmitter data rate must be 480 Mb/s $\pm 0.05\%$.

- EL_46

A hub upstream repeater must meet Template 1 transform waveform requirements measured at TP3.

- EL_6

A USB 2.0 HS driver must have 10% to 90% differential rise and fall times of greater than 500ps.

- EL_7

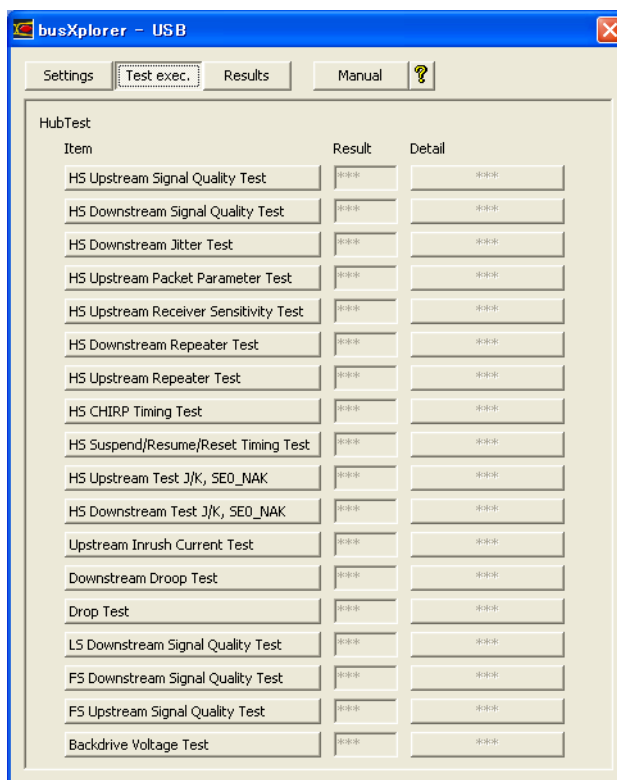
A USB 2.0 HS driver must have monotonic data transitions over the vertical openings specified in the appropriate eye pattern template.

- **Instruments Used**

Name	Q'ty
DL9240/DL9240L Digital Oscilloscope	1
PBD2000 Differential Probe	1
PBD2000 Probe attachment	1 set
USB-IF compliant 1 m USB 2.0 cable	1
Test bed computer	1
USB compliance test fixture	1
5 V power supply for test fixture	1

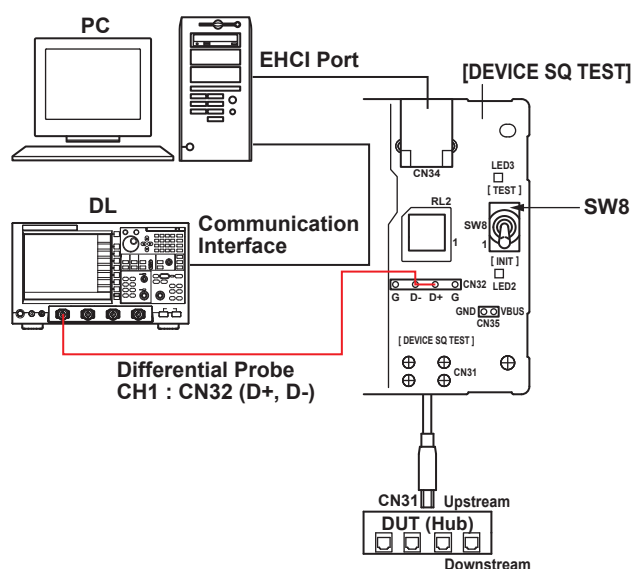
- **Executing the Test**

1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



- Click the **[HS Upstream Signal Quality Test]** button in the dialog box.
The Hub HS Upstream Signal Quality Test dialog box is displayed.

- Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.
- If necessary, enter a comment for the test in Comment text box.
The comment is saved together with test results and displayed in the Test Result Dialog box.
- Click the **[Next]** button in the dialog box of the busXplorer-USB.
The connection diagram as shown below is displayed.

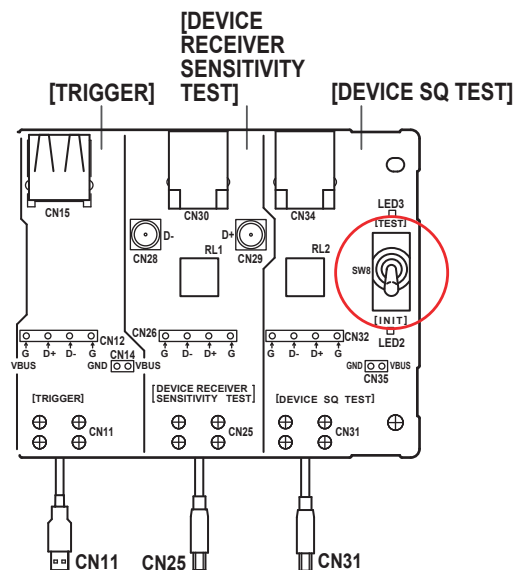


6. Turn ON the power to the hub under test(DUT).
7. Turn ON the power to the test fixture and verify that the green power supply LED1 is lit.
8. Connect the CN31 connector of the DEVICE SQ TEST block to the upstream port of the DUT.
9. Connect the test bed computer to the CN34 connector of the DEVICE SQ TEST block using a 1 m USB cable.
10. Connect the PBD2000 Differential Probe to CH1 of the digital oscilloscope.

Note

After connecting the probe, heat emitted from the probe causes the offset voltage to drift. The probe should nearly stabilize about thirty minutes after applying power.

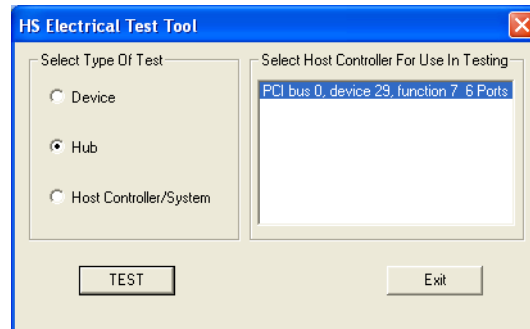
11. Connect the differential probe to the attachment on the tip to CN32 on the DEVICE SQ TEST block.
For the polarity, match up the plus side on the differential probe to D+ (the D+ pin at CN32) and the minus side to D- (the D- pin at CN32).
12. Click the **[Next]** button in the dialog box of the busXplorer-USB. Following the instructions displayed in the dialog box, place SW8 of the test fixture to the INIT position.
Verify LED2 of the test fixture is lit.



13. Click the **[Next]** button.

Following the instructions in the dialog box of the busXplorer-USB, invoke the HS Electrical Test Tool on the test bed computer.

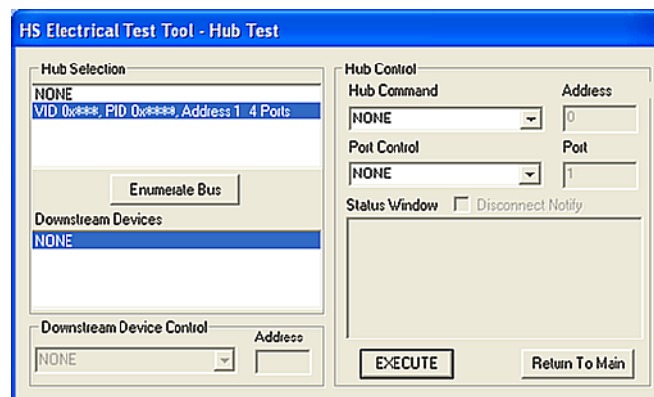
The HS Electrical Test Tool main menu is displayed, and the host controller is displayed under Select Host Controller For Use in Testing.



14. Select Hub under Select Type Of Test in the HS Electrical Test Tool.

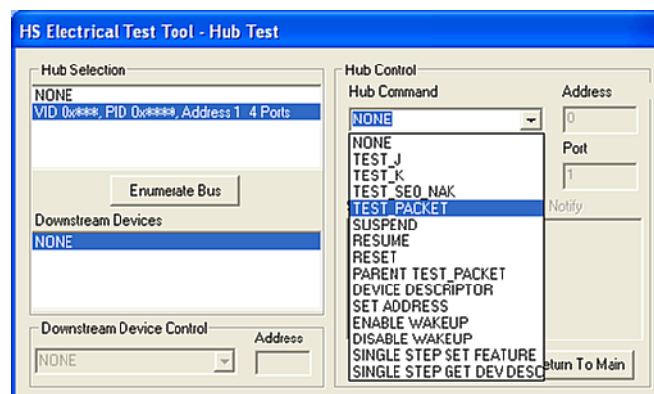
15. Click the **[TEST]** button in the HS Electrical Test Tool to enter the HS Electrical Test Tool - Hub Test menu.

16. Click the **[Next]** button in the dialog box of the busXplorer-USB, confirm that the VID, PID, connected address, and port of the DUT are displayed under Hub Selection of the HS Electrical Test Tool.

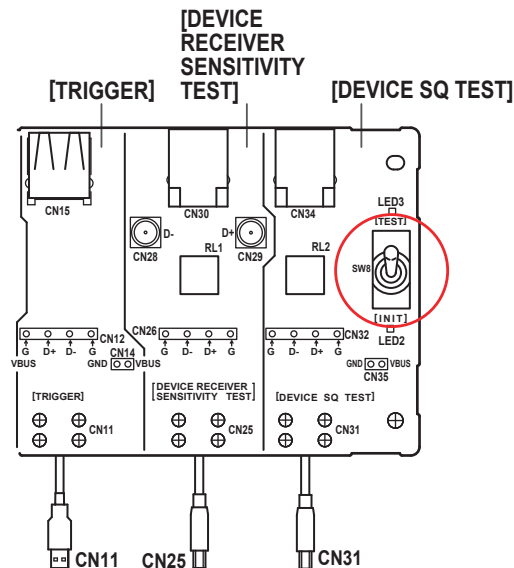


17. Click **[Next]** button in the dialog box of the busXplorer-USB.

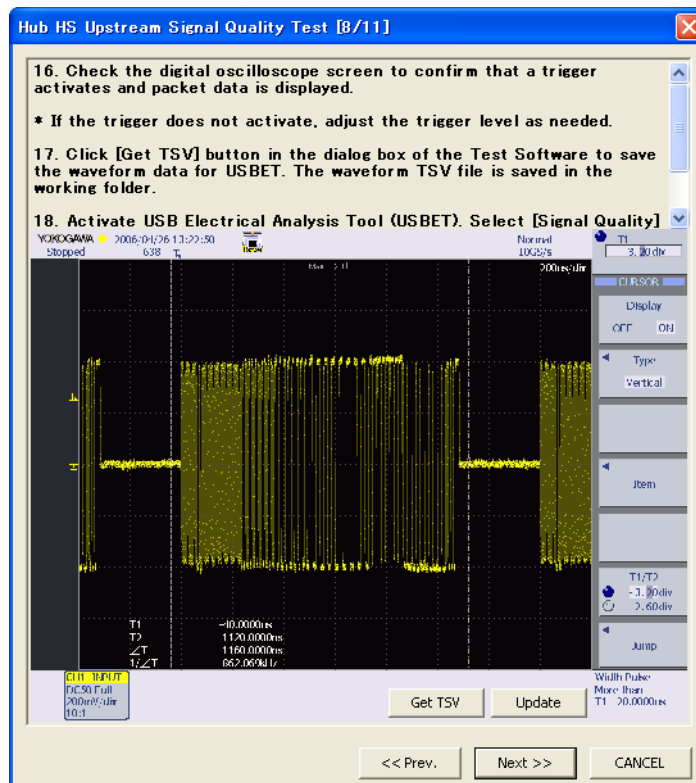
Following the instructions in the dialog box, select TEST PACKET from the Hub Command drop down menu in the HS Electrical Test Tool then click the **[EXECUTE]** button.



- 18.** Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, place SW8 of the test fixture to the TEST position.
Verify LED3 of the test fixture is lit.



- 19.** Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, check the digital oscilloscope screen to confirm that a trigger activates and packet data is displayed.
- If the trigger does not activate, adjust the trigger level as needed.
 - Click the **[Update]** button to update the image of waveform in the dialog box of the busXplorer-USB.



20. Click **[Get TSV]** button in the dialog box of the Test Software to save the waveform data for USBET. The waveform TSV file is saved in the working folder.

21. Activate 'USB Electrical Analysis Tool (USBET)'.

Select **[Signal Quality]** tab, click **[Browse]** button of USBET and specify the waveform data file (tsv file).

Set an appropriate Test Type (HSNE) then click **[TEST]** to start analysis.

Check the test report generated by USBET and verify the result of the test.

Note

To know how to use USBET, please refer to Appendix C of this document.

22. Click **[Next]** button in the dialog box of the busXplorer-USB.

Following the instructions in the dialog box, using zoom/cursor functions of oscilloscope, measure rise/fall time (10-90%) of the waveform and record the values to input text fields in the dialog box. They must be more than 500ps.

When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.

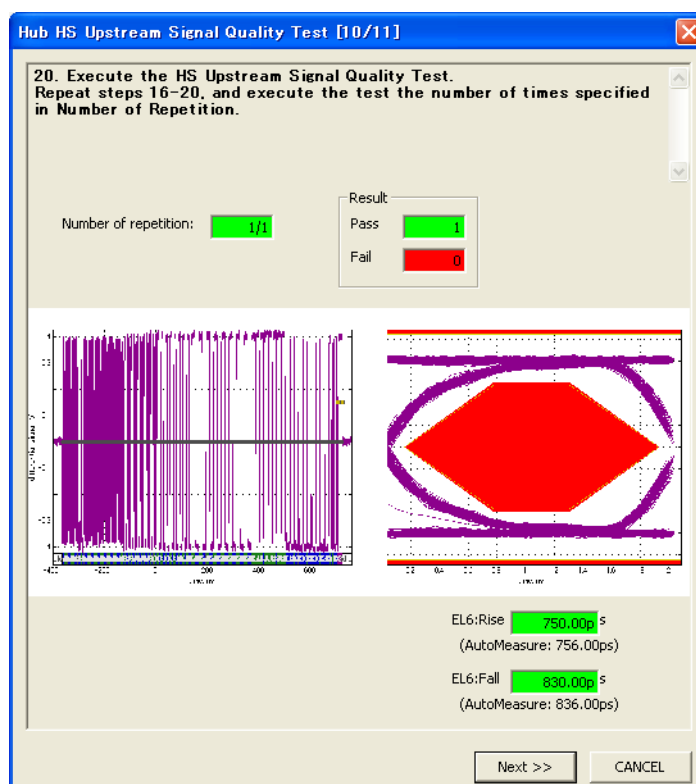
Hub HS Upstream Signal Quality Test [9/11]

19. Using zoom/cursor functions of oscilloscope, measure rise/fall time of the waveform and record the values to input text fields in the dialog box. They must be more than 500ps.

EL6:Rise	<input type="text" value="750.00p"/>	s	(AutoMeasure: 756.00ps)
EL6:Fall	<input type="text" value="830.00p"/>	s	(AutoMeasure: 836.00ps)

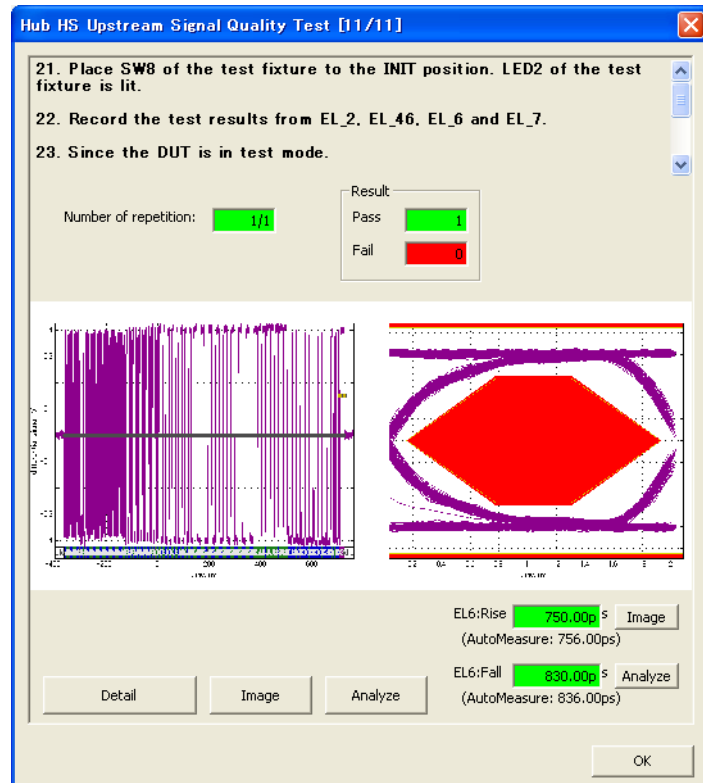
<< Prev. Next >> CANCEL

23. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box as shown below is displayed.



24. Click the **[Next]** button of the dialog box of the busXplorer-USB, repeat steps 19-23, and execute the test the number of times specified in "Number of Repetition."

When the number of tests is completed, the test result dialog box is displayed.



- Click the [Detail] button to display the test results by Internet Explorer as shown below.

Near End High Speed Signal Quality Test Results for Yokogawa_000

For details on test setup, methodology, and performance criteria, please consult the signal quality test description at the [USB-IF Compliance Program](#) web page.

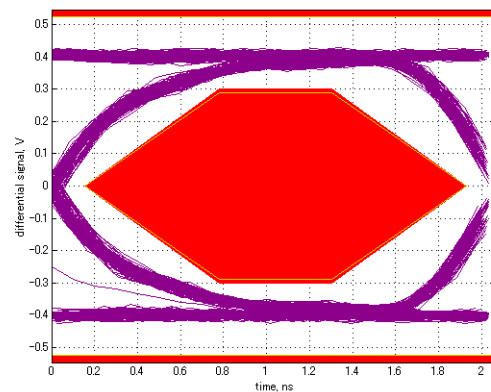
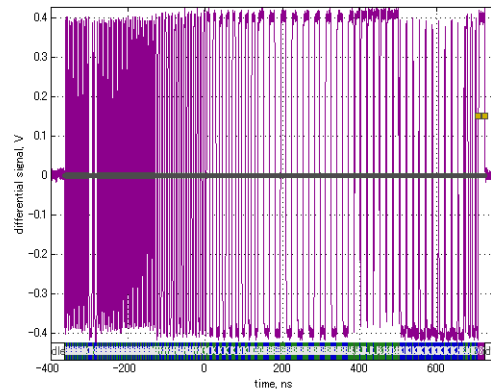
Required Tests

- Overall result: **pass!**
- Signal eye:
 - eye passes
- EOP width: 7.88 bits
 - EOP width passes
- Measured signaling rate: 479.9531 MHz
 - signal rate passes

Additional Information

- Consecutive jitter range: -49.745ps to 63.552ps, RMS jitter 22.503ps
 Paired JK jitter range: -27.563ps to 24.681ps, RMS jitter 12.433ps
 Paired KJ jitter range: -35.281ps to 25.094ps, RMS jitter 12.085ps

Signal Data and Eye



Tracking Information

- Voltage probes: default, gain accuracy: 1.5%
- Oscilloscope: default, A/D linearity: 1.0%
- Analysis call: usbsigcheck(C:\Program Files\Yokogawa\busXplorer USB\work\Device_HS_SignalQuality\Yokogawa_000.tsv, 'hsne', 1)
- Testing script version: 2.12

- Click the [Image] button to display an image of the digital oscilloscope screen.
- Click the [Analyze] button to start Xviewer and display the waveform data.
Xviewer must already have been installed.

Note

- Test result shown by Internet Explorer is saved in the directory specified as the working folder for the busXplorer-USB.
 - Test results can also be confirmed when displayed in the results display dialog box by clicking the results display button in the Test Software.
-

25. Place SW8 of the test fixture to the INIT position. LED2 of the test fixture is lit.

26. Record the test results in EL_2, EL_46, EL_6 and EL_7.

- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission
- All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.

27. Since the DUT is in test mode, power cycle the DUT in preparation for subsequent tests.

28. Remove the differential probe from the test fixture.

2.7. Hub Hi-Speed Signal Quality, Downstream Facing Port (EL_2, EL_3, EL_6, EL_7)

- **USB 2.0 Electrical Test Specification**

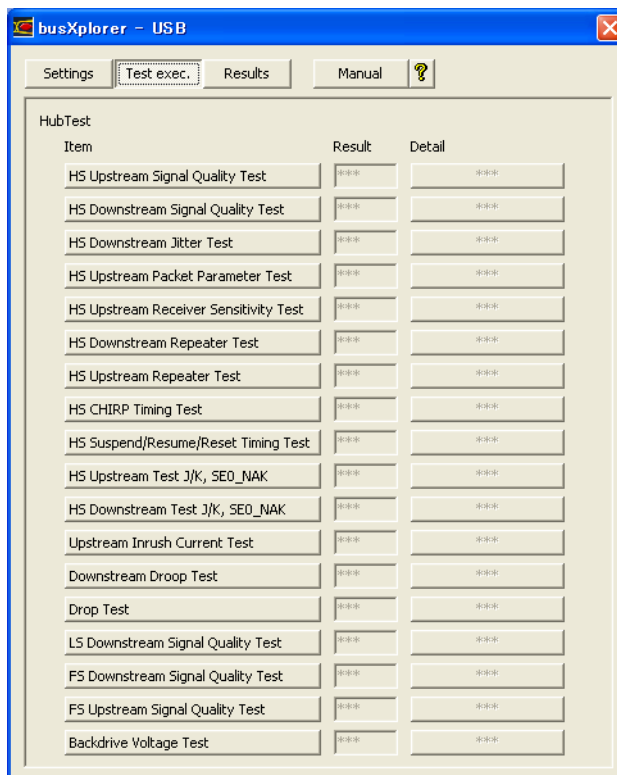
- EL_2
A USB 2.0 Hi-Speed transmitter data rate must be 480 Mb/s $\pm 0.05\%$.
- EL_3
A USB 2.0 downstream facing port must meet Template 1 transform waveform requirements measured at TP2 (each hub downstream port).
- EL_6
A USB 2.0 HS driver must have 10% to 90% differential rise and fall times of greater than 500ps.
- EL_7
A USB 2.0 HS driver must have monotonic data transitions over the vertical openings specified in the appropriate eye pattern template.

- **Instruments Used**

Name	Quantity
DL9240/DL9240L Digital Oscilloscope	1
PBD2000 Differential Probe	1
PBD2000 Probe attachment	1 set
USB-IF compliant 1 m USB 2.0	1
Test bed computer	1
USB compliance test fixture	1
5 V power supply for test fixture	1

- **Executing the Test**

1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



- Click the **[HS Downstream Signal Quality Test]** button in the dialog box. The Hub HS Downstream Signal Quality Test dialog box is displayed.

3. Enter the repeat number from 1(default) to 50 in the Number of Repetition input box.
4. If necessary, enter a comment for the test in Comment text box.
The comment is saved together with test results and displayed in the Test Result Dialog box.
5. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The connection diagram as shown below is displayed.

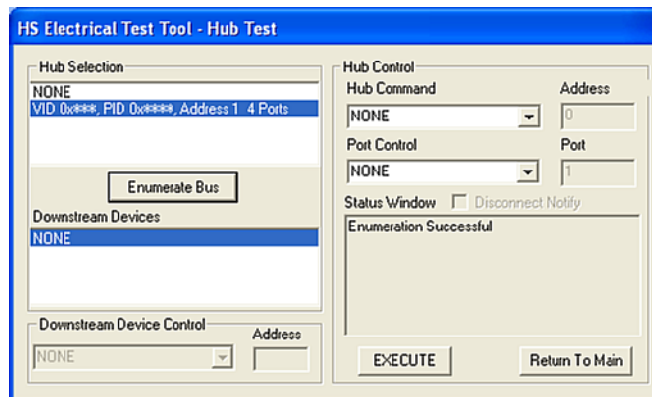
6. Turn ON the power to the DUT.
7. Connect the CN2 connector of the HOST SQ TEST block to the downstream port of the DUT.

8. Connect the test bed computer to the upstream port of the DUT using a 1 m USB cable.
9. Connect the PBD2000 Differential Probe to CH1 of the digital oscilloscope.

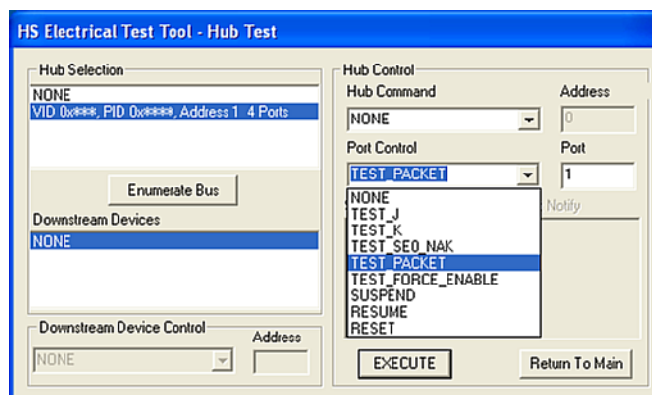
Note

After connecting the probe, heat emitted from the probe causes the offset voltage to drift. The probe should nearly stabilize about thirty minutes after applying power.

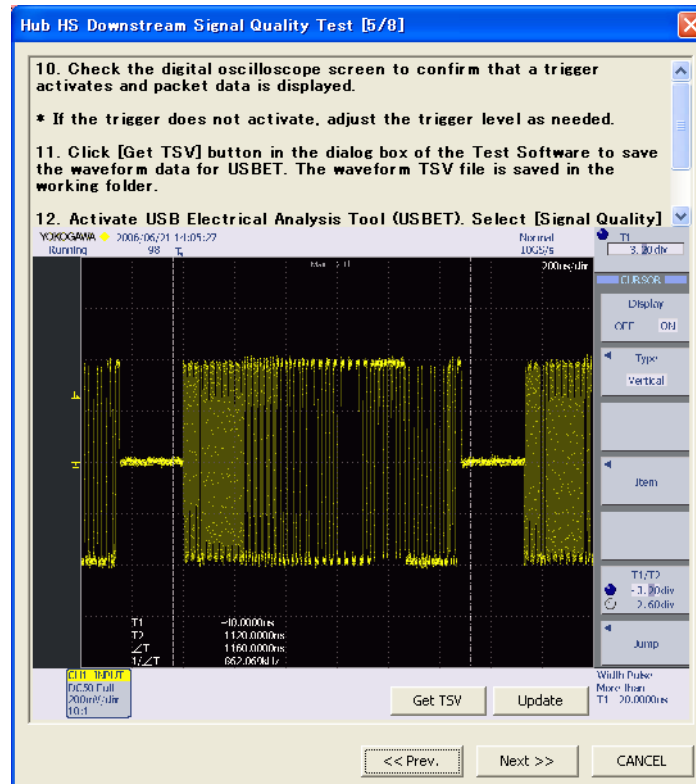
10. Connect the differential probe to the attachment on the tip to CN3 on the HOST SQ TEST block.
For the polarity, match up the plus side on the differential probe to D+ (the D+ pin at CN3) and the minus side to D- (the D- pin at CN3).
11. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, click the **[Enumerate Bus]** button in the HS Electrical Test Tool. Confirm that the VID, PID, connected address, and port of the DUT are displayed under Hub Selection .
If not already running, start the HS Electrical Test Tool. Select hub under SelectSelect Hub under Select Type of Test, click the TEST button, then confirm the above.



12. Click **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, select TEST PACKET from the Port Control drop down menu and set the target port number in the HS Electrical Test Tool then click the **[EXECUTE]** button.



13. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, check the digital oscilloscope screen to confirm that a trigger activates and packet data is displayed.
 - If the trigger does not activate, adjust the trigger level as needed.
 - Click the **[Update]** button to update the image of waveform in the dialog box of the busXplorer-USB.



14. Click **[Get TSV]** button in the dialog box of the Test Software to save the waveform data for USBET. The waveform TSV file is saved in the working folder.
15. Activate 'USB Electrical Analysis Tool (USBET)'.
Select **[Signal Quality]** tab, click **[Browse]** button of USBET and specify the waveform data file (tsv file).
Set an appropriate Test Type (HSNE) then click **[TEST]** to start analysis.
Check the test report generated by USBET and verify the result of the test.

Note

To know how to use USBET, please refer to Appendix C of this document.

-
- 16.** Click **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, using zoom/cursor functions of oscilloscope, measure rise/fall time (10-90%) of the waveform and record the values to input text fields in the dialog box. They must be more than 500ps.
When **[Next]** button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.

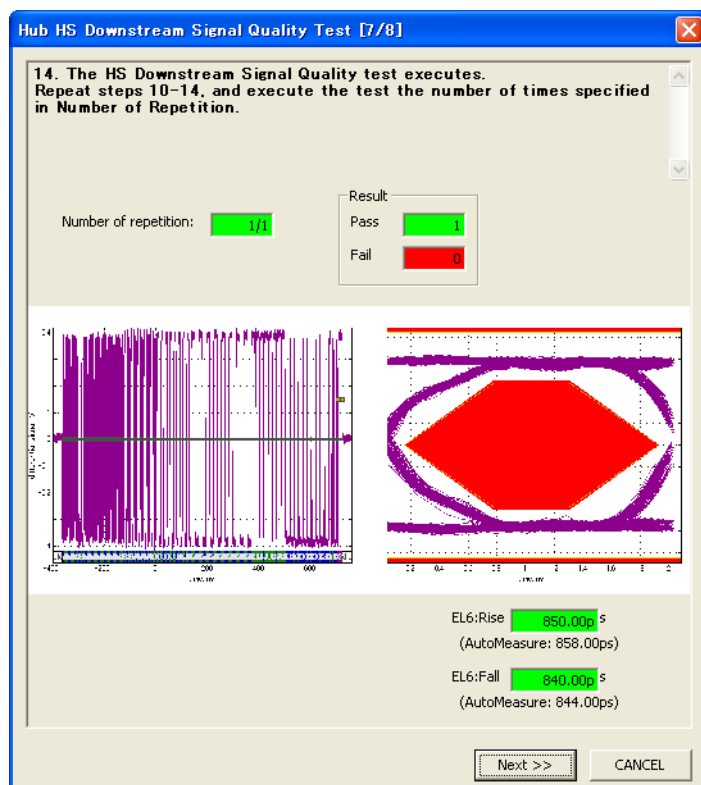
Hub HS Downstream Signal Quality Test [6/8]

13. Using zoom/cursor functions of oscilloscope, measure rise/fall time of the waveform and record the values to input text fields in the dialog box. They must be more than 500ps.

EL6:Rise	<input type="text" value="850.00p"/>	s	(AutoMeasure: 858.00ps)
EL6:Fall	<input type="text" value="840.00p"/>	s	(AutoMeasure: 844.00ps)

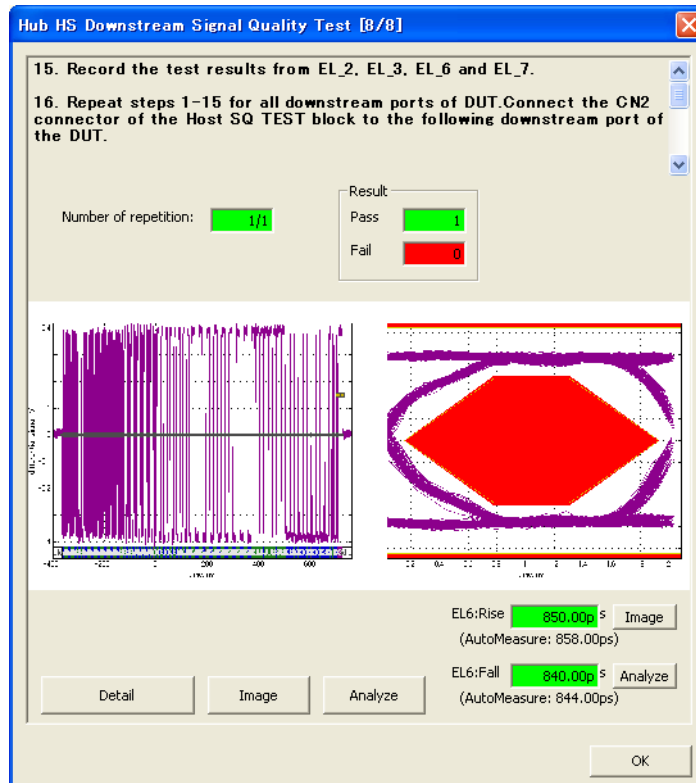
<< Prev. Next >> CANCEL

17. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box as shown below is displayed.



18. Click the **[Next]** button of the dialog box of the busXplorer-USB, repeat steps 13-17, and execute the test the number of times specified in “Number of Repetition.”.

When the number of tests is completed, the test result dialog box is displayed.



- Click the [Detail] button to display the test results by Internet Explorer as shown below.

Near End High Speed Signal Quality Test Results for Yokogawa_000

For details on test setup, methodology, and performance criteria, please consult the signal quality test description at the [USB-IF Compliance Program](#) web page.

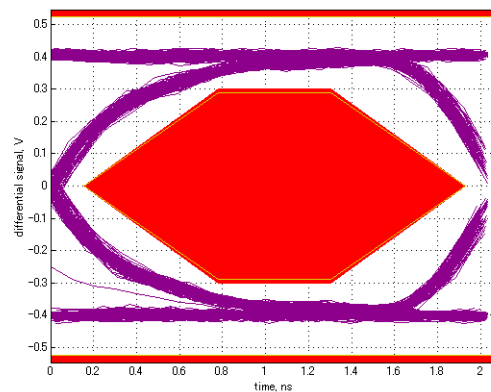
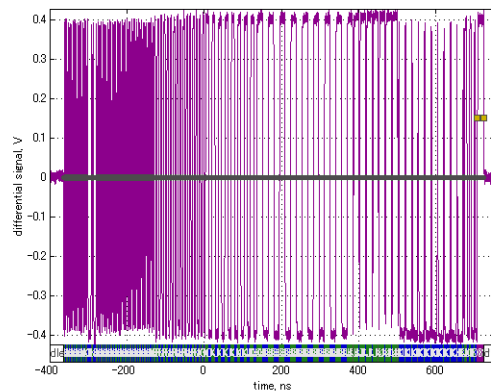
Required Tests

- Overall result: pass!
- Signal eye:
 - eye passes
- EOP width: 7.88 bits
- EOP width passes
- Measured signaling rate: 479.9531MHz
- signal rate passes

Additional Information

- Consecutive jitter range: -49.745ps to 63.552ps, RMS jitter 22.503ps
- Paired JK jitter range: -27.563ps to 24.681ps, RMS jitter 12.433ps
- Paired KJ jitter range: -35.281ps to 25.094ps, RMS jitter 12.085ps

Signal Data and Eye



Tracking Information

- Voltage probes: default, gain accuracy: 1.5%
- Oscilloscope: default, A/D linearity: 1.0%
- Analysis call: usbsigcheck(C:\Program Files\Yokogawa\busxplore\USB\work\Device_HS_SignalQuality\Yokogawa_000.tsv', 'hsne', 1)
- Testing script version: 2.12

- Click the [Image] button to display an image of the digital oscilloscope screen.
- Click the [Analyze] button to start Xviewer and display the waveform data.
Xviewer must already have been installed.

Note

- Test result shown by Internet Explorer is saved in the directory specified as the working folder for the busXplorer-USB.
 - Test results can also be confirmed when displayed in the results display dialog box by clicking the results display button in the Test Software.
-

19. Record the test results in EL_2, EL_3, EL_6 and EL_7.

- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission
- All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.

20. Repeat steps 2-19 for all downstream ports of DUT.

Connect the CN2 connector of the Host SQ TEST block to the following downstream port of the DUT.

Note

A specific port fails to enter TEST_PACKET mode after TEST_PACKET command has been issued to the hub a number of times. Cycle power on the hub and click [Enumerate Bus] will alleviate this problem.

21. When all downstream ports have been tested, power cycle the DUT to prepare for the next test.

2.8. Hub Jitter, Downstream Facing Ports (EL_47)

- **USB 2.0 Electrical Test Specification**

- EL_47

A hub downstream facing repeater must meet Template 1 transform waveform requirements measured at TP2 (each hub downstream port).

- **Instruments Used**

Name	Quantity
DL9240/DL9240L Digital Oscilloscope	1
PBD2000 Differential Probe	1
PBD2000 Probe attachment	1 set
USB-IF compliant 1 m USB 2.0 cable	1
Test bed computer	1
USB compliance test fixture	1
5 V power supply for test fixture	1

- **Executing the Test**

1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



-
2. Click the **[HS Downstream Jitter Test]** button in the dialog box. The Hub HS Downstream Jitter Test dialog box is displayed.

Hub HS Downstream Jitter Test [1/9]

1. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.

2. If necessary, enter a comment for the test in Comment text box. The comment is saved together with test results and displayed in the Test Result Dialog box.

Number of repetition:

Test Point

☐ Far End

☒ Near End

Comment:

Next >> CANCEL

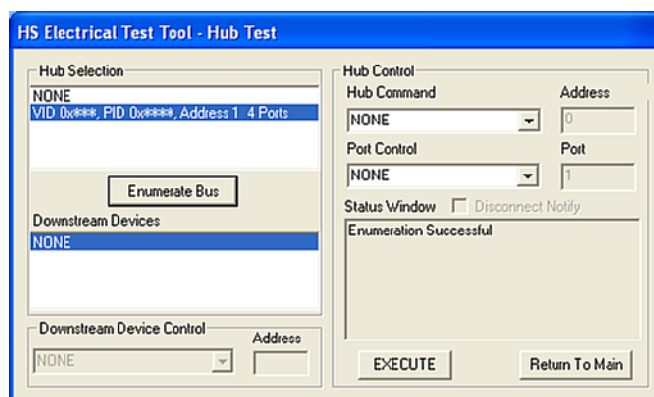
3. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.
4. If necessary, enter a comment for the test in Comment text box. The comment is saved together with test results and displayed in the Test Result Dialog box.
5. Click the **[Next]** button in the dialog box of the busXplorer-USB. Connect the upstream port of the DUT to the known good port of the test bed computer with a 1 m USB cable.

Note

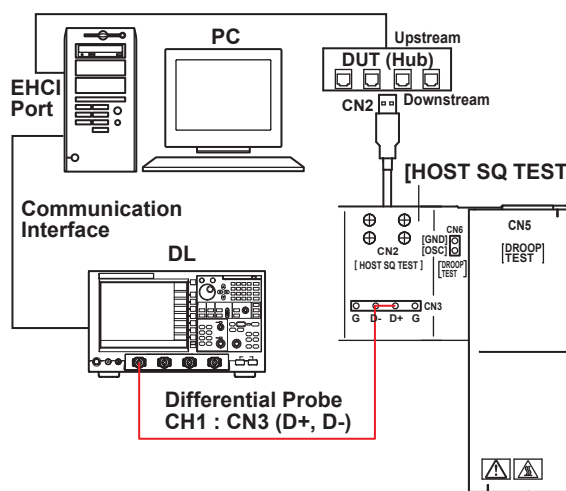
The known good high-speed root port should have excellent signal quality eye and minimum clock jitter. A host controller with poor eye quality or clock jitter will tend to negatively affect the result of the DUT.

6. Turn ON the power to the DUT.

7. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, click the **[Enumerate Bus]** button in the HS Electrical Test Tool. Confirm that the VID, PID, connected address, and port of the DUT are displayed under Hub Selection .
If not already running, start the HS Electrical Test Tool. Select Hub under Select Type of Test, click the TEST button.



8. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The connection diagram as shown below is displayed.



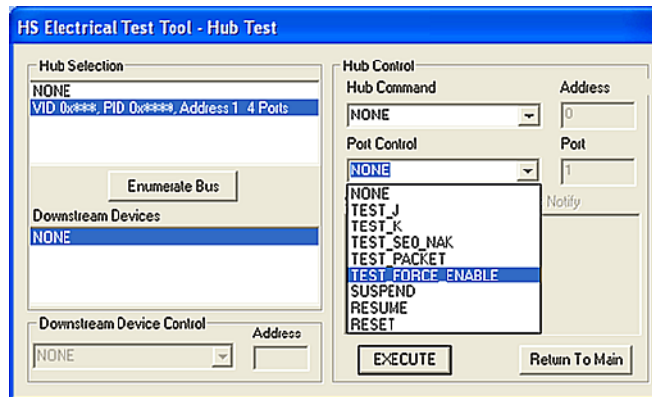
9. Connect the CN2 connector of the HOST SQ TEST block to the downstream port of the DUT.
10. Connect the PBD2000 Differential Probe to CH1 of the digital oscilloscope.

Note

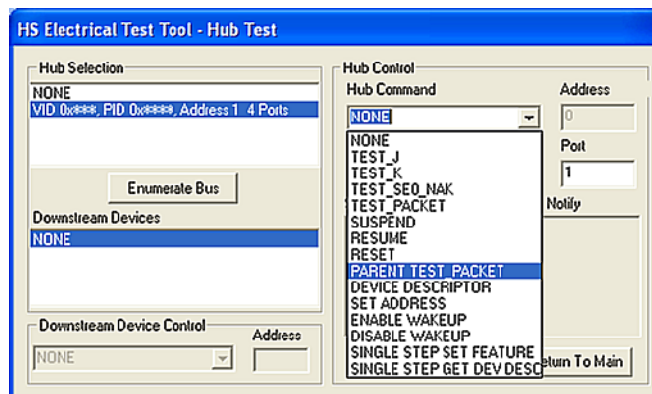
After connecting the probe, heat emitted from the probe causes the offset voltage to drift. The probe should nearly stabilize about thirty minutes after applying power.

11. Connect the differential probe to the attachment on the tip to CN3 on the HOST SQ TEST block.
For the polarity, match up the plus side on the differential probe to D+ (the D+ pin at CN3) and the minus side to D- (the D- pin at CN3).

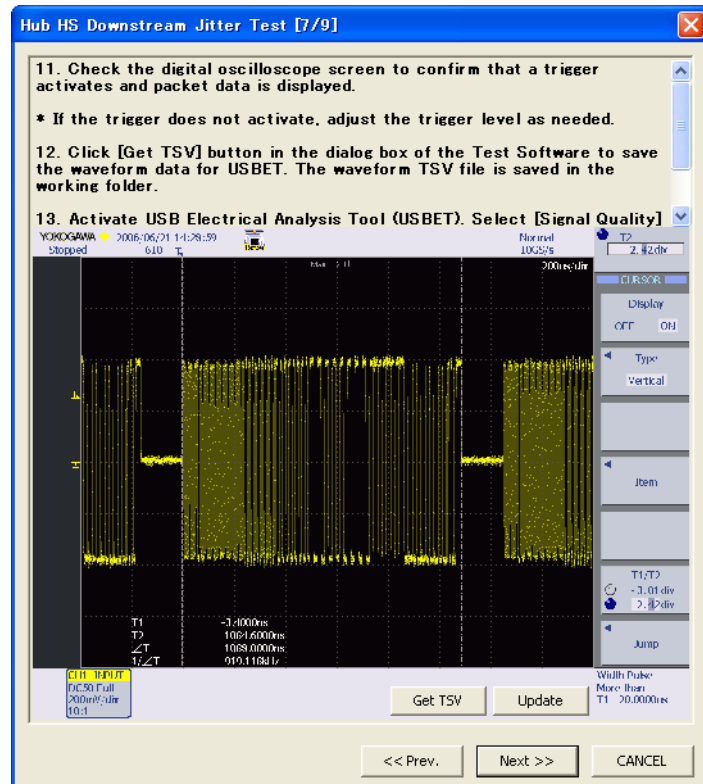
12. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, select TEST FORCE ENABLE from the Port Control drop down menu and set target port number in the HS Electrical Test Tool then click the **[EXECUTE]** button.



13. Click **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, select PARENT TEST PACKET from the Hub Command drop down menu in the HS Electrical Test Tool then click the **[EXECUTE]** button.



14. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, check the digital oscilloscope screen to confirm that a trigger activates and packet data is displayed.
 - If the trigger does not activate, adjust the trigger level as needed.
 - Click the **[Update]** button to update the image of waveform in the dialog box of the busXplorer-USB.

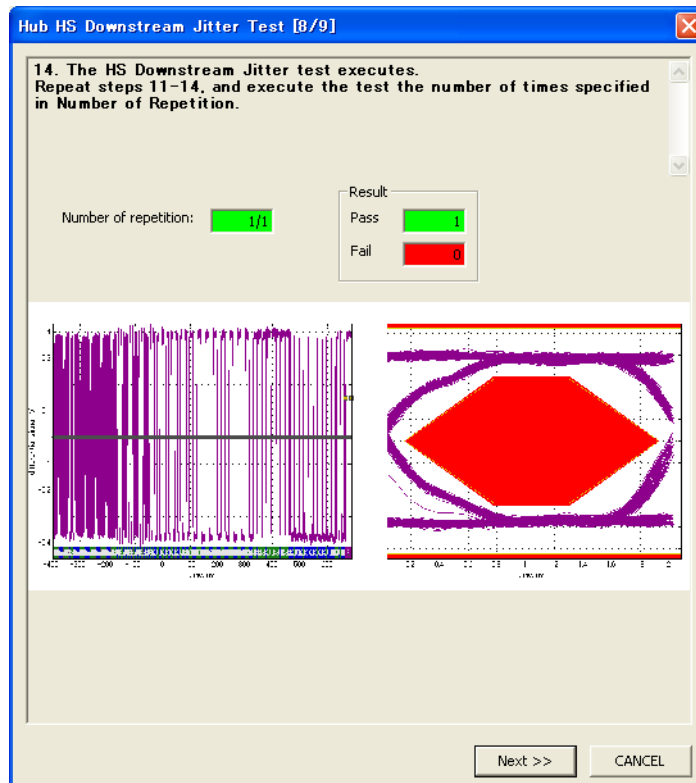


15. Click **[Get TSV]** button in the dialog box of the Test Software to save the waveform data for USBET. The waveform TSV file is saved in the working folder.
16. Activate 'USB Electrical Analysis Tool (USBET)'.
Select **[Signal Quality]** tab, click **[Browse]** button of USBET and specify the waveform data file (tsv file).
Set an appropriate Test Type (HSNE) then click **[TEST]** to start analysis.
Check the test report generated by USBET and verify the result of the test.

Note

To know how to use USBET, please refer to Appendix C of this document.

17. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box as shown below is displayed.



18. Click the **[Next]** button of the dialog box of the busXplorer-USB, repeat steps 14-17, and execute the test the number of times specified in "Number of Repetition."
When the number of tests is completed, the test result dialog box is displayed.

- Click the [Detail] button to display the test results by Internet Explorer as shown below.

Near End High Speed Signal Quality Test Results for Yokogawa_000

For details on test setup, methodology, and performance criteria, please consult the signal quality test description at the [USB-IF Compliance Program](#) web page.

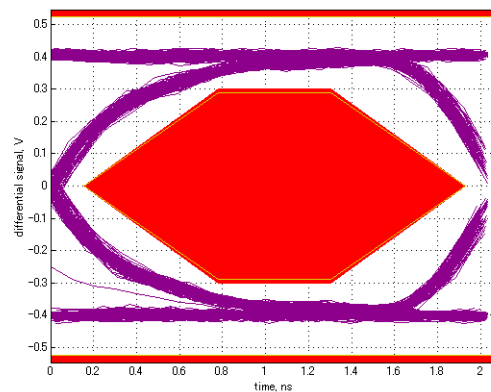
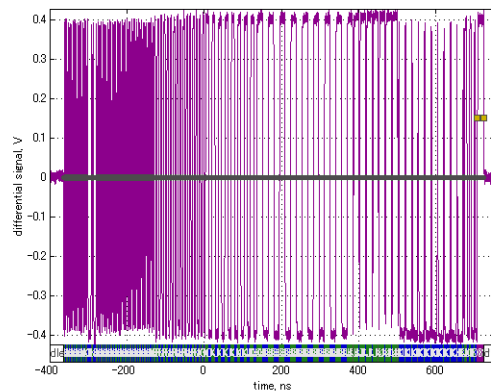
Required Tests

- Overall result: pass!
- Signal eye:
 - eye passes
- EOP width: 7.88 bits
- EOP width passes
- Measured signaling rate: 479.9531MHz
- signal rate passes

Additional Information

- Consecutive jitter range: -49.745ps to 63.552ps, RMS jitter 22.503ps
- Paired JK jitter range: -27.563ps to 24.681ps, RMS jitter 12.433ps
- Paired KJ jitter range: -35.281ps to 25.094ps, RMS jitter 12.085ps

Signal Data and Eye



Tracking Information

- Voltage probes: default, gain accuracy: 1.5%
- Oscilloscope: default, A/D linearity: 1.0%
- Analysis call: usbsigcheck(C:\Program Files\Yokogawa\busxplore\USB\work\Device_HS_SignalQuality\Yokogawa_000.tsv', 'hsne', 1)
- Testing script version: 2.12

- Click the [Image] button to display an image of the digital oscilloscope screen.
- Click the [Analyze] button to start Xviewer and display the waveform data.
Xviewer must already have been installed.

Note

- Test result shown by Internet Explorer is saved in the directory specified as the working folder for the busXplorer-USB.
 - Test results can also be confirmed when displayed in the results display dialog box by clicking the results display button in the Test Software.
-

19. Record the test results in EL_47.

- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission
- All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.

20. Repeat steps 2-19 for all downstream ports of the DUT.

Connect the CN2 connector of the Host SQ TEST block to the following downstream port of the DUT.

21. When all downstream ports have been tested, power cycle the DUT to prepare for the next test.**22.** Remove the differential probe from the test fixture.

2.9. Hub Disconnect Detect (EL_36, EL_37)

Please contact the independent test facilities to perform the Disconnect Test. Yokogawa Test Fixture and busXplorer-USB do not support this test.

Note

Disconnect testing is required for uncertified hub silicon and host silicon or certified silicon using an uncertified PHY.

- **USB 2.0 Electrical Test Specification**

- EL_36

- A USB 2.0 downstream facing port must not detect the high-speed disconnect state when the amplitude of the differential signal at the downstream facing driver's connector is ≥ 525 mV.

- EL_37

- USB 2.0 downstream facing port must detect the hi-speed disconnect state when the amplitude of the differential signal at the downstream facing driver's connector is ≤ 625 mV.

2.10. Hub Packet Parameters, Upstream Facing Port (EL_21,EL_22, EL_25)

- **USB 2.0 Electrical Test Specification**

- EL_21

The SYNC field for all transmitted packets (not repeated packets) must begin with a 32-bit SYNC field.

- EL_22

When transmitting after receiving a packet, hosts and devices must provide an inter-packet gap of at least 8 bit times and not more than 192 bit times.

- EL_25

The EOP for all transmitted packets (except SOFs) must be an 8-bit NRZ byte of 01111111 without bit stuffing.

- **Instruments Used**

Name	Quantity
DL9240/DL9240L Digital Oscilloscope	1
PBD2000 Differential Probe	1
PBD2000 Probe attachment	1 set
USB-IF compliant 1 m USB 2.0 cable	1
Test bed computer	1
USB compliance test fixture	1
5 V power supply for test fixture	1

- **Executing the Test**

1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



2. Click the **[HS Upstream Packet Parameter Test]** button in the dialog box. The Hub HS Upstream Packet Parameter Test dialog box opens.

Hub HS Upstream Packet Parameter Test [1/13]

1. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.

2. If necessary, enter a comment for the test in Comment text box. The comment is saved together with test result and displayed in the Test Result Dialog box.

Number of repetition:

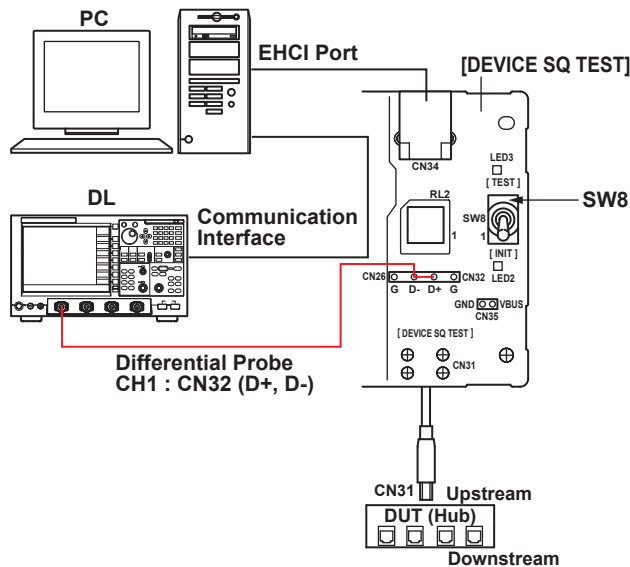
Parameter	Min.	Max.	unit	Default
EL21:	<input type="text" value="31.500"/>	<input type="text" value="32.500"/>	bit	<input type="checkbox"/>
EL25:	<input type="text" value="7.5000"/>	<input type="text" value="8.5000"/>	bit	<input type="checkbox"/>
EL22: (1st step)	<input type="text" value="8.0000"/>	<input type="text" value="192.00"/>	bit	<input type="checkbox"/>
EL22: (2nd step)	<input type="text" value="8.0000"/>	<input type="text" value="192.00"/>	bit	<input type="checkbox"/>

Comment:

Next >> CANCEL

3. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.
4. If necessary, enter a comment for the test in Comment text box. The comment is saved together with test result and displayed in the Test Result Dialog box.
5. If you wish to change the judgment range, you can edit the judgment criteria for EL_21, EL_25, and EL_22. Default values for the judgment criteria are as follows:
 - EL_21
Min.: 31.500 bits, Max.: 32.500 bits
 - EL_25
Min.: 7.500 bits, Max.: 8.500 bits
 - EL_22 (gap between 2nd and 3rd packets) (1st step)
Min.: 8.000 bits, Max.: 192.000 bits
 - EL_22 (gap between 1st and 2nd packets) (2nd step)
Min.: 8.000 bits, Max.: 192.000 bits
 If you click the [Default] button after changing the judgment range, the default values of the judgment range are restored.

6. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The connection diagram as shown below is displayed.



7. Turn ON the power to the DUT.
8. Turn ON the power to the test fixture and verify that the green power supply LED 1 is lit.
9. Connect the CN31 connector of the DEVICE SQ TEST block to the upstream port of the DUT.
10. Connect the test bed computer to the CN34 connector of the DEVICE SQ TEST block using a 1 m USB cable.
11. Connect the PBD2000 Differential Probe to CH1 of the digital oscilloscope.

Note

After connecting the probe, heat emitted from the probe causes the offset voltage to drift. The probe should nearly stabilize about thirty minutes after applying power.

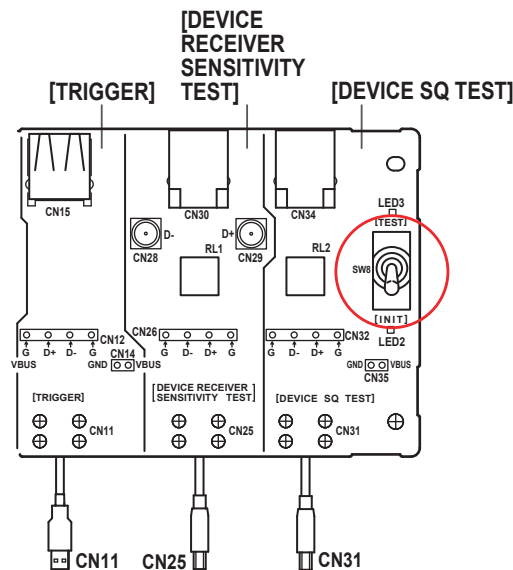
12. Connect the differential probe to the attachment on the tip to CN32 on the DEVICE SQ TEST block.

For the polarity, match up the plus side on the differential probe to D+ (the D+ pin at CN32) and the minus side to D- (the D- pin at CN32).

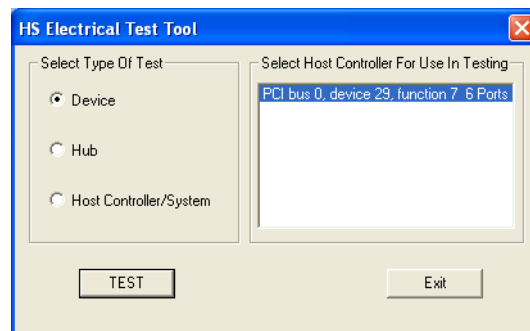
Note

The use of the Device Hi-Speed Signal Quality test fixture makes it possible to trigger on packets generated by the device because the differential probe is located closer to the device transmitter, hence the device packets are larger in amplitude.

- 13.** Click the **[Next]** button in the dialog box of the busXplorer-USB.
- Following the instructions displayed in the dialog box, place SW8 of the test fixture to the INIT position.
- Verify LED2 of the test fixture is lit.

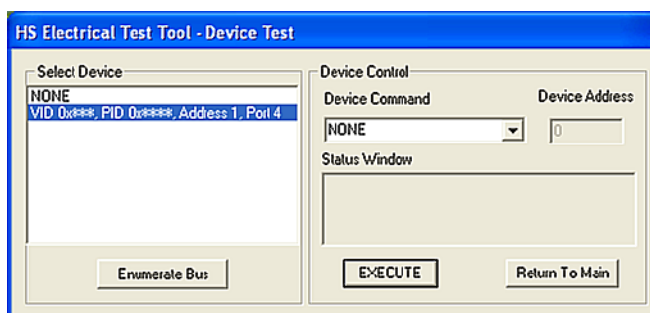


- 14.** Click the **[Next]** button in the dialog box of the busXplorer-USB.
- Following the instructions in the dialog box of the busXplorer-USB, invoke the HS Electrical Test Tool on the test bed computer.
- The HS Electrical Test Tool main menu is displayed, and the host controller is displayed under Select Host Controller For Use in Testing.

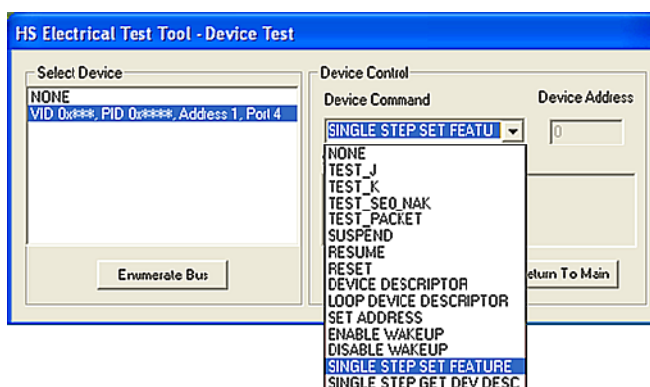


- 15.** Select Device under Select Type Of Test in the HS Electrical Test Tool, and click the TEST button.

16. Click the **[Next]** button in the dialog box of the busXplorer-USB.
- Following the instructions in the dialog box, confirm that the VID, PID, connected address, and port of the DUT are displayed under Select Device of the HS Electrical Test Tool.
- If not already running, start the HS Electrical Test Tool. Select Device under Select Type of Test, click the TEST button, then confirm the above.



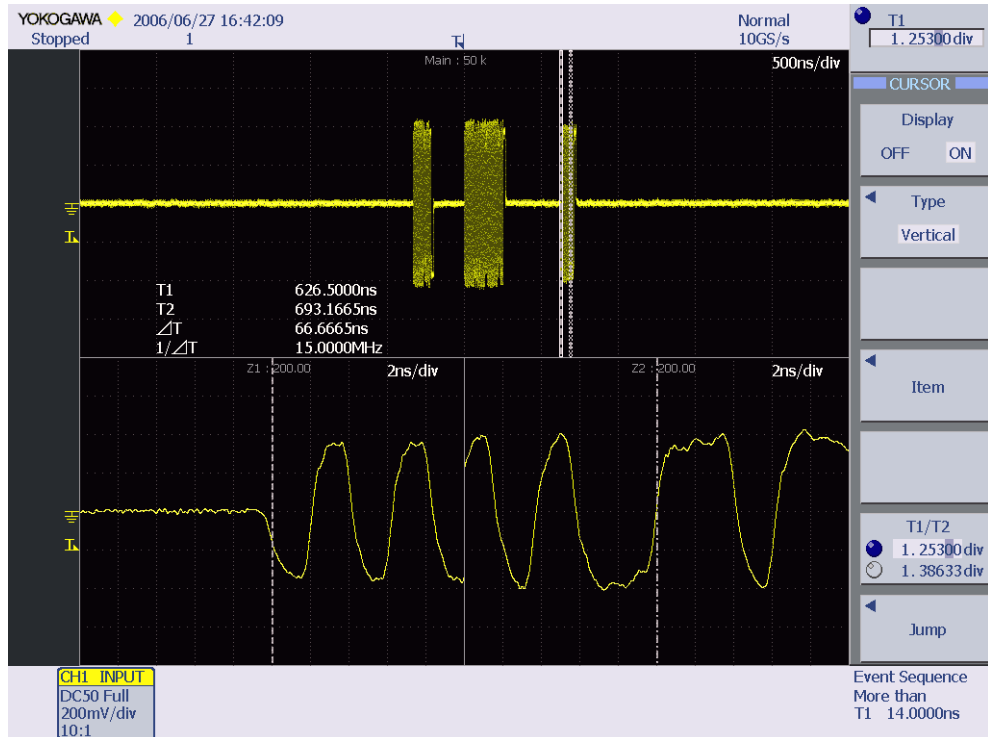
17. Click **[Next]** button in the dialog box of the busXplorer-USB.
- Following the instructions in the dialog box, select SINGLE STEP SET FEATURE from the Device Command drop down menu in the HS Electrical Test Tool then click the **[EXECUTE]** button.



18. Click the **[Next]** button in the dialog box of the busXplorer-USB.

Following the instructions in the dialog box, check the digital oscilloscope screen to confirm that a trigger activates and packet is displayed.

- If the trigger does not activate, adjust the trigger level as needed.
Then, select SINGLE STEP SET FEATURE again from the Device Command drop down menu in the HS Electrical Test Tool, and click the **[EXECUTE]** button again.
- Click the **[Update]** button to update the image of waveform in the dialog box of the busXplorer-USB.



19. Confirm the Sync field of the 3rd packet (EL_21). Using the digital oscilloscope's zoom function, adjust the zoom position on the 3rd packet. Then set the cursors of the digital oscilloscope on the start and the end points of the Sync field of the 3rd packet. The Sync field must be 32bits.

When **[Next]** button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.

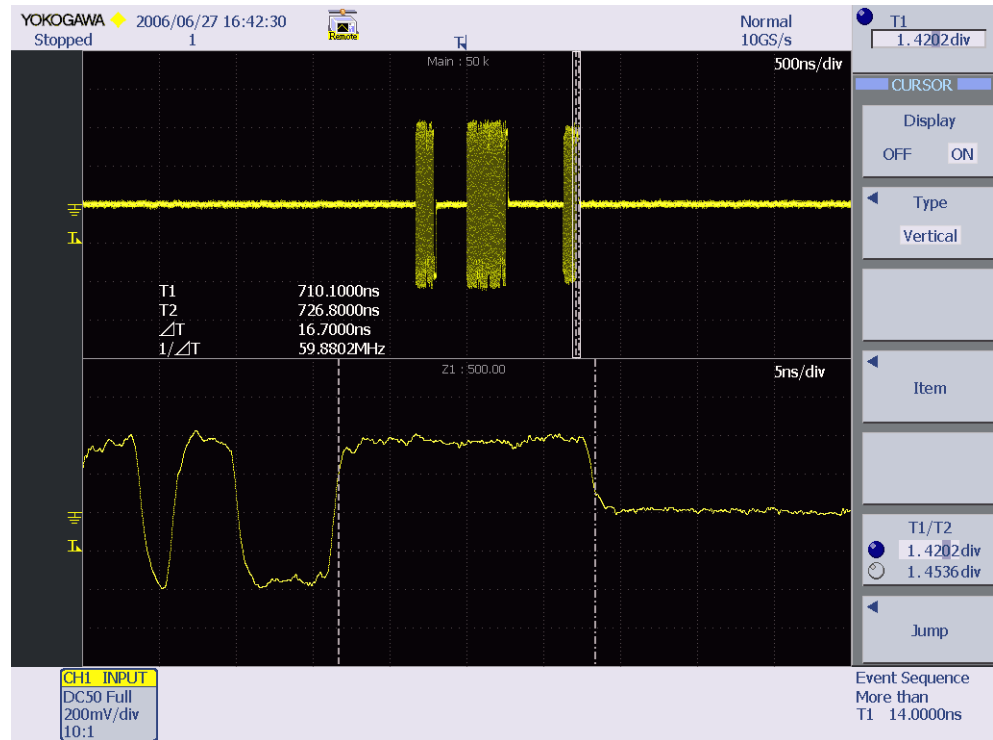
Note

When setting the cursor on the Sync field, note that the Sync field starts from the Hi-Speed idle transitions to a falling edge. Count both rising and falling edges until the first two consecutive 1's and include the first 1.

20. Click the **[Next]** button in the dialog box of the busXplorer-USB.

To measure the EOP width (EL_25), adjust the zoom position on the EOP of the 3rd packet and set the cursors on the start and the end points of the EOP of the 3rd packet. The EOP width must be 8bits.

- Click the [Update] button to update the image of waveform in the dialog box.
- When [Next] button is clicked, the measured width (the number of bits) of EOP is judged and Fail message will be displayed if the result is failed.



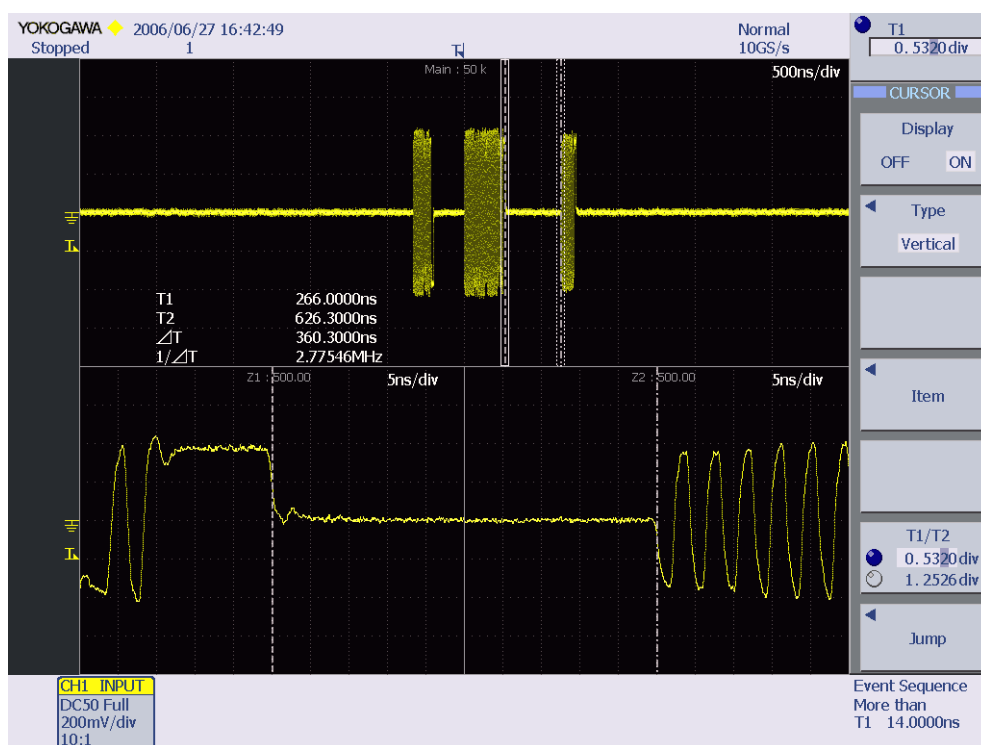
Note

Note that EOP could appear as a falling pulse or a rising pulse.

21. Click the [Next] button in the dialog box of the busXplorer-USB.

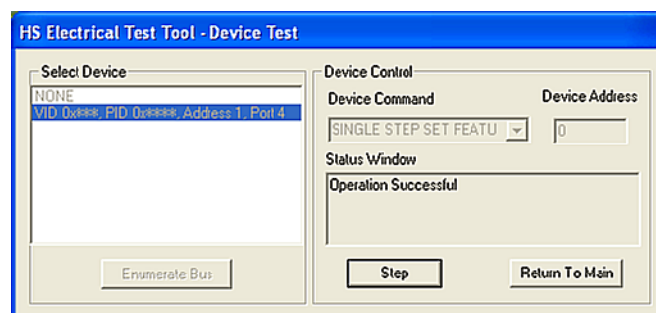
To measure the gap between packets (EL_22), adjust zoom1 position to the end of the 2nd packet and zoom2 position to the start of the 3rd packet. Then set the cursors on the end point of the 2nd packet in zoom1 and the start point of the 3rd packet in zoom2. The requirement of the gap is between 8bits and 192bits.

- Click the [Update] button to update the image of waveform in the dialog box.
- When [Next] button is clicked, the measured gap (the number of bits) between packets is judged and Fail message will be displayed if the result is failed.



22. Click the [Next] button in the dialog box of the busXplorer-USB.

Following the instructions in the dialog box, click the [STEP] button in the dialog box of the HS Electrical Test Tool.



- 23.** Following the instructions in the dialog box, check the digital oscilloscope screen to confirm its trigger activates and packets from the host and device are displayed.
- If the trigger does not activate, adjust the trigger level as needed.
Then, select SINGLE STEP SET FEATURE again from the Device Command drop down menu in the HS Electrical Test Tool, and click the [STEP] button again.
 - Click the [Update] button to update the image of waveform in the dialog box of the busXplorer-USB.



- 24.** To measure the gap between packets (EL_22), adjust zoom1 position to the end of the 1st packet and zoom2 position to the start of the 2nd packet. Then set the cursors on the end point of the 1st packet in zoom1 and the start point of the 2nd packet in zoom2. The gap must be between 8bits and 192 bits. When [Next] button is clicked, the measured gap (the number of bits) between packets is judged and Fail message will be displayed if the result is failed.

25. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box is displayed.

Hub HS Upstream Packet Parameter Test [12/13]

22. The HS Packet Parameter Test executes.

Repeat steps 14-22, and execute the test the number of times specified in Number of Repetition.

Number of repetition: 1/1

Result

Pass	1
Fail	0

Parameter

	Min.	Max.	Result	unit
EL21:	31.500	32.500	31.999	bit
EL25:	7.5000	8.5000	8.0160	bit
EL22: (1st step)	8.0000	192.00	172.94	bit
EL22: (2nd step)	8.0000	192.00	177.84	bit

Next >> CANCEL

- 26.** Click the **[Next]** button in the dialog box of the busXplorer-USB, repeat steps 17-25, and execute the test the number of times specified in “Number of Repetition.”
- When the number of tests is completed, the test results dialog box as shown below is displayed.
 - Click the **[Detail]** button to display the test results by Internet Explorer.
 - Click the **[Image]** button to display an image of the digital oscilloscope screen.
 - Click the **[Analyze]** button to start Xviewer and display the waveform data. Xviewer must already have been installed.

23. Record the test results in EL_21, EL_25, and EL_22.

24. Click the Return Main button in the HS Electrical Test Tool, and exit the HS Electrical Test Tool's Device Test menu.

25. Next, select Hub under Select Type Of Test in the HS Electrical Test

Number of repetition: 1/1

Result:
 Pass: 1
 Fail: 0

Parameter	Min.	Max.	Result	unit	Image	Analyze
EL21:	31.500	32.500	31.999	bit
EL25:	7.5000	8.5000	8.0160	bit
EL22: (1st step)	8.0000	192.00	172.94	bit
EL22: (2nd step)	8.0000	192.00	177.84	bit

Detail

OK

- 27.** Record the test results in EL_21, EL_25, and EL_22.
- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission
 - All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.
- 28.** Click the Return Main button in the HS Electrical Test Tool, and exit the HS Electrical Test Tool's Device Test menu.
- 29.** Next, select Hub under Select Type Of Test in the HS Electrical Test Tool, and click the TEST button.
- 30.** Remove the differential probe from the test fixture.

2.11. HS Receiver Sensitivity, Upstream Facing Port Test (EL_16, EL_17, EL_18)

- **USB 2.0 Electrical Test Specification**

- EL_16

A hi-speed capable device must implement a transmission envelope detector that indicates squelch (i.e. never receives packets) when a receiver's input falls below 100 mV differential amplitude.

- EL_17

A hi-speed capable device must implement a transmission envelope detector that does not indicate squelch (i.e. reliably receives packets) when a receiver exceeds 150 mV differential amplitude.

- EL_18

A hi-speed capable device's Transmission Envelope Detector must be fast enough to allow the HS receiver to detect data transmission, achieve DLL lock, and detect the end of the SYNC field within 12 bit times.

- **Instruments Used**

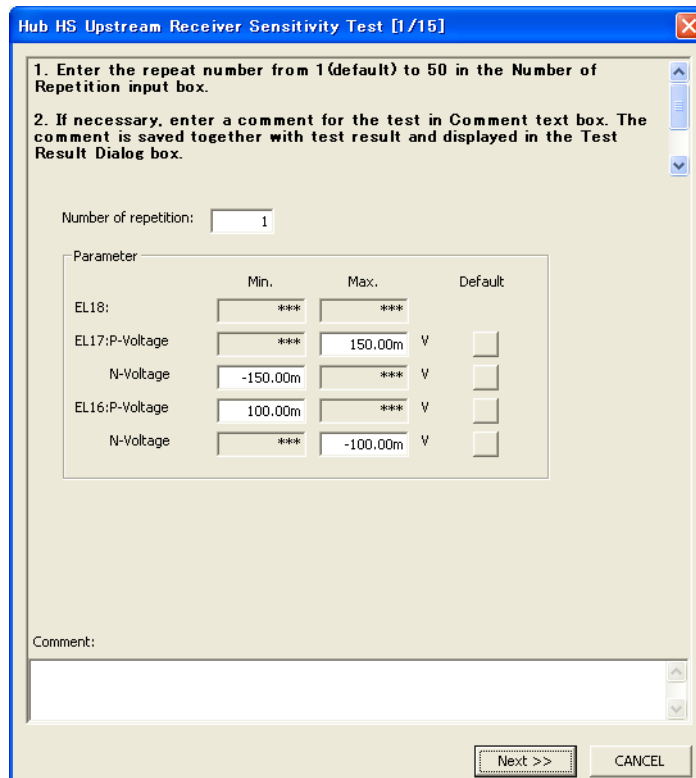
Name	Quantity
DL9240/DL9240L Digital Oscilloscope	1
PBD2000 Differential Probe	1
PBD2000 Probe attachment	1 set
USB-IF compliant 1 m USB 2.0 cable	1
Test bed computer	1
Tektronix DG2040 Data Generator	1
SMA cable	2
Attenuators (x 5)	2
USB compliance test fixture	1
5 V power supply for test fixture	1

- **Executing the Test**

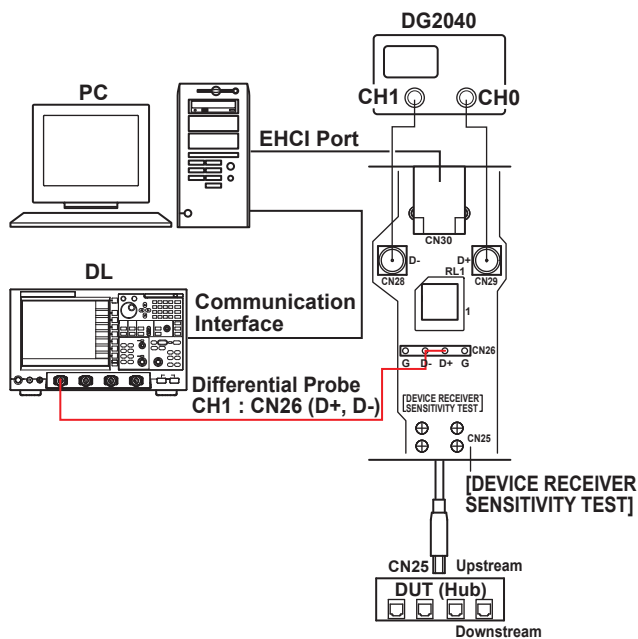
1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



2. Click the **[HS Upstream Receiver Sensitivity Test]** button in the dialog box. The Hub HS Upstream Receiver Sensitivity Test screen is displayed.



3. Enter the repeat number from 1(default) to 50 in the Number of Repetition input box.
4. If necessary, enter a comment for the test in Comment text box.
The comment is saved together with test result and displayed in the Test Result Dialog box.

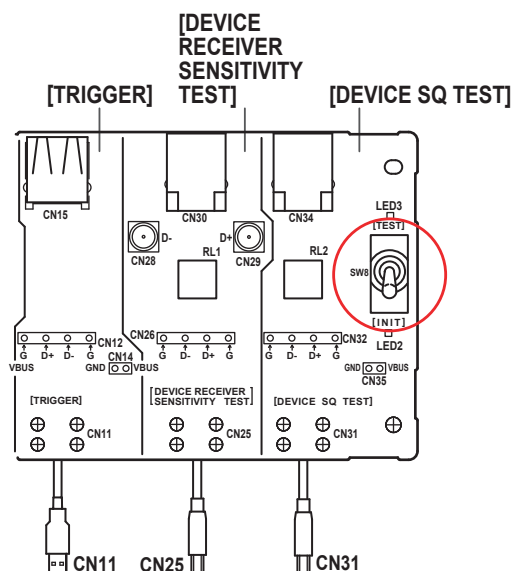


11. Connect the PBD2000 Differential Probe to CH1 of the digital oscilloscope.

Note

After connecting the probe, heat emitted from the probe causes the offset voltage to drift. The probe should nearly stabilize about thirty minutes after applying power.

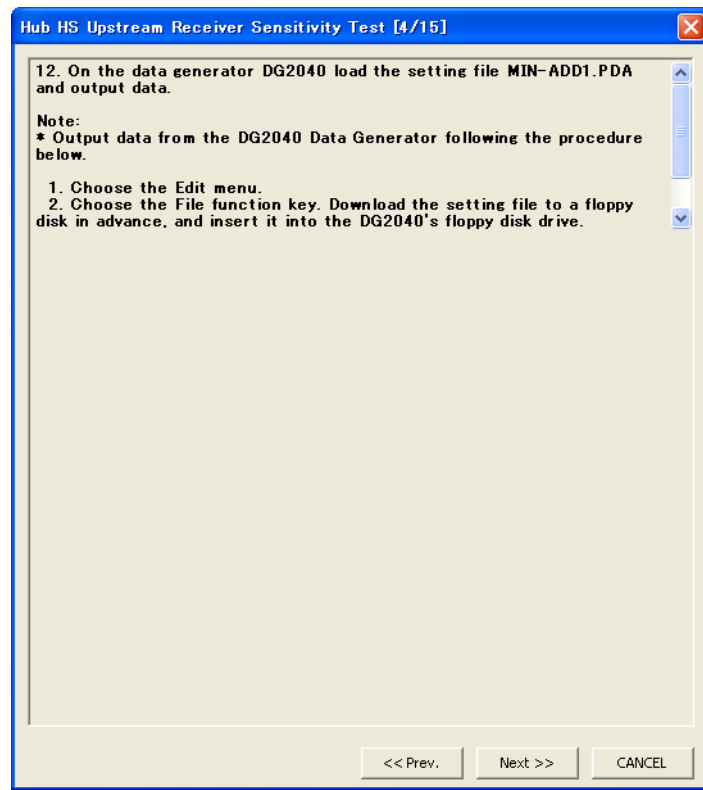
12. Connect the differential probe with the attachment fastened on the tip to CN26 on the DEVICE RECEIVER SENSITIVITY TEST block.
For the polarity, match up the plus side on the differential probe to D+ (the D+ pin at CN26) and the minus side to D- (the D- pin at CN26).
13. Connect SMA cables through x 5 attenuators from the DG2040 Data Generator's CH0 to CN29 (D+) and CH1 to CN28 (D-) on the Device Receiver Sensitivity TEST block.
14. Click the **[Next]** button in the dialog box of the busXplorer-USB. Following the instructions in the dialog box, place SW8 of the test fixture to the INIT position. Verify LED2 of the test fixture is lit.



Note

If the repeat number is set to 2 or more, power cycle the DUT after the each test is completed.

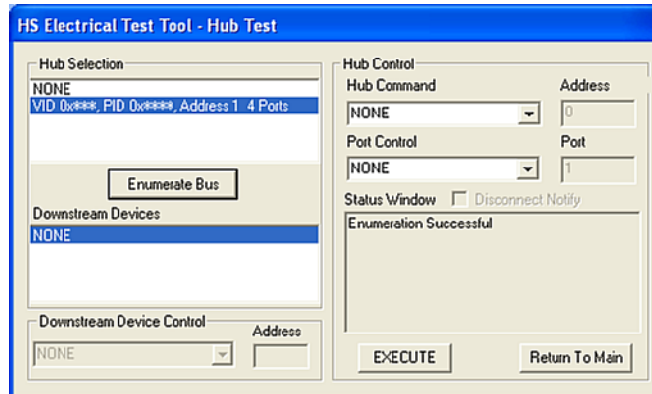
-
15. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, on the data generator DG2040 load the setting file 'MIN-ADD1.PDA' and output data.



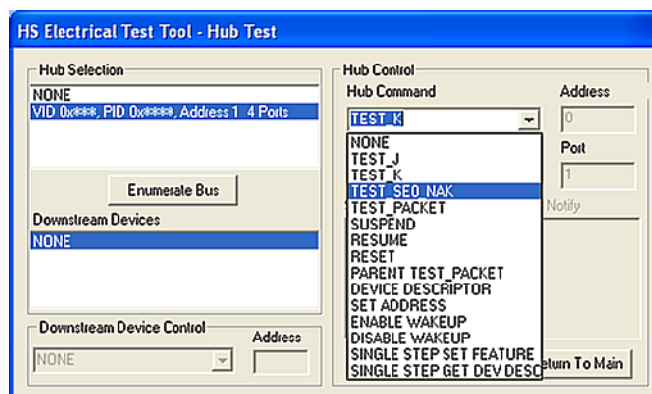
Note

- Setting files for DG2040 can be obtained by extracting 'USBHSET.EXE'. For details about 'USBHSET.EXE', please refer to the following web site. <http://www.usb.org/developers/tools>
 - Output data from the DG2040 Data Generator following the procedure below.
 1. Choose the Edit menu.
 2. Choose the File function key.
 - * Download the setting file to a floppy disk in advance, and insert it into the DG2040's floppy disk drive.
 3. Choose Load Data & Setup, and then load the MIN-ADD1.PDA file using the jog shuttle.
 4. Press the START/STOP button.
-

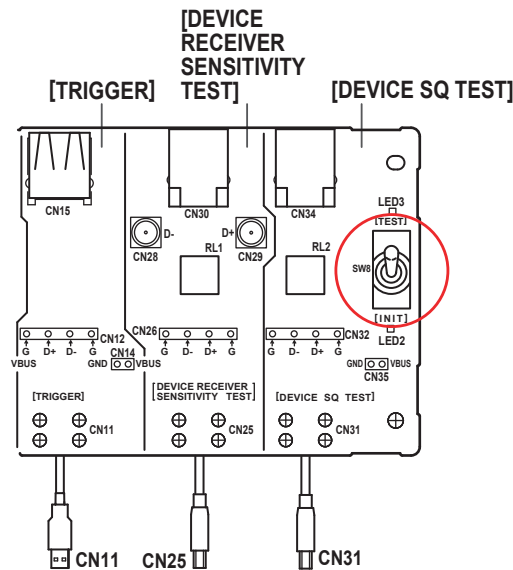
16. Click the **[Next]** button in the dialog box of the busXplorer-USB. Following the instructions in the dialog box, click the **[Enumerate Bus]** button in the HS Electrical Test Tool. Confirm that the VID, PID, connected address, and port of the DUT are displayed under Hub Selection . If not already running, start the HS Electrical Test Tool. Select Hub under Select Type of Test, click the TEST button, then confirm the above.



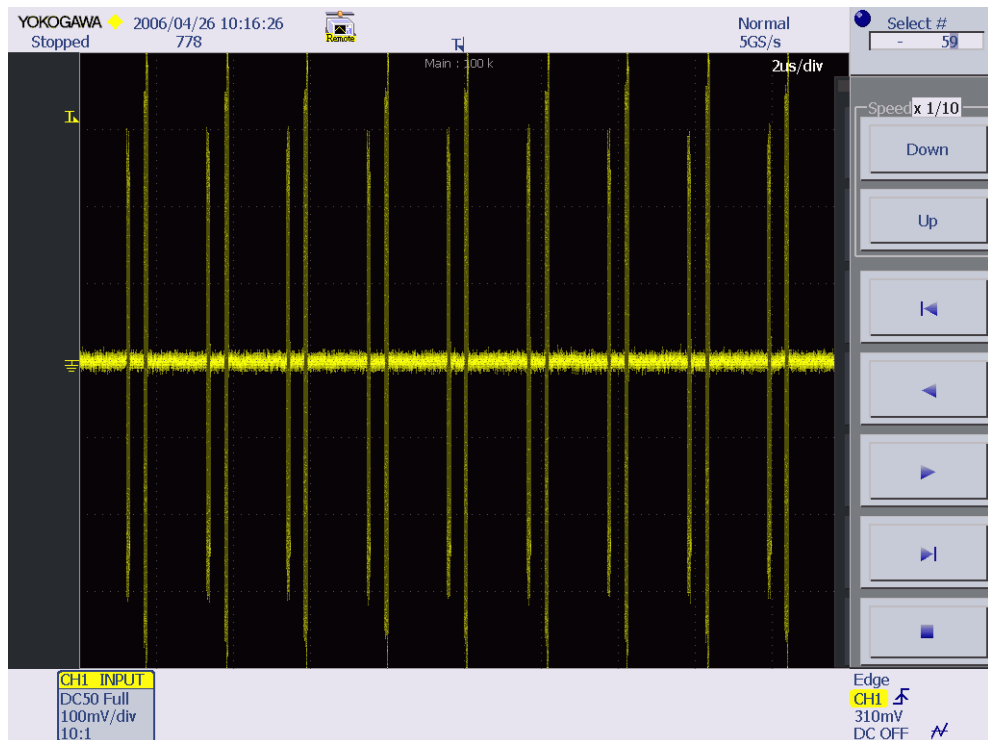
17. Click the **[Next]** button in the dialog box of the busXplorer-USB, and then select TEST_SE0_NAK from Hub Command drop down menu in the HS Electrical Test Tool, then click the **[EXECUTE]** button.



- 18.** Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, place SW8 of the test fixture to the TEST position.
Verify LED3 of the test fixture is lit.



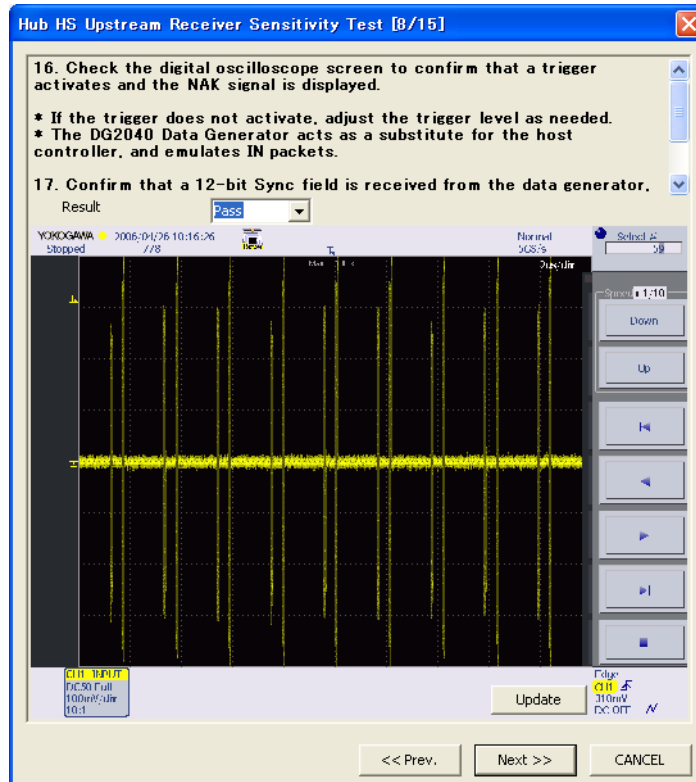
- 19.** Click the **[Next]** button in the dialog box of the busXplorer-USB, and then check the digital oscilloscope screen to confirm that a trigger activates and the NAK signal is displayed.
- If the trigger does not activate, adjust the trigger level as needed.
 - The DG2040 Data Generator acts as a substitute for the host controller, and emulates IN packets.
 - Click the **[Update]** button to update the image of waveform in the dialog box.



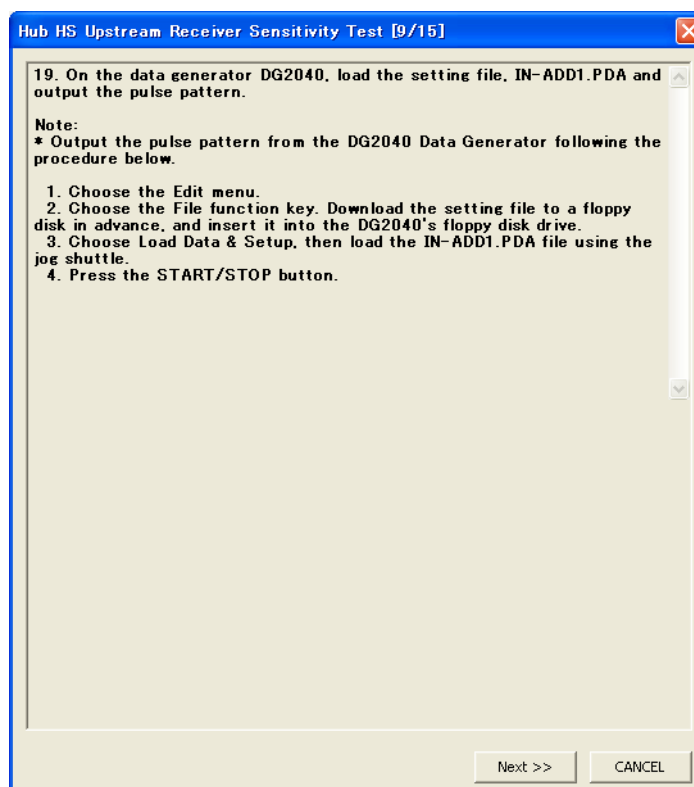
20. Confirm that a 12-bit Sync field is received from the data generator, and confirm that NAK is returned from the DUT (EL_18).

21. If NAK is returned, select Pass in the results confirmation box, and if NAK is not returned, select Fail.

When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



-
22. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, on the data generator DG2040, load the setting file, 'IN-ADD1.PDA' and output the pulse pattern.



Note

Output the pulse pattern from the DG2040 Data Generator following the procedure below.

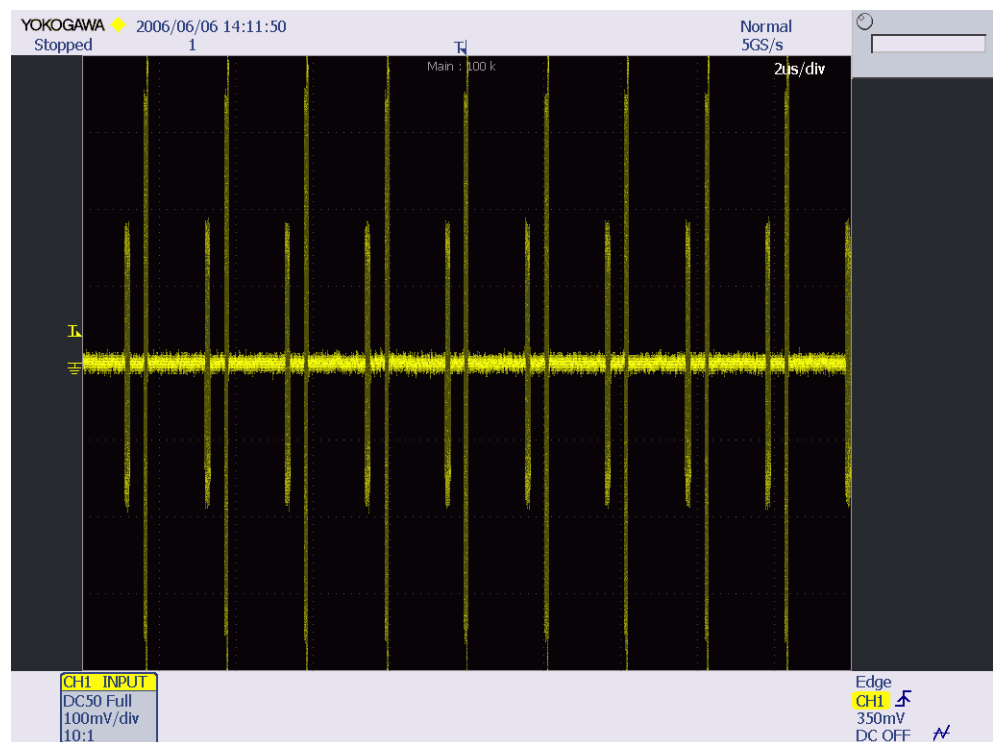
1. Choose the Edit menu.
 2. Choose the File function key.
 - * Download the setting file to a floppy disk in advance, and insert it into the DG2040's floppy disk drive.
 3. Choose Load Data & Setup, then load the IN-ADD1.PDA file using the jog shuttle.
 4. Press the START/STOP button.
-

23. Click the **[Next]** button in the dialog box of the busXplorer-USB.

To measure the minimum receiver sensitivity level just prior to squelch (EL17), adjust the DG2040 Data Generator's output level while watching the digital oscilloscope screen.

Reduce the amplitude of the packets from the data generator while monitoring the NAK response from the device on the oscilloscope. Adjust output level of CH0 and CH1 of the data generator to keep them the same levels. Reduce the amplitude in 50mV steps until the NAK packets start to become intermittent. After that, increase the amplitude so that the NAK packets are no longer intermittent. This output amplitude is just above the minimum receiver sensitivity levels before squelch.

- Click the [Update] button to update the image of waveform in the dialog box.
- When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



Note

Follow the procedure below to adjust the DG2040 Data Generator output level.

1. Choose the Setup menu.
2. Choose Level Condition with the function key.
3. Select a CH1 and adjust the output level.

24. Click the **[Next]** button in the dialog box of the busXplorer-USB, and then set cursors on the Zero to Positive voltage and Negative voltage of the packet. Using zoom function of oscilloscope, adjust zoom magnitude and position so that the packet is displayed in it. Set H1 cursor on the positive peak and H2 cursor on the negative peak of the packet.

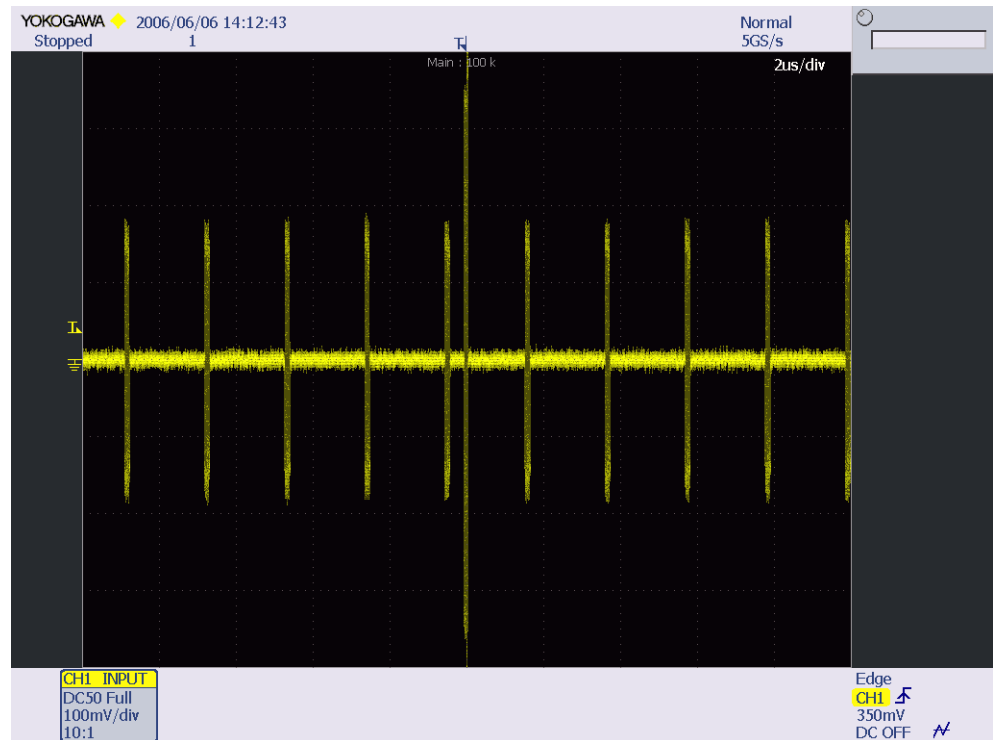
- Each cursor should be set on the flat portion of packet waveform such as EOP.
- When **[Next]** button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



25. Click the **[Next]** button in the dialog box of the busXplorer-USB.

To measure the squelch sensitivity level (EL16), adjust the DG2040 Data Generator's output level while watching the digital oscilloscope screen. Reducing the level of the amplitude of the packets from the data generator in 50mV steps, adjust the output amplitude of CH0 and CH1 of the data generator to keep them the same levels until the receiver just stops responding with NAK. This is the receiver's squelch level.

- Click the [Update] button to update the image of waveform in the dialog box.
- When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



26. Click the **[Next]** button in the dialog box of the busXplorer-USB, and then set cursors on the Zero to Positive voltage and Negative voltage of the packet. Using zoom function of oscilloscope, adjust zoom magnitude and position so that the packet is displayed in it. Set H1 cursor on the positive peak and H2 cursor on the negative peak of the packet.

- Each cursor should be set on the flat portion of packet waveform such as EOP.
- When **[Next]** button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



27. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box is displayed.

Hub HS Upstream Receiver Sensitivity Test [14/15]

24. The HS Receiver Sensitivity Test executes.
Repeat steps 11-24, and execute the test the number of times specified in Number of Repetition.

Note:
* With certain devices making an accurate zero-to-peak measurement of

Number of repetition: 1/1

Result
Pass 1
Fail 0

Parameter	Min.	Max.	Result
EL18:	***	***	Pass
EL17:P-Voltage	***	150.00m	140.00m V
N-Voltage	-150.00m	***	-140.00m V
EL16:P-Voltage	100.00m	***	137.00m V
N-Voltage	***	-100.00m	-139.00m V

Next >> CANCEL

- 28.** Click the **[Next]** button in the dialog box of the busXplorer-USB, repeat steps 14-27, and execute the test the number of times specified in “Number of Repetition.”
- When this number of tests is completed, the test results dialog box as shown below is displayed.
 - Click the **[Detail]** button to display the test results by Internet Explorer.
 - Click the **[Image]** button to display an image of the digital oscilloscope screen.
 - Click the **[Analyze]** button to start Xviewer and display the waveform data. Xviewer must already have been installed.

Hub HS Upstream Receiver Sensitivity Test [15/15]

25. Record the test results in EL_18, EL_17, and EL_16.

26. Return SW8 of the test fixture to the INIT position. LED2 of the test fixture is lit.

27. Since the DUT is in Test mode. Power cycle the DUT in preparation

Number of repetition: 1/1

Result:
 Pass: 1
 Fail: 0

Parameter	Min.	Max.	Result	Image	Analyze
EL18:	***	***	Pass
EL17:P-Voltage	***	150.00m	140.00m	V	...
N-Voltage	-150.00m	***	-140.00m	V	...
EL16:P-Voltage	100.00m	***	137.00m	V	...
N-Voltage	***	-100.00m	-139.00m	V	...

Detail

OK

Note

With certain devices making an accurate zero-to-peak measurement of the IN packet from the data generator may be difficult due to excessive reflection artifacts. Also, on devices with captive cable, the measured zero-to-peak amplitudes of the IN packet at the test fixture could be considerably higher than that seen by the device receiver. In these situations, it is advisable to make the measurement near the device receiver pins on the PCB (Printed Circuit Board).

- 29.** Record the test results in EL_18, EL_17, and EL_16.
- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission.
 - All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.
- 30.** Return SW8 of the test fixture to the INIT position.
LED2 of the test fixture is lit.
- 31.** Since the DUT is in Test mode, power cycle the DUT in preparation for subsequent tests.
- 32.** Remove the differential probe from the test fixture.

2.12. Hub Repeater Test, Downstream Facing Port (EL_42, EL_43, EL_44, EL_45, EL_48)

- **USB 2.0 Electrical Test Specification**

- EL_42
Hub repeaters must not truncate more than 4 bits from a repeated SYNC pattern.
- EL_43
Hubs must not corrupt any repeated bits of the SYNC field.
- EL_44
A hub may add at most 4 random bits to the end of the EOP field when repeating a packet.
- EL_45
A hub must not corrupt any of the valid EOP bits when repeating a packet.
- EL_48
A hub repeater may not delay packets for more than 36 bit times plus 4 ns.

Note

Although most hubs have multiple downstream ports, it is acceptable to only test one port for the economy of test time.

- **Instruments Used**

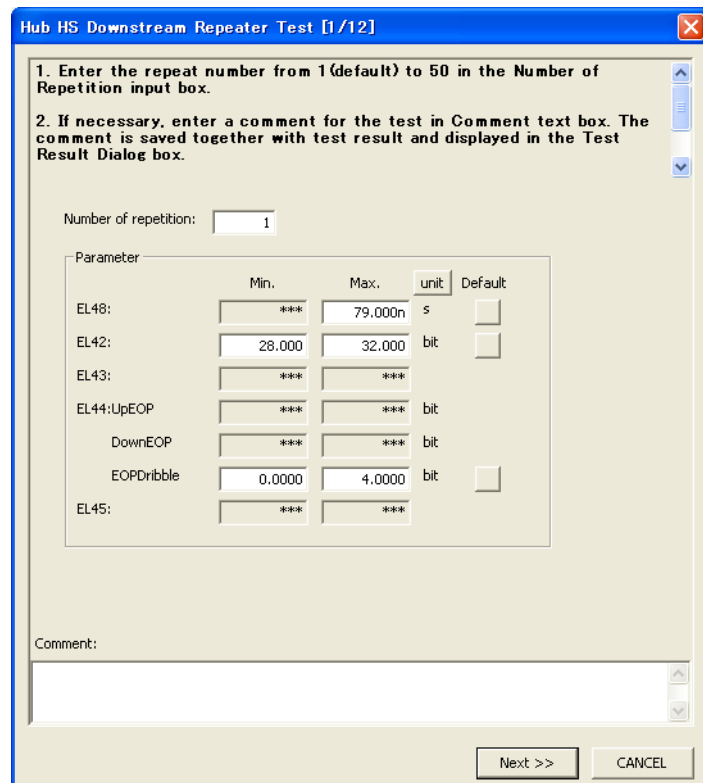
Name	Quantity
DL9240/DL9240L Digital Oscilloscope	1
PBD2000 Differential Probe	2
PBD2000 Probe attachment	2 sets
USB-IF compliant 1 m USB 2.0 cable	1
USB-IF Compliant Hi-Speed Device	1
Test bed computer	1
USB compliance test fixture	1
5 V power supply for test fixture	1

- **Executing the Test**

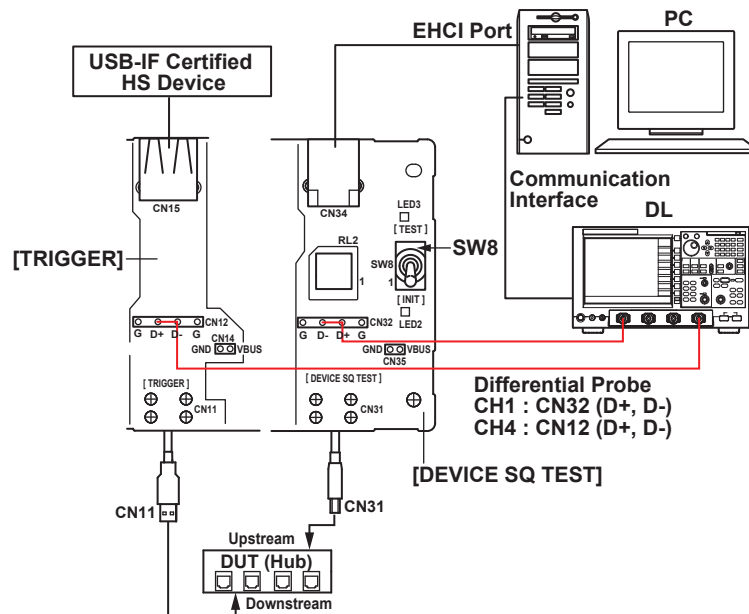
1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



2. Click the **[HS Downstream Repeater Test]** button in the dialog box. The Hub HS Downstream Repeater Test dialog box is displayed.



3. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.
4. If necessary, enter a comment for the test in Comment text box.
The comment is saved together with test result and displayed in the Test Result Dialog box.
5. If you wish to change the judgment range, you can edit the judgment criteria for EL_48, EL_42, and EL_44.
Default values for the judgment criteria are as follows:
 - EL_48
Max.: 79.00 ns
EL_42
Min.: 28.00 bit, Max.: 32.00 bit
 - EL_44 EOPDribble
Min.: 0.00 bit, Max.: 4.00 bit
 If you click the [Default] button after changing the judgment range, the default values of the judgment range are restored.
6. Click the **[Next]** button in the dialog box of the busXplorer-USB.
A connection diagram as shown below is displayed.

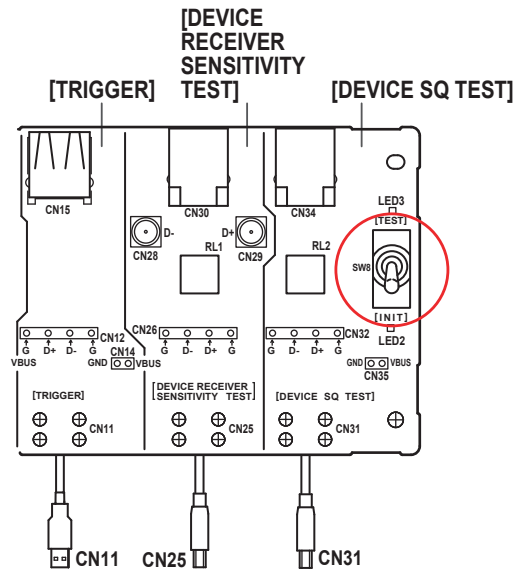


7. Turn ON the power to the test fixture and verify that the green power supply LED1 is lit.
8. Connect the CN31 connector of the DEVICE SQ TEST block to the upstream port of the DUT.
9. Connect the test bed computer to the CN34 connector of the DEVICE SQ TEST block using a 1 m USB cable.
10. Connect the downstream port of the DUT to the CN11 connector of the TRIGGER block.
11. Connect the USB-IF Compliant Hi-Speed Device to the CN15 connector.
12. Connect two PBD2000 Differential Probes, one to CH1 and the other to CH4 of the digital oscilloscope.

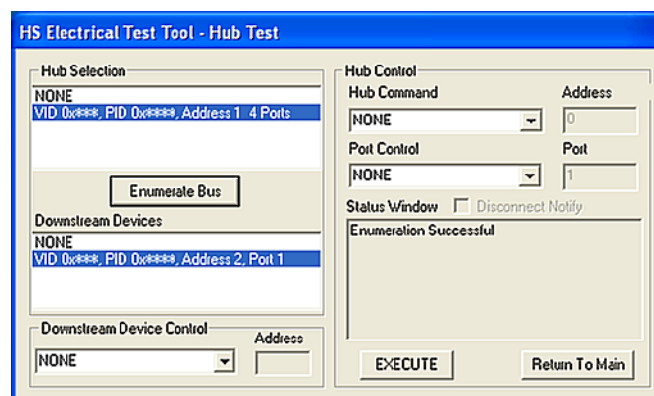
Note

After connecting the probe, heat emitted from the probe causes the offset voltage to drift. The probe should nearly stabilize about thirty minutes after applying power.

13. Attach the attachments on the tips of the differential probes, then connect the CH1 probe to D+ and D- of CN32, and the CH4 probe to D+ and D- of CN12. For the polarity, match up the plus side on the differential probe to D+ (the D+ pin at CN32 or CN12) and the minus side to D- (the D- pin at CN32 or CN12).
14. Turn ON the power to the USB-IF compliant Hi-Speed device.
15. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, place SW8 of the test fixture to the INIT position.
Verify LED2 of the test fixture is lit.



16. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, click the **[Enumerate Bus]** button in the HS Electrical Test Tool. Confirm that the VID, PID, connected address, and port of the DUT are displayed under Hub Selection .
If not already running, start the HS Electrical Test Tool. Select hub under SelectSelect Hub under Select Type of Test, click the TEST button, then confirm the above.



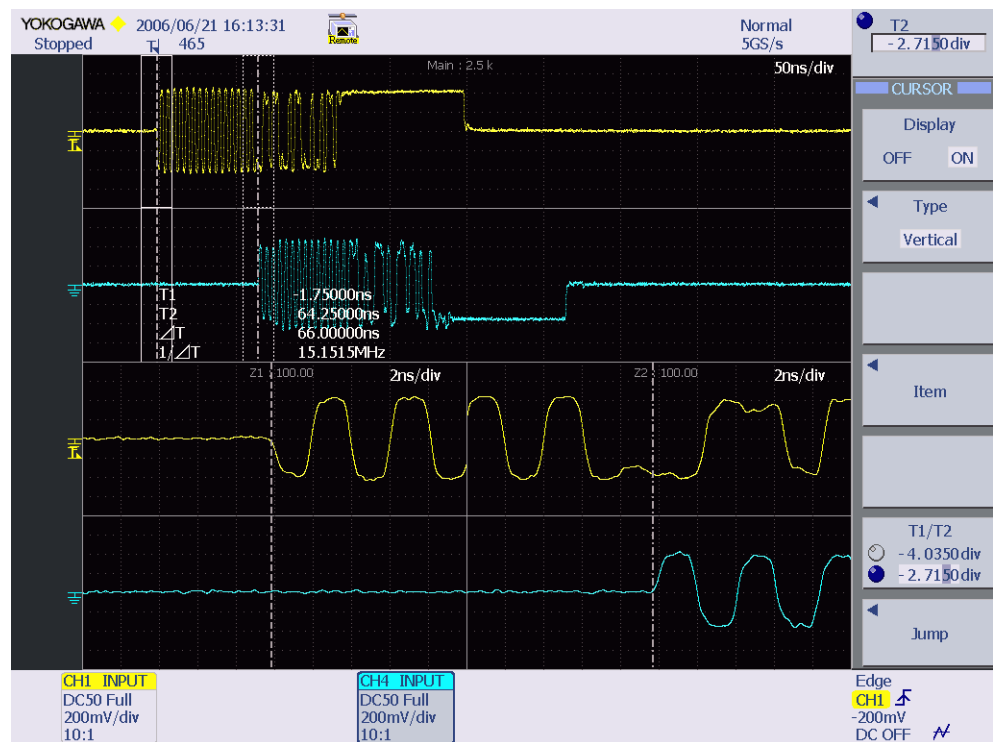
17. Click the **[Next]** button in the dialog box of the busXplorer-USB, check the digital oscilloscope screen to confirm that a trigger activates and SOF packet is displayed.

- If the trigger does not activate, adjust the trigger level as needed
- Click the [Update] button to update the image of waveform in the dialog box.

18. Measure the packet delay (EL_48).

Using the oscilloscope's cursor/zoom function, measure the time from the SOF on the hub's upstream port (CH1) to the SOF on the hub's downstream port under test(CH4). Adjust zoom1 position to the SOF on the hub's upstream port and set T1 cursor on the start of the SOF packet. Adjust zoom2 position to the SOF on the hub's downstream port and set T2 cursor on the start of the SOF packet. Confirm that the SOF packet delay is 79 ns or less.

- Click the [Update] button to update the image of waveform in the dialog box.
- When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



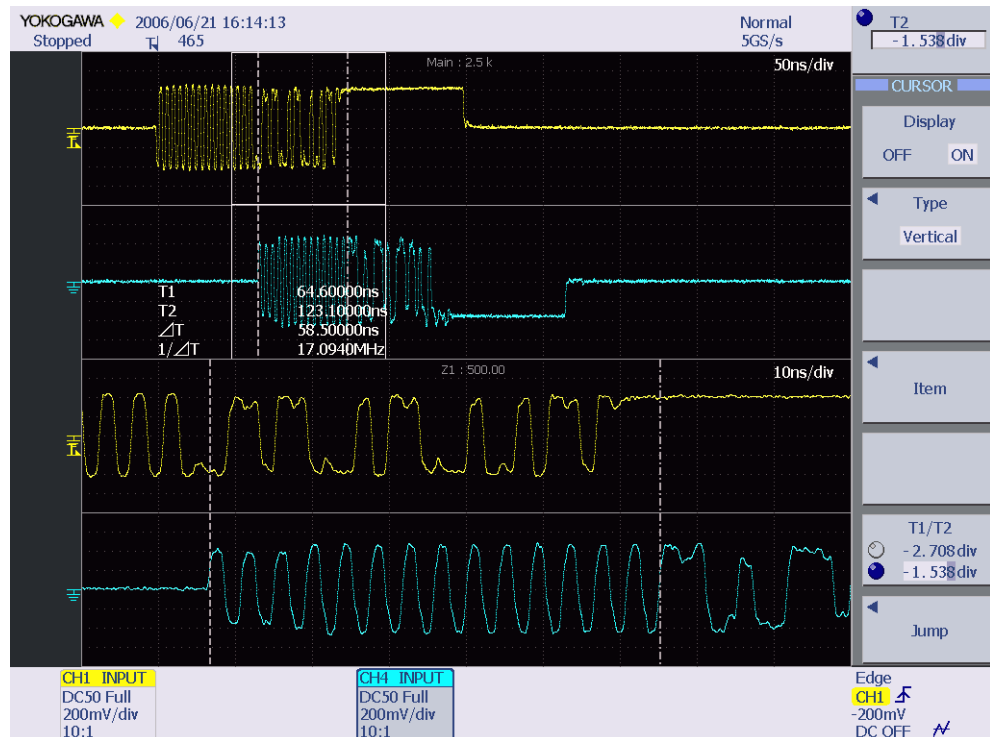
19. Click the [Next] button in the dialog box of the busXplorer-USB. Measure the number of bits in the Sync field (EL_42).

Using the oscilloscope's zoom/cursor function, measure number of bits in the sync field on the hub's downstream port under test. Adjust zoom1 position to the Sync field on the hub's downstream port and set T1 cursor on the start of the Sync field and set T2 cursor on the end of the Sync field.

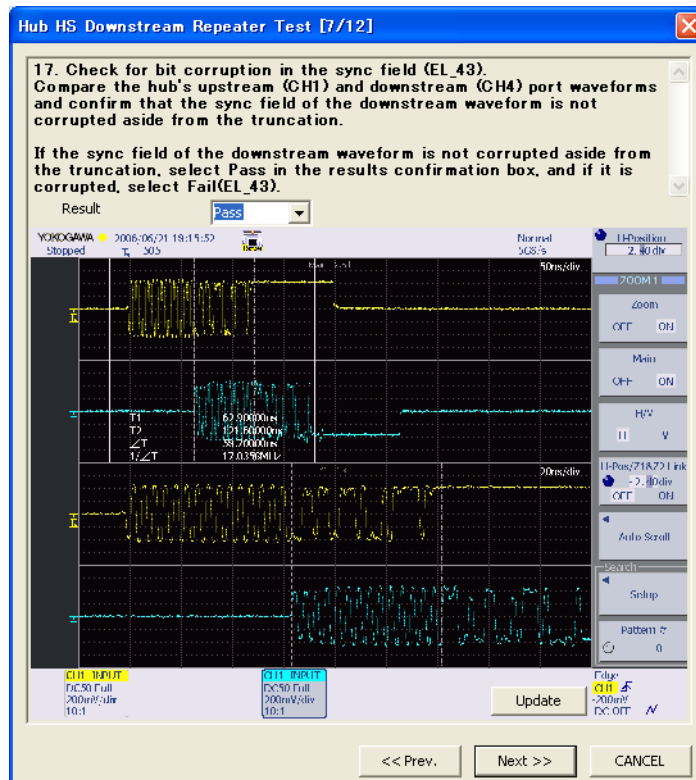
Confirm that the number of bits in the Sync field is between 28 and 32 bits.

Note

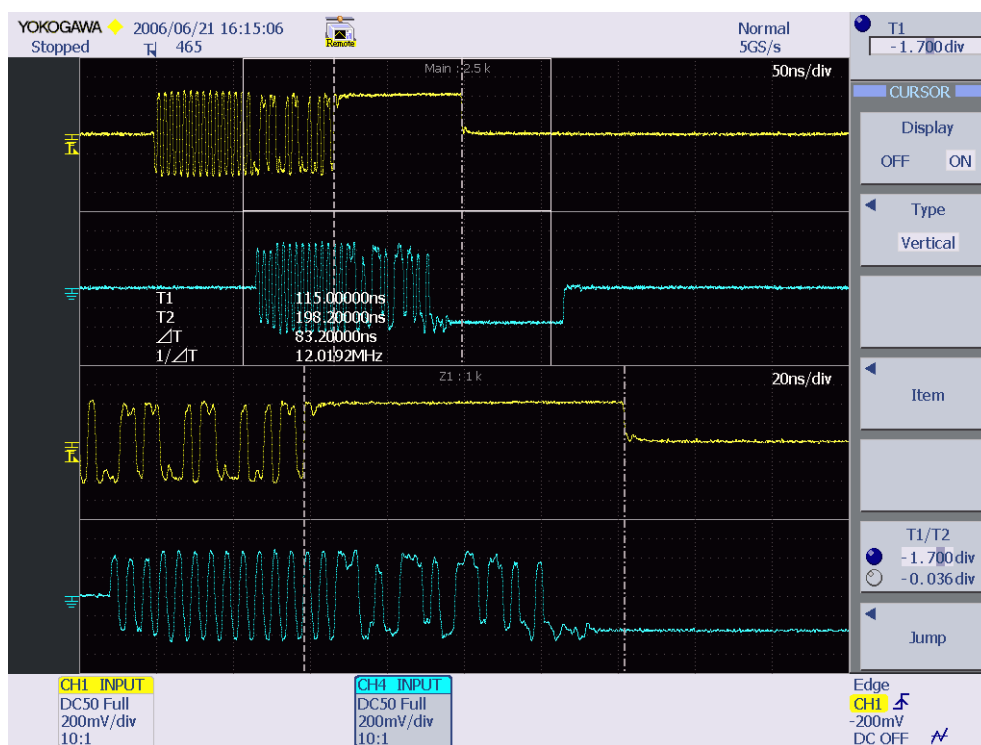
- Note that the Sync field starts from the Hi-Speed idle transitions to a falling edge. Count both rising and falling edges until the first two consecutive 1's and include the first 1.
- When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



20. Click the **[Next]** button in the dialog box of the busXplorer-USB.
 Check for bit corruption in the sync field (EL_43).
 Compare the hub's upstream (CH1) and downstream (CH4) port waveforms and confirm that the sync field of the downstream waveform is not corrupted aside from the truncation.
 If the sync field of the downstream waveform is not corrupted aside from the truncation, select Pass in the results confirmation box, and if it is corrupted, select Fail(EL_43).
 When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



- 21.** Click the **[Next]** button in the dialog box of the busXplorer-USB.
 Measure the EOP pulse width (EL_44). Using the oscilloscope's zoom/cursor function, measure the time between the start and the end points of the EOP packet of the waveforms on the hub's upstream port (CH1). Adjust zoom1 position to the EOP packet, and set T1 cursor at the start point of the EOP packet, and set T2 cursor at the end point of the EOP packet.
 Click the **[Update]** button to update the image of waveform in the dialog box.

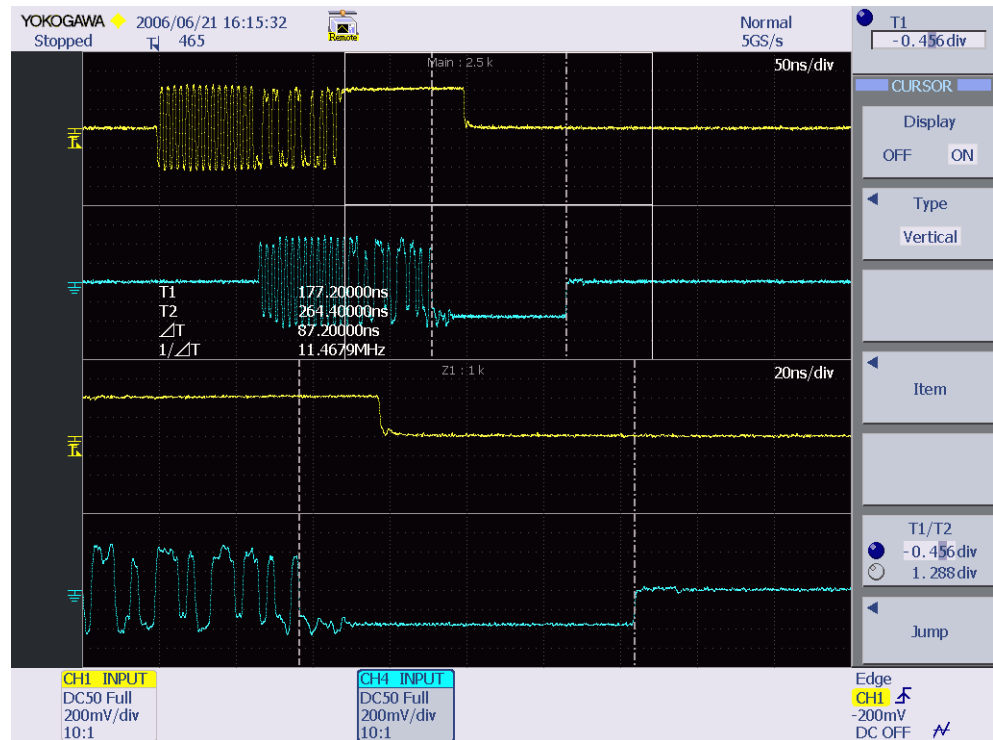


22. Click the **[Next]** button in the dialog box of the busXplorer-USB.

Using the oscilloscope's zoom/cursor function, measure the time between the start and the end points of the EOP packet of the waveforms on the hub's downstream port (CH4). Adjust zoom1 position to the EOP packet, and set T1 cursor at the start point of the EOP packet, and set T2 cursor at the end point of the EOP packet.

Confirm that the number of bits on CH4 is not 4 bits longer than CH1 (EL44).

- Click the [Update] button to update the image of waveform in the dialog box.
- When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



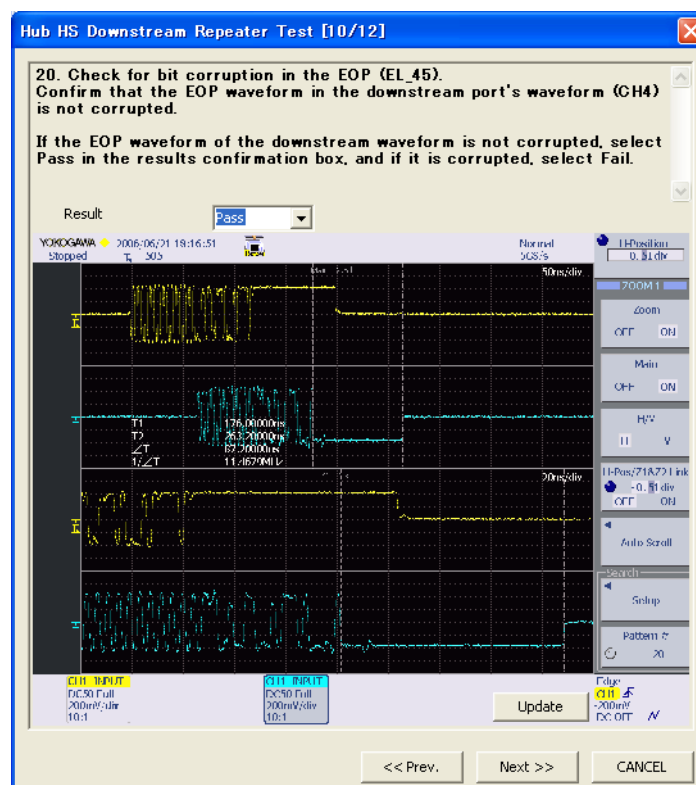
23. Click the [Next] button in the dialog box of the busXplorer-USB.

Check for bit corruption in the EOP (EL_45).

Confirm that the EOP waveform in the downstream port's waveform (CH4) is not corrupted.

If the EOP waveform of the downstream waveform is not corrupted, select Pass in the results confirmation box, and if it is corrupted, select Fail.

- Click the [Update] button to update the image of waveform in the dialog box.
- When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



24. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box is displayed.

Hub HS Downstream Repeater Test [11/12]

21. The HS Downstream Repeater test executes.
Repeat steps 13-21, and execute the test the number of times specified in Number of Repetition.

Number of repetition: 1/1

Result

Pass	1
Fail	0

Parameter	Min.	Max.	Result	unit
EL48:	***	79.000n	64.800n	s
EL42:	28.000	32.000	28.176	bit
EL43:	***	***	Pass	
EL44:UpEOP	***	***	40.032	bit
DownEOP	***	***	41.856	bit
EOPDribble	0.0000	4.0000	1.8240	bit
EL45:	***	***	Pass	

Next >> CANCEL

25. Click the **[Next]** button in the dialog box of the busXplorer-USB, repeat steps 17-24, and execute the test the number of times specified in "Number of Repetition."

- When this number of tests is completed, the test results dialog box as shown below is displayed.
- Click the **[Detail]** button to display the test results by Internet Explorer.
- Click the **[Image]** button to display an image of the digital oscilloscope screen.
- Click the **[Analyze]** button to start Xviewer and display the waveform data. Xviewer must already have been installed.

22. Record the test results in EL_48, EL_42, EL_43, EL_44, and EL_45.

23. Remove the differential probe from the test fixture.

File "U:\¥16 USB Compliance Test¥Test Procedure¥プログラム文字列¥櫻井¥Image 提出用¥Hub¥Hub_HS_Downstream Repeater¥Yokogawa_003.xml"

Number of repetition: 1/1

Result
Pass 1
Fail 0

Parameter	Min.	Max.	Result	unit	Image	Analyze
EL48:	***	79.000n	64.800n	s
EL42:	28.000	32.000	28.176	bit
EL43:	***	***	Pass	
EL44:UpEOP	***	***	40.032	bit
DownEOP	***	***	41.856	bit
EOPDribble	0.0000	4.0000	1.8240	bit
EL45:	***	***	Pass	

Detail OK

26. Record the test results in EL_48, EL_42, EL_43, EL_44, and EL_45.

- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission
- All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.

2.13. Hub Repeater Test, Upstream Facing Port (EL_42, EL_43, EL_44, EL_45)

- **USB 2.0 Electrical Test Specification**

- EL_42

Hub repeaters must not truncate more than 4 bits from a repeated SYNC pattern.

- EL_43

Hubs must not corrupt any repeated bits of the SYNC field.

- EL_44

A hub may add at most 4 random bits to the end of the EOP field when repeating a packet.

- EL_45

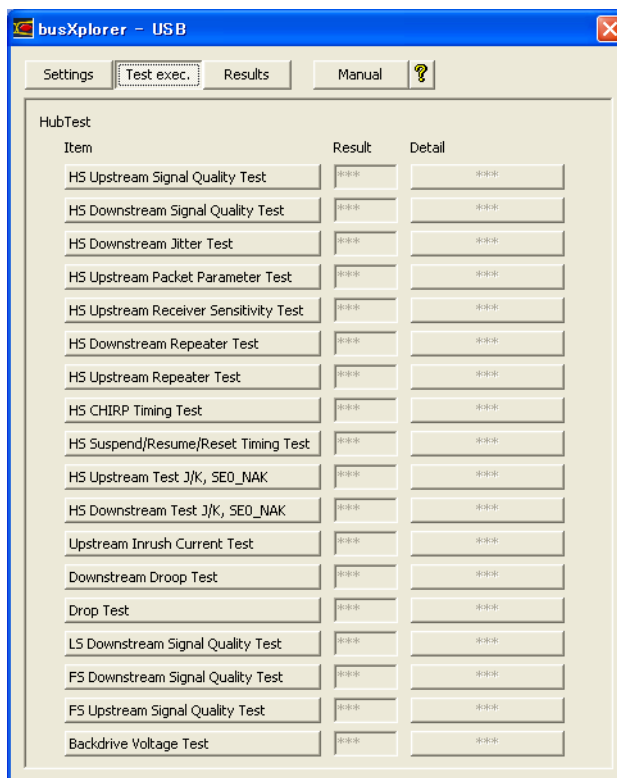
A hub must not corrupt any of the valid EOP bits when repeating a packet.

- **Instruments Used**

Name	Quantity
DL9240/DL9240L Digital Oscilloscope	1
PBD2000 Differential Probe	2
PBD2000 Probe attachment	2 sets
USB-IF compliant 1 m USB 2.0 cable	1
USB-IF Compliant Hi-Speed Device	1
Test bed computer	1
USB compliance test fixture	1
5 V power supply for test fixture	1

- **Executing the Test**

1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



2. Click the **[HS Upstream Repeater Test]** button in the dialog box.
The Hub HS Upstream Repeater Test dialog box is displayed.

Hub HS Upstream Repeater Test [1/12]

1. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.

2. If necessary, enter a comment for the test in Comment text box. The comment is saved together with test result and displayed in the Test Result Dialog box.

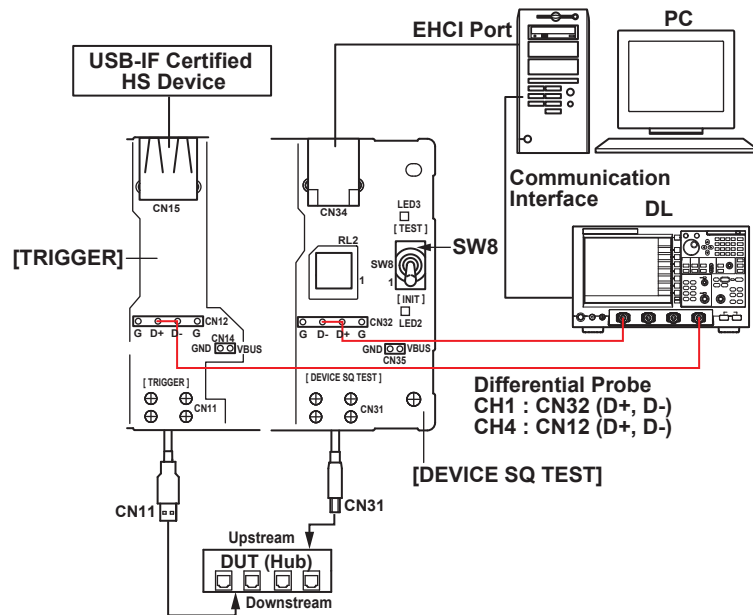
Number of repetition:

Parameter	Min.	Max.	unit	Default
EL42:	28.000	32.000	bit	<input type="checkbox"/>
EL43:	***	***	bit	<input type="checkbox"/>
EL44:UpEOP	***	***	bit	<input type="checkbox"/>
DownEOP	***	***	bit	<input type="checkbox"/>
EOPDribble	0.0000	4.0000	bit	<input type="checkbox"/>
EL45:	***	***	bit	<input type="checkbox"/>

Comment:

3. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.
4. If necessary, enter a comment for the test in Comment text box.
The comment is saved together with test result and displayed in the Test Result Dialog box.
5. If you wish to change the judgment range, you can edit the judgment criteria for EL_42, and EL_44.
Default values for the judgment criteria are as follows:
 - EL_42
Min.: 28.00 bit, Max.: 32.00 bit
 - EL_44 EOPDribble
Min.: 0.00 bit, Max.: 4.00 bit
 If you click the [Default] button after changing the judgment range, the default values of the judgment range are restored.

6. Click the **[Next]** button in the dialog box of the busXplorer-USB.
A connection diagram as shown below is displayed.



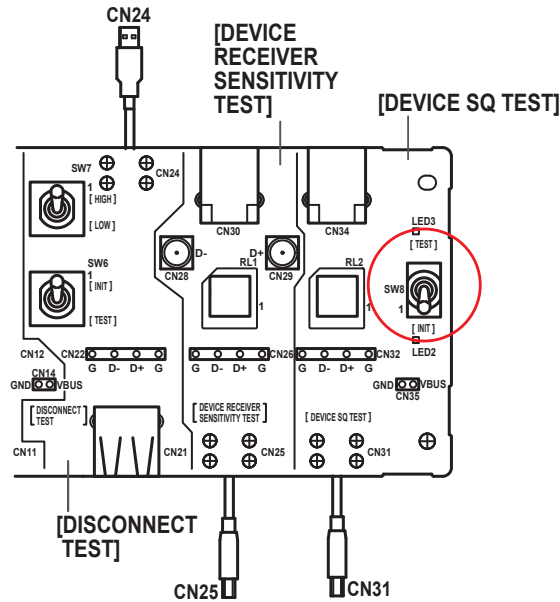
7. Turn ON the power to the test fixture and verify that the green power supply LED1 is lit.
8. Connect the CN31 connector of the DEVICE SQ TEST block to the upstream port of the DUT.
9. Connect the test bed computer to the CN34 connector of the DEVICE SQ TEST block using a 1 m USB cable
10. Connect the downstream port of the DUT to the CN11 connector of the TRIGGER block.
11. Connect the USB-IF Compliant Hi-Speed Device to the CN15 connector.
12. Connect two PBD2000 Differential Probes, one to CH1 and the other to CH4 of the digital oscilloscope.

Note

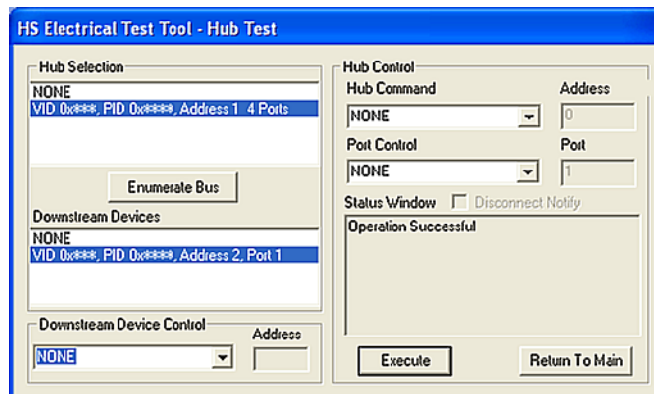
After connecting the probe, heat emitted from the probe causes the offset voltage to drift. The probe should nearly stabilize about thirty minutes after applying power.

13. Attach the attachments on the tips of the differential probes, then connect the CH1 probe to D+ and D- of CN32, and the CH4 probe to D+ and D+ of CN12. For the polarity, match up the plus side on the differential probe to D+ (the D+ pin at CN32 or CN12) and the minus side to D- (the D- pin at CN32 or CN12).
14. Turn ON the power to the DUT and the USB-IF compliant Hi-Speed device.

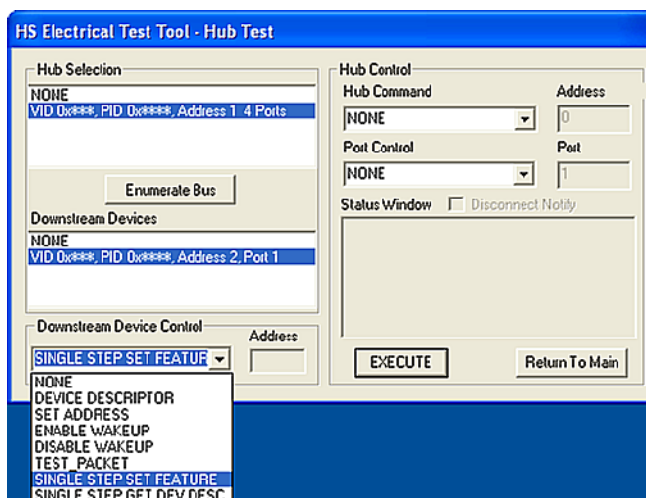
15. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, place SW8 of the test fixture to the INIT position.
Verify LED2 of the test fixture is lit.



16. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, click the **[Enumerate Bus]** button in the HS Electrical Test Tool. Confirm that the VID, PID, connected address, and port of the DUT are displayed under Hub Selection .
If not already running, start the HS Electrical Test Tool. Select hub under SelectSelect Hub under Select Type of Test, click the TEST button, then confirm the above.



17. Click the **[Next]** button in the dialog box of the busXplorer-USB. Following the instructions in the dialog box that is displayed, select SINGLE STEP FEATURE from the Downstream Device Control drop down menu in the HS Electrical Test Tool then click the **[EXECUTE]** button.



18. Click the **[Next]** button in the dialog box of the busXplorer-USB, check the digital oscilloscope screen to confirm that a trigger activates and packet is displayed.
- If the trigger does not activate, adjust the trigger level as needed. Then, select SINGLE STEP SET FEATURE again from the Device Command drop down menu in the HS Electrical Test Tool, and click the **[EXECUTE]** button again.
 - Click the **[Update]** button to update the image of waveform in the dialog box.

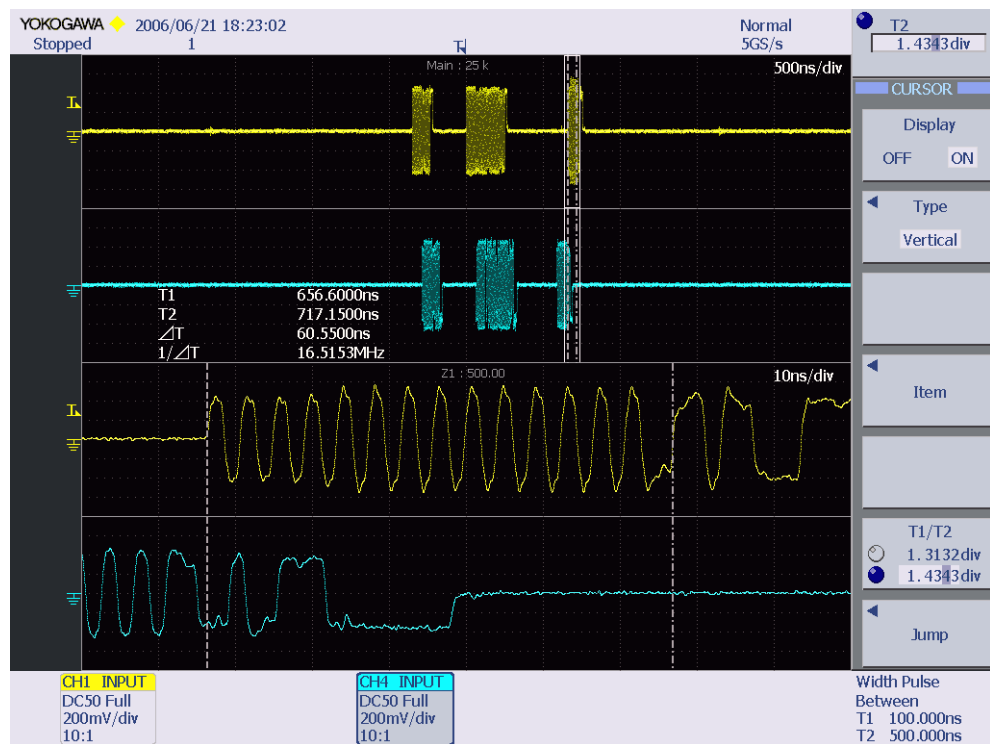
19. Measure the number of bits in the Sync field (EL_42).

Using the oscilloscope's zoom/cursor function, measure number of bits in the 3rd sync field on the hub's upstream port under test. Adjust zoom1 position to the 3rd Sync field on the hub's upstream port and set T1 cursor on the start of the Sync field and set T2 cursor on the end of the Sync field.

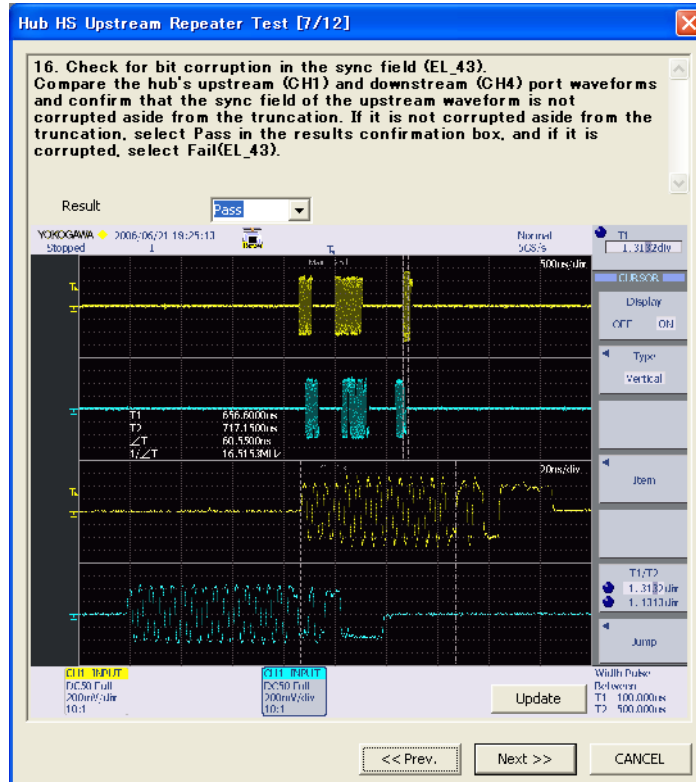
Confirm that the number of bits in the Sync field is between 28 and 32 bits.

Note

- Note that the Sync field starts from the Hi-Speed idle transitions to a falling edge. Count both rising and falling edges until the first two consecutive 1's and include the first 1.
- When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



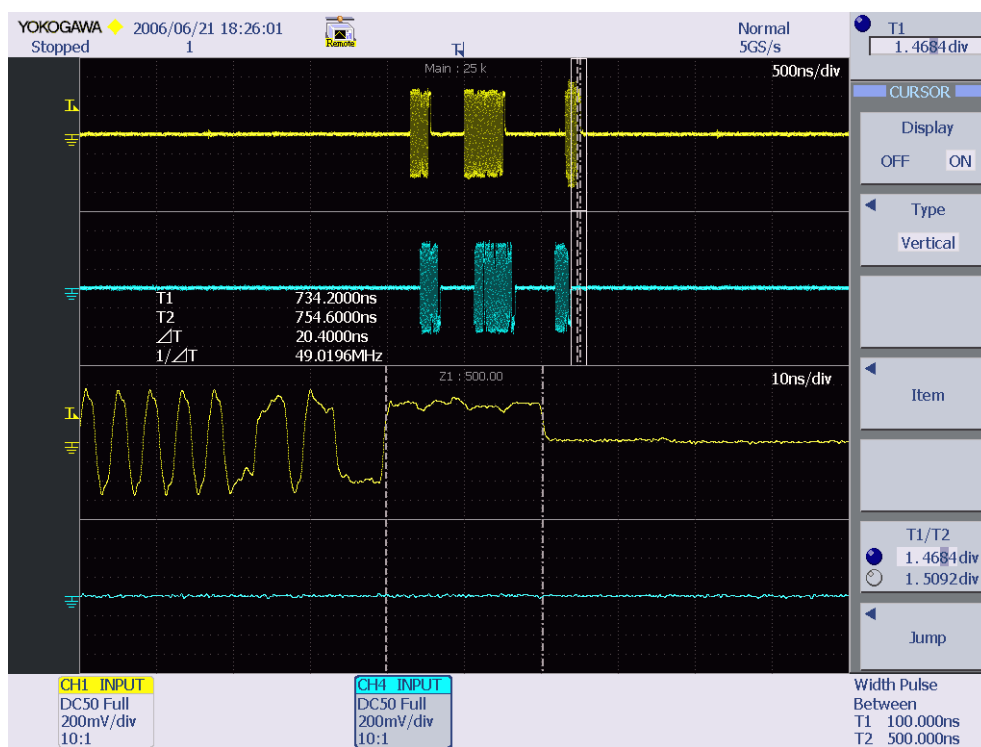
20. Click the **[Next]** button in the dialog box of the busXplorer-USB. Check for bit corruption in the sync field (EL_43). Compare the hub's upstream (CH1) and downstream (CH4) port waveforms and confirm that the sync field of the upstream waveform is not corrupted aside from the truncation. If it is not corrupted aside from the truncation, select Pass in the results confirmation box, and if it is corrupted, select Fail (EL_43). When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



21. Click the **[Next]** button in the dialog box of the busXplorer-USB.

Using the oscilloscope's zoom/cursor function, measure the time between the start and the end points of the EOP width of the 3rd packet of the waveforms on the hub's upstream port (CH1). Adjust zoom1 position to the EOP packet, and set T1 cursor at the start point of the EOP packet, and set T2 cursor at the end point of the EOP packet.

Click the **[Update]** button to update the image of waveform in the dialog box.

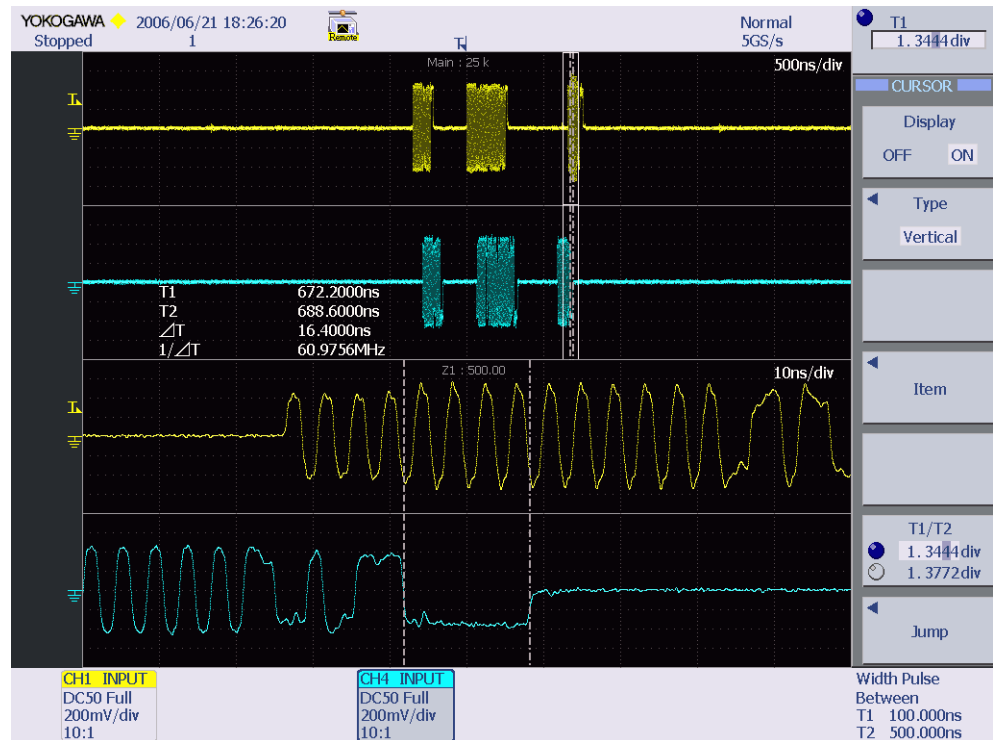


22. Click the **[Next]** button in the dialog box of the busXplorer-USB.

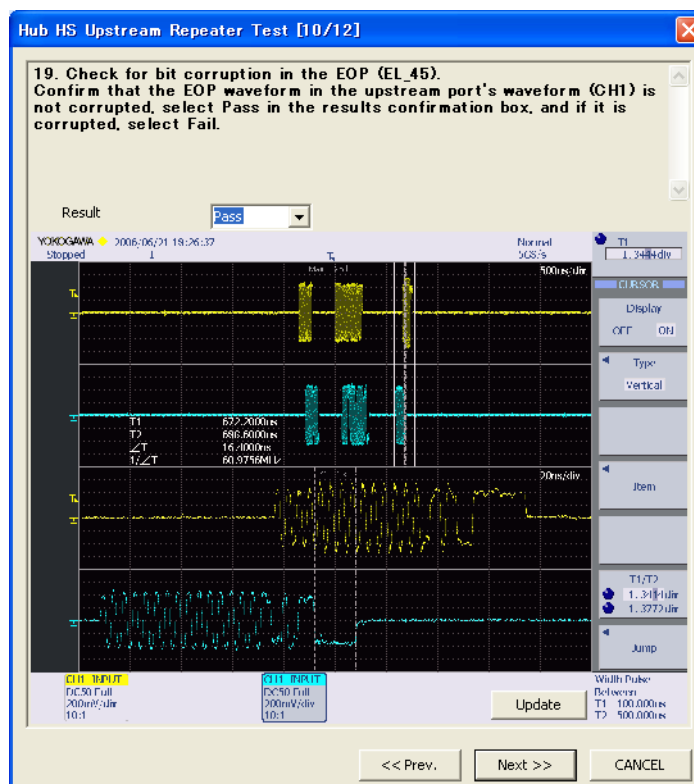
Using the oscilloscope's zoom/cursor function, measure the time between the start and the end points of the EOP width of the 3rd packet on the hub's downstream port (CH4). Adjust zoom1 position to the EOP packet, and set T1 cursor at the start point of the EOP packet, and set T2 cursor at the end point of the EOP packet.

Confirm that the number of bits on CH1 is not 4 bits longer than CH4 (EL44).

- Click the [Update] button to update the image of waveform in the dialog box.
- When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



- 23.** Click the **[Next]** button in the dialog box of the busXplorer-USB.
Check for bit corruption in the EOP (EL_45).
Confirm that the EOP waveform in the upstream port's waveform (CH1) is not corrupted, select Pass in the results confirmation box, and if it is corrupted, select Fail.
- Click the [Update] button to update the image of waveform in the dialog box.
 - When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



24. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box is displayed.

Hub HS Upstream Repeater Test [11/12]

20. The HS Upstream Repeater test executes.
Repeat steps 13-20, and execute the test the number of times specified in Number of Repetition.

Number of repetition: 1/1

Result

Pass	1
Fail	0

Parameter	Min.	Max.	Result	unit
EL42:	28.000	32.000	29.064	bit
EL43:	***	***	Pass	
EL44:UpEOP	***	***	9.7920	bit
DownEOP	***	***	7.8720	bit
EOPDribble	0.0000	4.0000	1.9200	bit
EL45:	***	***	Pass	

Next >> CANCEL

25. Click the **[Next]** button in the dialog box of the busXplorer-USB, repeat steps 16-24, and execute the test the number of times specified in "Number of Repetition."

- When this number of tests is completed, the test results dialog box as shown below is displayed.
- Click the **[Detail]** button to display the test results by Internet Explorer.
- Click the **[Image]** button to display an image of the digital oscilloscope screen.
- Click the **[Analyze]** button to start Xviewer and display the waveform data. Xviewer must already have been installed.

Hub HS Upstream Repeater Test [12/12]

21. Record the test results in EL_42,EL_43,EL_44, and EL_45.
 22. Remove the differential probe from the test fixture.

Number of repetition: 1/1

Result:
 Pass: 1
 Fail: 0

Parameter	Min.	Max.	Result	unit	Image	Analyze
EL42:	28.000	32.000	29.064	bit
EL43:	***	***	Pass		...	
EL44:UpEOP	***	***	9.7920	bit	...	
DownEOP	***	***	7.8720	bit	...	
EOPDribble	0.0000	4.0000	1.9200	bit		
EL45:	***	***	Pass		...	

Detail

OK

26. Record the test results in EL_42,EL_43,EL_44, and EL_45.

- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission
- All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.

27. Remove the differential probe from the test fixture.

2.14. Hub CHIRP Timing, Upstream Facing Ports (EL_28, EL_29, EL_31)

- **USB 2.0 Electrical Test Specification**

- EL_28

Devices must transmit a CHIRP handshake no sooner than 2.5 μ s and no later than 6 ms when being reset from suspend or a full-speed state.

- EL_29

The CHIRP handshake generated by a device must be at least 1 ms and not more than 6 ms in duration.

- EL_31

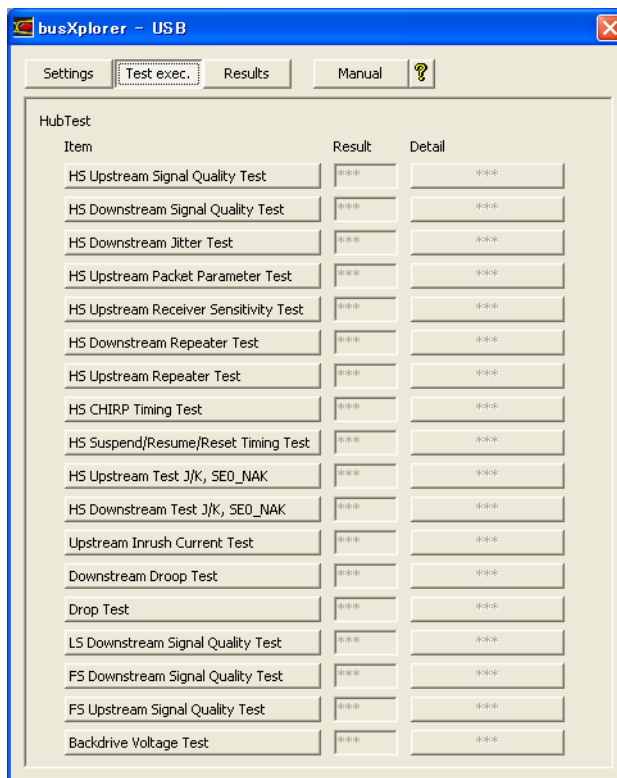
During device speed detection, when a device detects a valid CHIRP K-J-K-J-K-J sequence, the device must disconnect its 1.5 k Ω pull-up resistor and enable its hispeed terminations within 500 μ s.

- **Instruments Used**

Name	Quantity
DL9240/DL9240L Digital Oscilloscope	1
PBA2500 Active Probe	2
PBA2500 Probe attachment	2 sets
USB-IF compliant 1 m USB 2.0 cable	1
Test bed computer	1
USB compliance test fixture	1
5 V power supply for test fixture	1

- **Executing the Test**

1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



2. Click the **[HS CHIRP Timing Test]** button in the dialog box.
The Hub HS CHIRP Timing Test dialog box is displayed.

Hub HS CHIRP Timing Test [1/9]

1. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.

2. If necessary, enter a comment for the test in Comment text box. The comment is saved together with test result and displayed in the Test Result Dialog box.

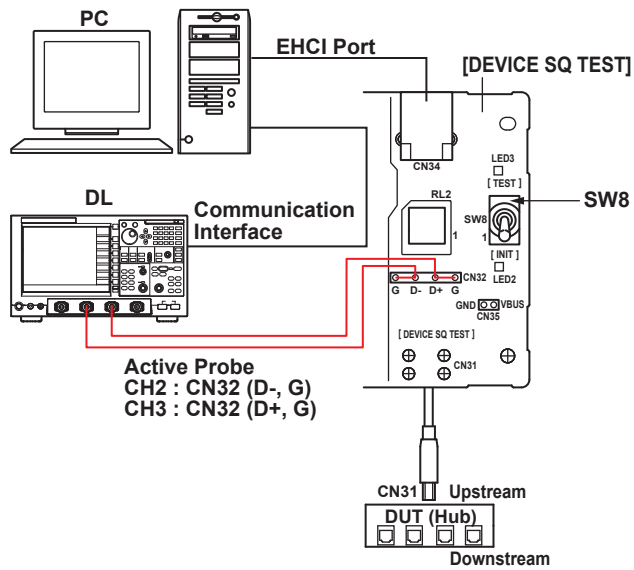
Number of repetition:

Parameter	Min.	Max.	Default
EL28:	<input type="text" value="2.5000u"/>	<input type="text" value="6.0000m"/>	<input type="button" value="s"/>
EL29:	<input type="text" value="1.0000m"/>	<input type="text" value="6.0000m"/>	<input type="button" value="s"/>
EL31:	<input type="text" value="***"/>	<input type="text" value="500.00u"/>	<input type="button" value="s"/>

Comment:

3. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.
4. If necessary, enter a comment for the test in Comment text box.
The comment is saved together with test result and displayed in the Test Result Dialog box.
5. If you wish to change the judgment range, you can edit the judgment criteria for EL_28, EL_29, and EL_31.
Default values for the judgment criteria are as follows:
 - EL_28
Min.: 2.50 μ s, Max.: 6.00 ms
 - EL_29
Min.: 1.00 ms, Max.: 6.00 ms
 - EL_31
Max.: 500 μ s
 If you click the [Default] button after changing the judgment range, the default values of the judgment range are restored.

6. Click the **[Next]** button.
A connection diagram as shown below is displayed.



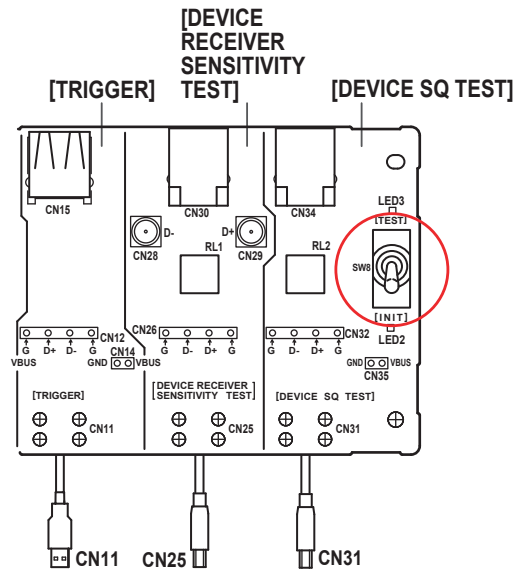
7. Turn ON the power to the DUT.
8. Turn ON the power to the test fixture and verify that the green power supply LED1 is lit.
9. Connect the CN31 connector of the DEVICE SQ TEST block to the upstream port of the DUT.
10. Connect the test bed computer to the CN34 connector of the DEVICE SQ TEST block using a 1 m USB cable.
11. Connect two PBA2500 active probes, one to CH2 and the other to CH3 of the digital oscilloscope.

Note

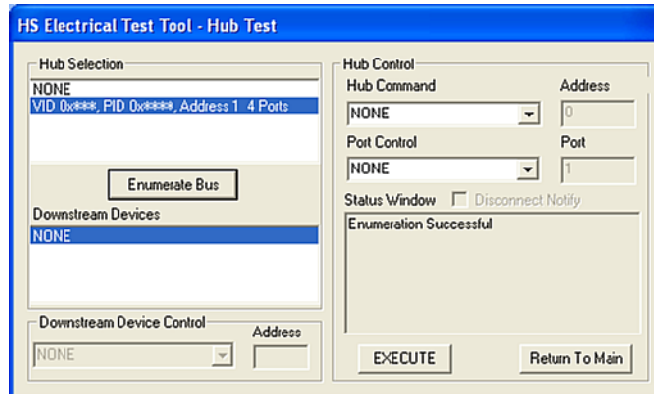
After connecting the probe, heat emitted from the probe causes the offset voltage to drift. The probe should nearly stabilize about thirty minutes after applying power.

12. Attach the attachments on the tips of the active probes, then connect the CH2 probe to GND and D- of CN32, and the CH3 probe to GND and D+ of CN32.

13. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, place SW8 of the test fixture to the INIT position.
Verify LED2 of the test fixture is lit.

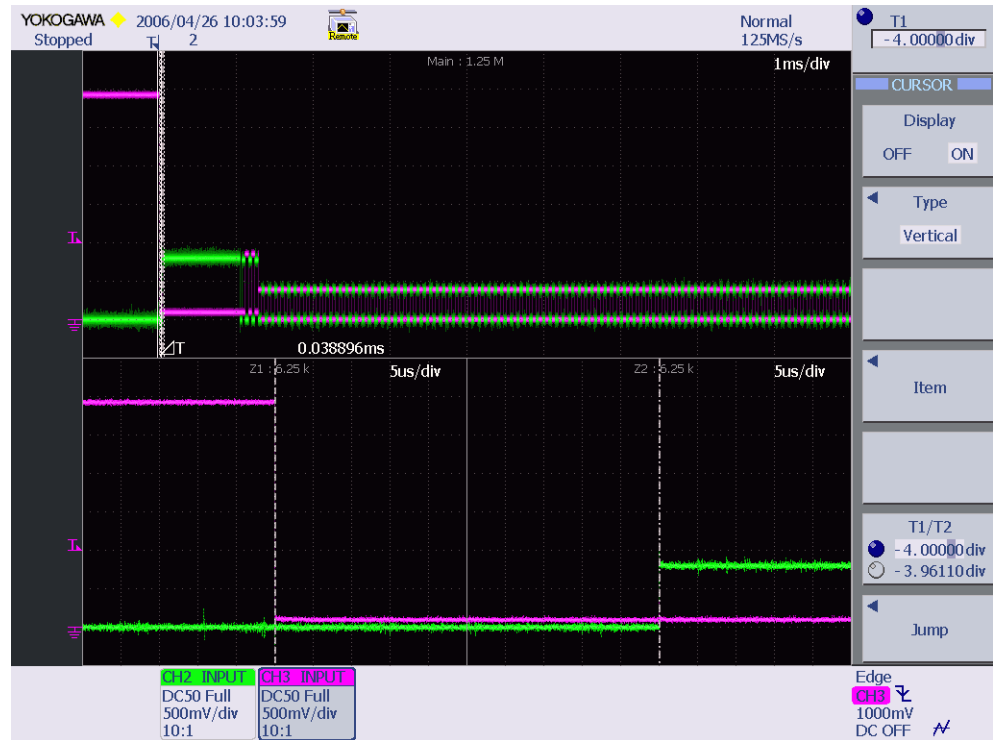


14. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, click the **[Enumerate Bus]** button in the HS Electrical Test Tool. Confirm that the VID, PID, connected address, and port of the DUT are displayed under Hub Selection .
If not already running, start the HS Electrical Test Tool. Select hub under SelectSelect Hub under Select Type of Test, click the TEST button, then confirm the above.



15. Click the **[Next]** button in the dialog box of the busXplorer-USB, check the digital oscilloscope screen to confirm that a trigger activates and CHIRP data is displayed.
- If the trigger does not activate, adjust the trigger level as needed
 - Click the [Update] button to update the image of waveform in the dialog box.

- 16.** The time from the host port reset to the start of device's CHIRP-K (latency) is measured. The requirement is between 2.5 μ s and 6.0 ms (EL_28).
When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



17. Click the [Next] button in the dialog box of the busXplorer-USB, and then the device's CHIRP-K duration is measured. The requirement of the duration is between 1.0 ms and 6.0 ms (EL_29).

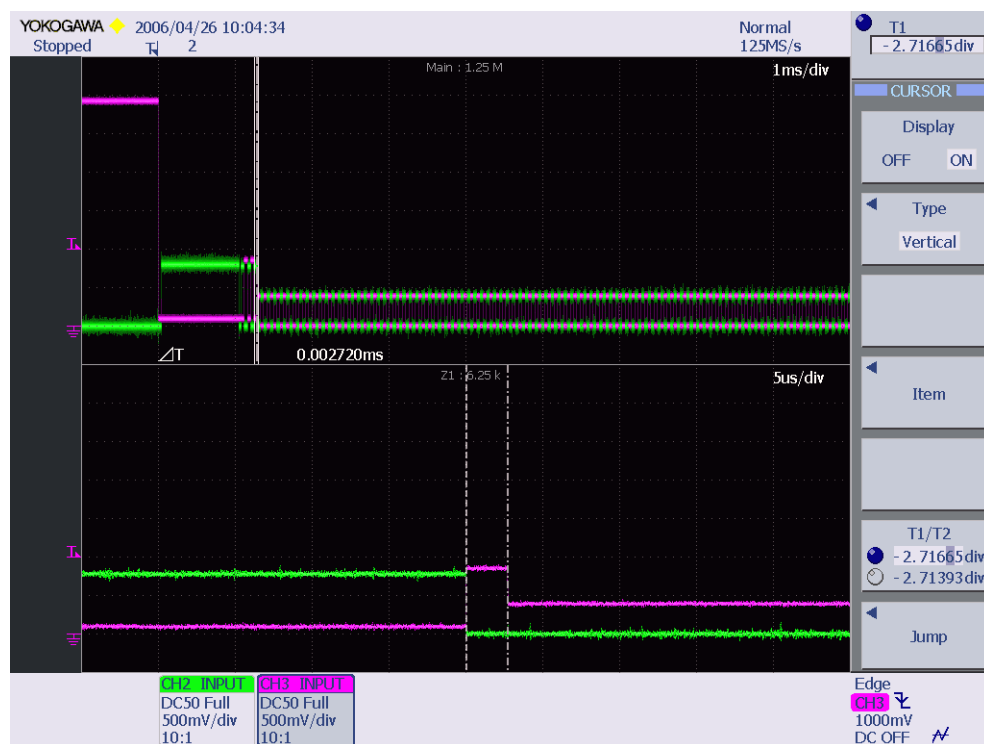
- Click the [Update] button to update the image of waveform in the dialog box.
- When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



18. Click the **[Next]** button in the dialog box of the busXplorer-USB.

The time from the last J in the CHIRP-K-J-K-J-K-J until the D+ pull-up resistor is disconnected and the device turns ON the Hi-Speed terminations is measured (EL_31). The time must be less than or equal to 500us.

- Click the [Update] button to update the image of waveform in the dialog box.
- When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



19. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box is displayed.

Hub HS CHIRP Timing Test [8/9]

16. The HS Upstream CHIRP Timing Test executes.
Repeat steps 11-16, and execute the test the number of times specified
in Number of Repetition.

Number of repetition: 1/1

Result
Pass 1
Fail 0

Parameter	Min.	Max.	Result	
EL28:	2.5000u	6.0000m	38.896u	s
EL29:	1.0000m	6.0000m	1.0111m	s
EL31:	***	500.00u	2.7200u	s

Next >> CANCEL

20. Click the **[Next]** button in the dialog box of the busXplorer-USB, repeat steps 14-19, and execute the test the number of times specified in “Number of Repetition.”

- When this number of tests is completed, the test results dialog box as shown below is displayed.
- Click the **[Detail]** button to display the test results by Internet Explorer.
- Click the **[Image]** button to display an image of the digital oscilloscope screen.
- Click the **[Analyze]** button to start Xviewer and display the waveform data. Xviewer must already have been installed.

Hub HS CHIRP Timing Test [9/9]

17. Record the test results in EL_28, EL_29, and EL_31.

Number of repetition: 1/1

Result:

Pass	1
Fail	0

Parameter

	Min.	Max.	Result		Image	Analyze
EL28:	2.5000u	6.0000m	38.896u	s
EL29:	1.0000m	6.0000m	1.0111m	s
EL31:	***	500.00u	2.7200u	s

Detail

OK

21. Record the test results in EL_28, EL_29, and EL_31.

- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission.
- All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.

2.15. Device Suspend/Resume/Reset Timing Upstream Facing Port (EL_27, EL_28, EL_38, EL_39, EL_40)

- **USB 2.0 Electrical Test Specification**

- EL_27

Devices must transmit a CHIRP handshake no sooner than 3.1 ms and no later than 6 ms when being reset from a non-suspended hi-speed mode. The timing is measured from the beginning of the last SOF transmitted before the reset begins.

- EL_28

Devices must transmit a CHIRP handshake no sooner than 2.5 μ s and no later than 6 ms when being reset from suspend or a full-speed state.

- EL_38

A device must revert to full-speed termination no later than 125 μ s after there is a 3 ms idle period on the bus.

- EL_39

A device must support the Suspend state.

- EL_40

If a device is in the suspend state, and was operating in hi-speed before being suspended, then device must transition back to hi-speed operation within two bit times from the end of resume signaling.

- **Instruments Used**

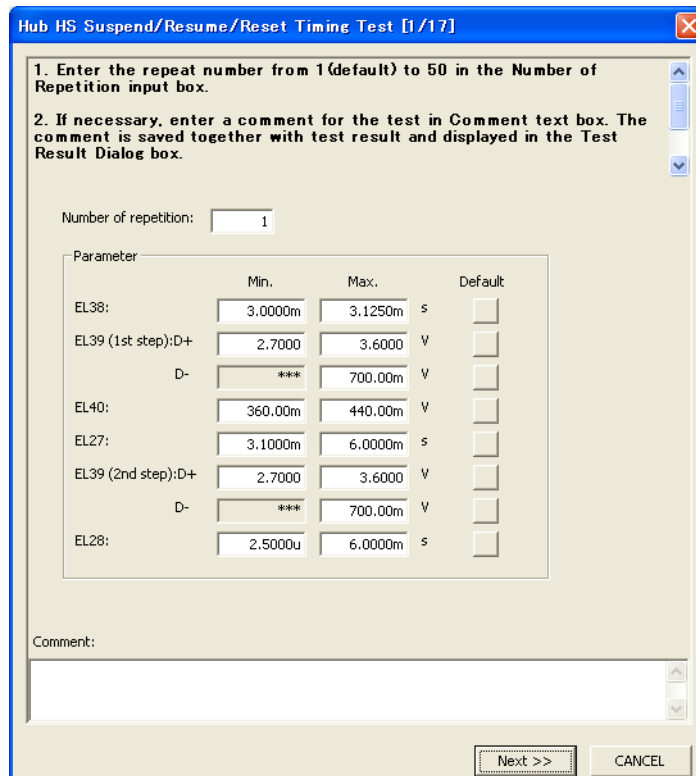
Name	Quantity
DL9240/DL9240L Digital Oscilloscope	1
PBA2500 Active Probe	2
PBA2500 Probe attachment	2 sets
USB-IF compliant 1 m USB 2.0 cable	1
Test bed computer	1
USB compliance test fixture	1
5 V power supply for test fixture	1

- **Executing the Test**

1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.

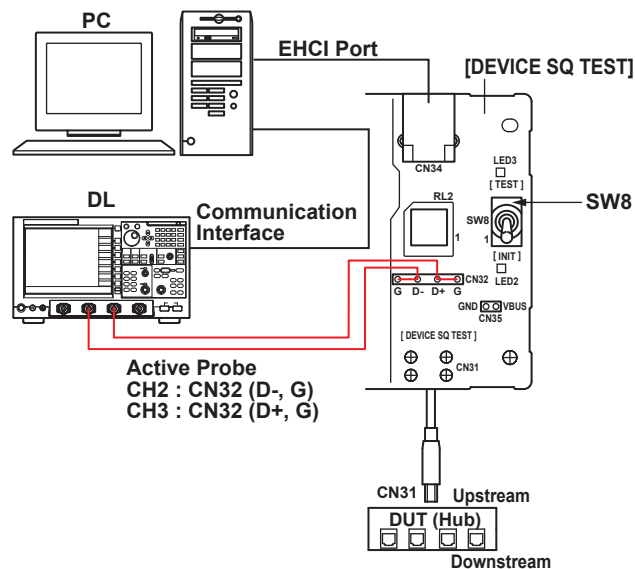


2. Click the **[HS Suspend/Resume/Reset Timing Test]** button in the dialog box. The Hub HS Suspend/Resume/Reset Timing Test dialog box is displayed.



3. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box. .
4. If necessary, enter a comment for the test in Comment text box.
The comment is saved together with test result and displayed in the Test Result Dialog box.
5. If you wish to change the judgment range, you can edit the judgment criteria for EL_27, EL_28, EL_29, EL_39, and EL_40.
Default values for the judgment criteria are as follows:
 - EL_38
Min.: 3.000 ms, Max.: 3.125 ms
 - EL_39 (1st step) D+
Min.: 2.7 V, Max.: 3.6 V
 - EL_39 (1st step) D-:
Max.: 700 mV
 - EL_40
Min.: 360 mV, Max.: 440 mV
 - EL_27
Min.: 3.1 ms, Max.: 6.0 ms
 - EL_39 (2nd step) D+
Min.: 2.7 V, Max.: 3.6 V
 - EL_39 (2nd step) D-
Max: 700 mV
 - EL_28
Min.: 2.5 μ s, Max.: 6.0 ms

If you click the [Default] button after changing the judgment range, the default values of the judgment range are restored.
6. Click the **[Next]** button in the dialog box of the busXplorer-USB.
A connection diagram as shown below is displayed.



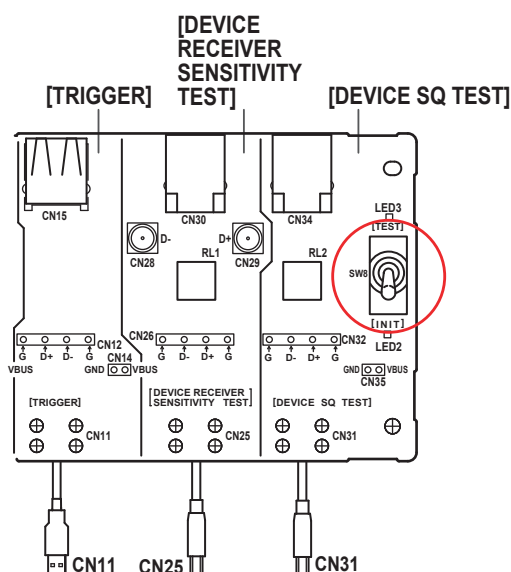
7. Turn ON the power to the DUT.
8. Turn ON the power to the test fixture and verify that the green power supply LED1 is lit.
9. Connect the CN31 connector of the DEVICE SQ TEST block to upstream port of the DUT.
10. Connect the test bed computer to the CN34 connector of the DEVICE SQ TEST block using a 1 m USB cable.

11. Connect the PBA2500 active probes to CH2 and CH3 of the digital oscilloscope.

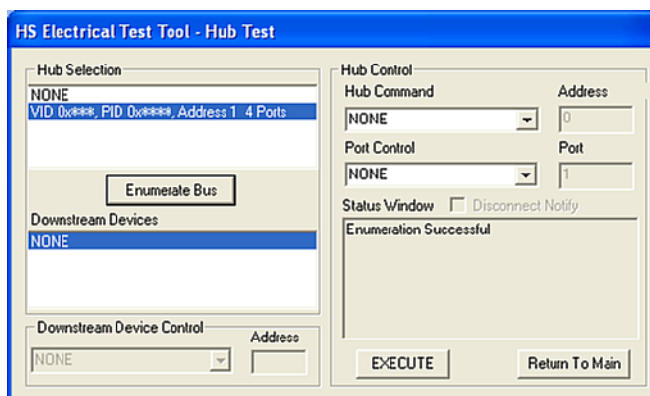
Note

After connecting the probe, heat emitted from the probe causes the offset voltage to drift. The probe should nearly stabilize about thirty minutes after applying power.

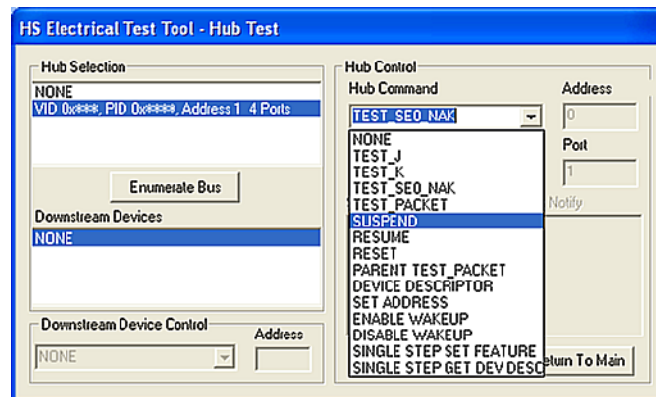
12. Attach the attachments on the tips of the active probes, and then connect the CH2 probe to GND and D- of CN32, and the CH3 probe to GND and D+ of test pin CN32.
13. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, place SW8 of the test fixture to the INIT position.
Verify LED2 of the test fixture is lit.



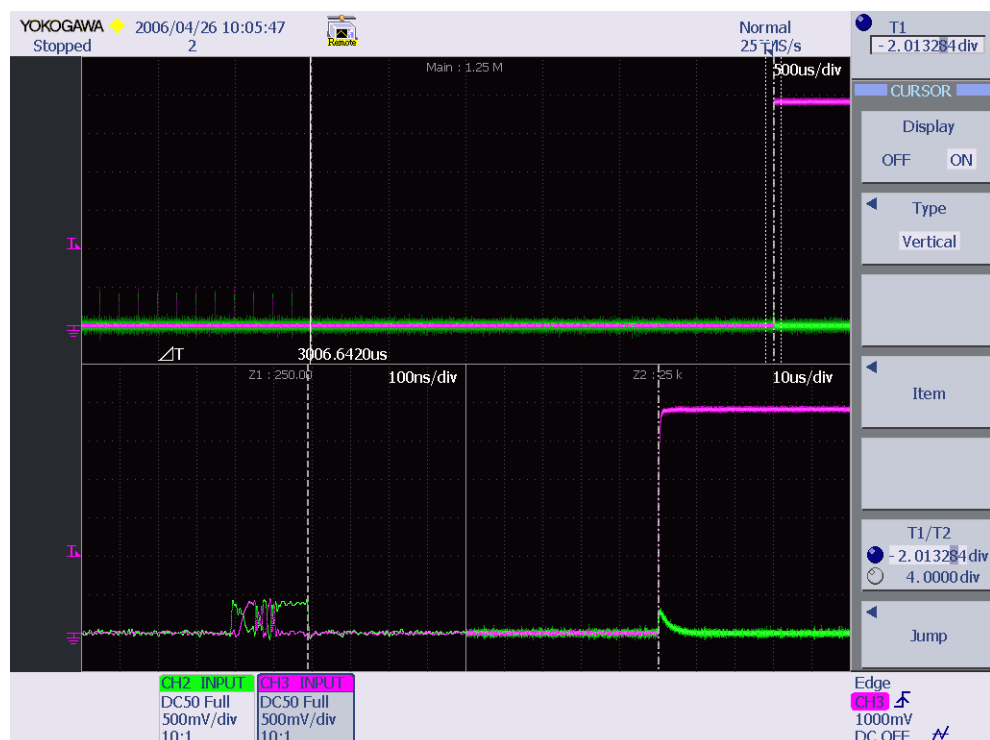
14. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, click the **[Enumerate Bus]** button in the HS Electrical Test Tool. Confirm that the VID, PID, connected address, and port of the DUT are displayed under Hub Selection .
If not already running, start the HS Electrical Test Tool. Select Hub under Select Type of Test, click the TEST button, then confirm the above.



15. Click the **[Next]** button in the dialog box of the busXplorer-USB. Select SUSPEND from the Hub Command drop down menu in the HS Electrical Test Tool, then click **[EXECUTE]** button.



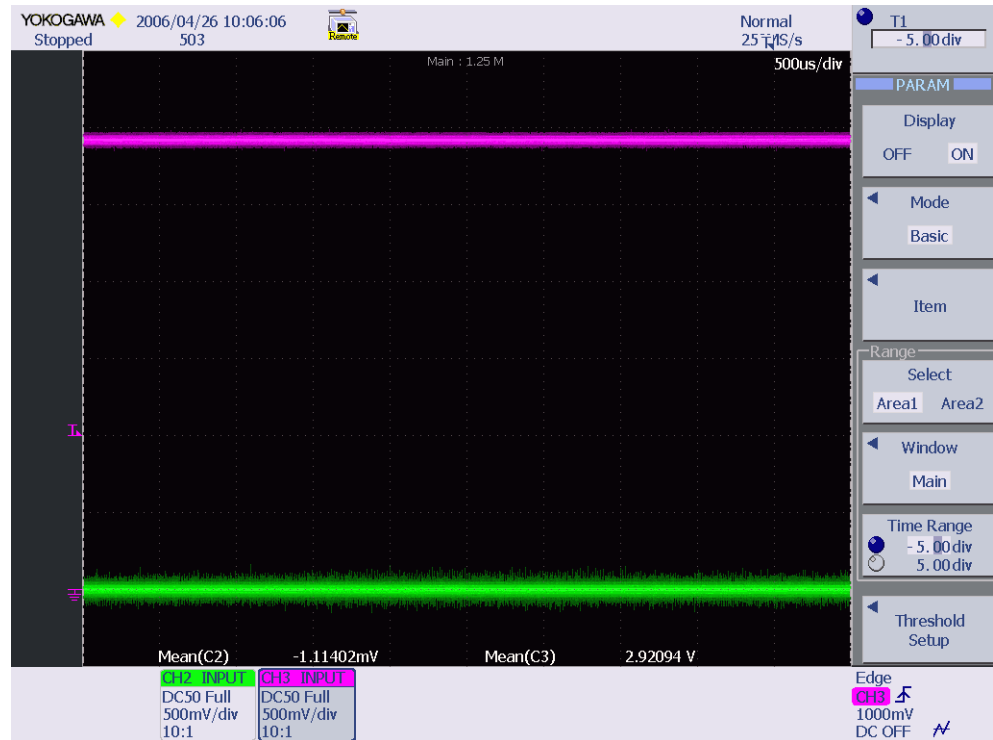
16. Click the **[Next]** button in the dialog box of the busXplorer-USB, check the digital oscilloscope screen to confirm that a trigger activates and the Suspend signal is displayed.
- If the trigger does not activate, adjust the trigger level as needed
 - Click the [Update] button to update the image of waveform in the dialog box.
17. Using the oscilloscope's cursor/zoom function, measure the time from the end of the last SOF packet to the point when the hub connects its full speed pull-up resistor on D+ (EL_38). Adjust zoom1 position to the last SOF packet and set T1 cursor on the end of the SOF packet in zoom1. The requirement of the time is between 3.000 ms and 3.125 ms.
- Do not change position of zoom2 and cursor T2.
 - Click the [Update] button to update the image of waveform in the dialog box.
 - When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



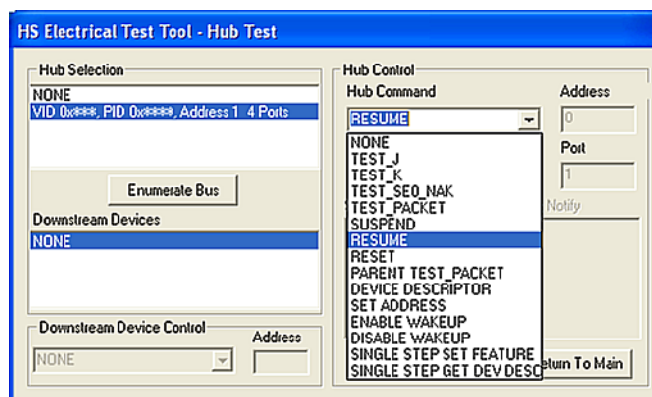
18. Click the **[Next]** button in the dialog box of the busXplorer-USB.

The trigger mode on the digital oscilloscope is set to Auto Mode to confirm the hub is still in the suspend state and to measure D+ and D- voltage (EL_39). The requirement of D+ voltage is between 2.7 V and 3.6 V, D- voltage is less than 0.7 V.

- Click the [Update] button to update the image of waveform in the dialog box.
- When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



19. Click **[Next]** in the dialog box of the busXplorer-USB, and then choose RESUME from Hub Command drop down menu in the HS Electrical Test Tool, then click the **[EXECUTE]** button.

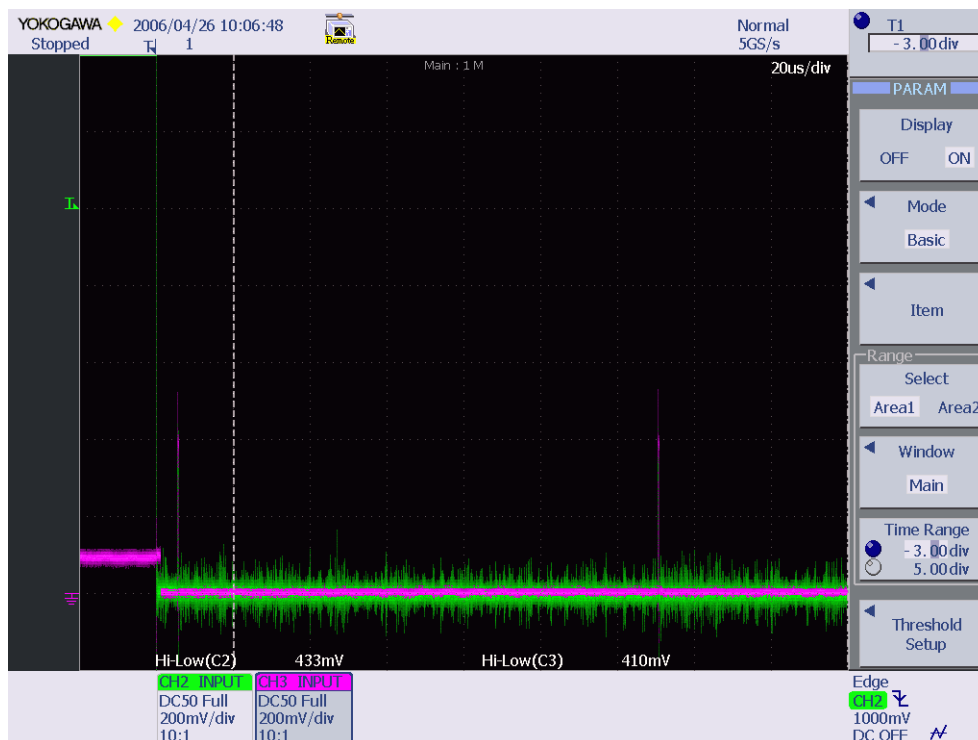


20. Click the **[Next]** button in the dialog box of the busXplorer-USB, check the digital oscilloscope screen to confirm that a trigger activates and the Resume signal is displayed.

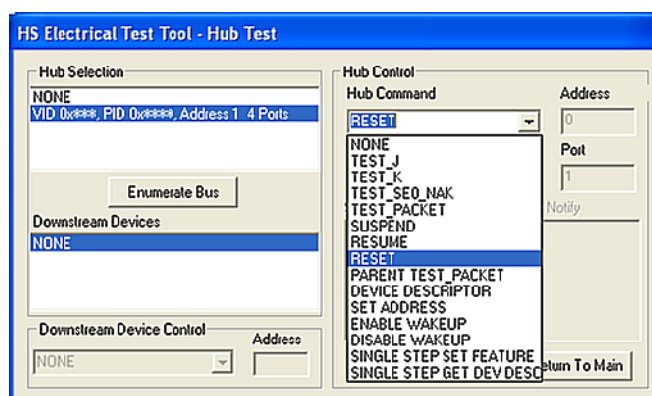
- The hub should resume in Hi-Speed mode.
- If the trigger does not activate, adjust the trigger level as needed
- Click the [Update] button to update the image of waveform in the dialog box.

21. The amplitude of the Hi-Speed SOF packets following the K state driven by the host controller is measured (EL_40). The requirement is between 360 mV and 440 mV.

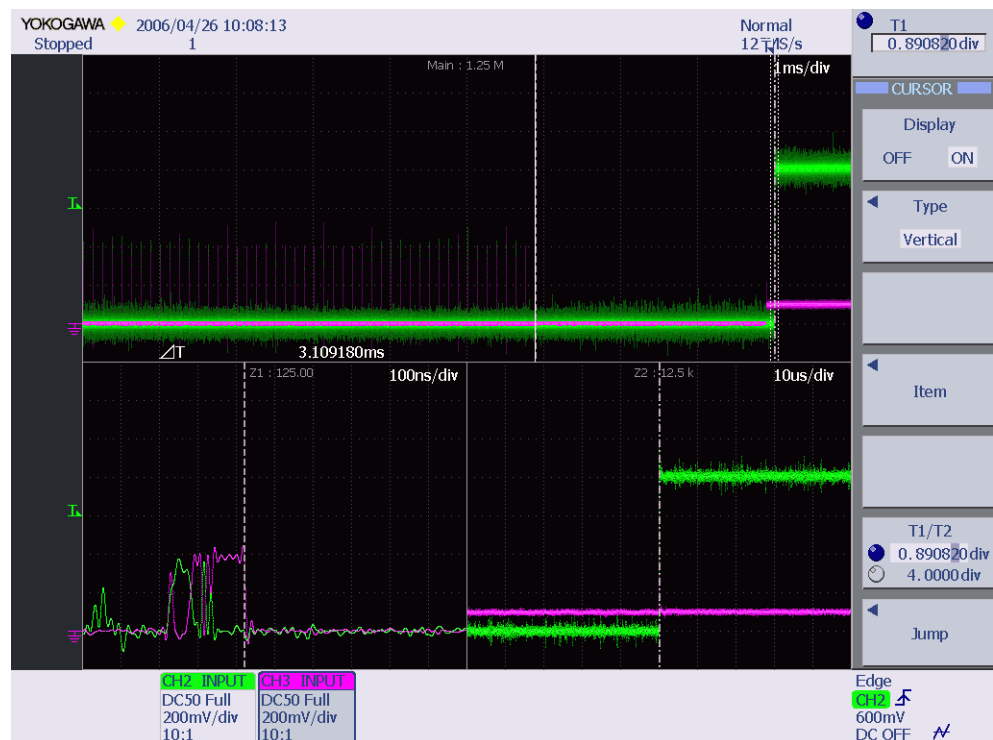
When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



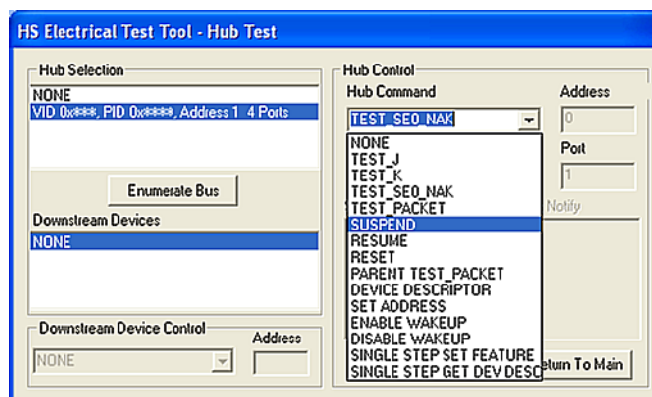
22. Click the [Next] button in the dialog box of the busXplorer-USB, and then select Reset from Hub Command drop down menu in the HS Electrical Test Tool, then click the [EXECUTE] button.



23. Click the **[Next]** button in the dialog box of the busXplorer-USB, check the digital oscilloscope screen to confirm that a trigger activates and the Reset signal is displayed.
- Following a reset, the hub should send a CHIRP handshake.
 - If the trigger does not activate, adjust the trigger level as needed
 - Click the [Update] button to update the image of waveform in the dialog box.
24. Using the oscilloscope's cursor/zoom function, measure the time from the last SOF packet before the reset to the CHIRP-K (EL_27). Adjust zoom1 position to the last SOF packet, and set T1 cursor at the end of the SOF packet in zoom1. The requirement of the time is between 3.1ms and 6.0ms.
- Do not change position of zoom2 and cursor T2.
 - When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



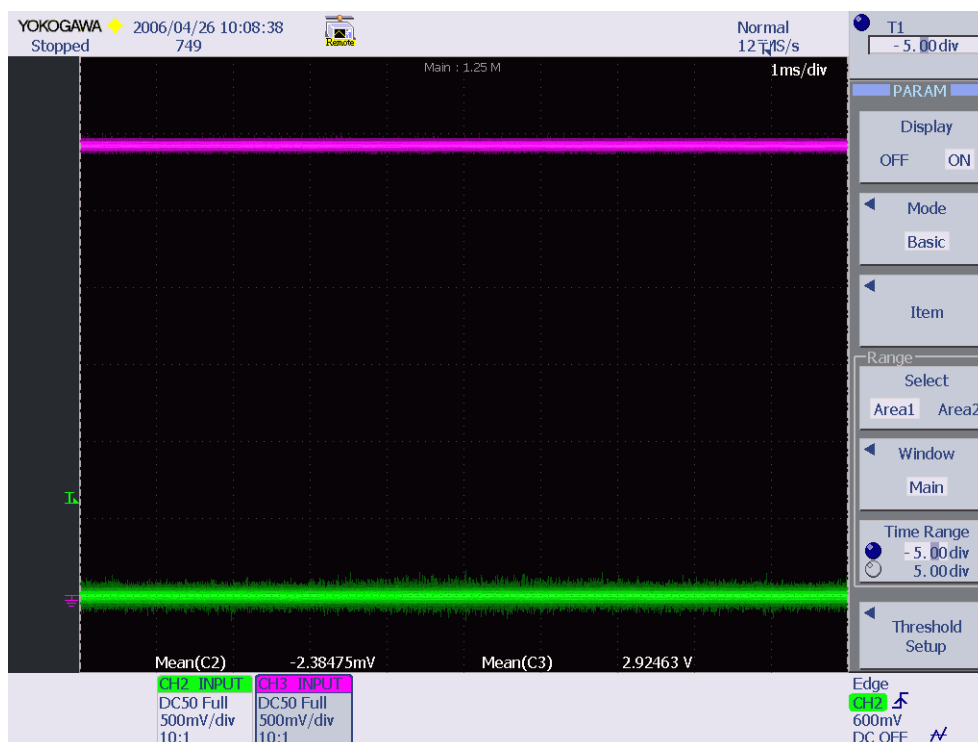
25. Click **[Next]** button in the dialog box of the busXplorer-USB, and then select SUSPEND from Hub Command drop down menu in the HS Electrical Test Tool and click the **[EXECUTE]** button.



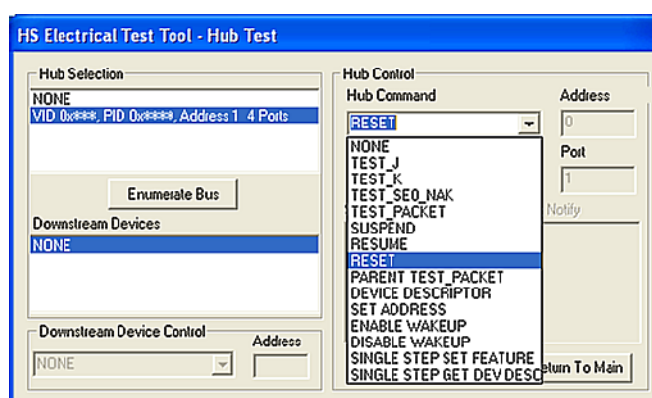
26. Click the [Next] button in the dialog box of the busXplorer-USB.

The trigger mode on the digital oscilloscope is set to Auto to confirm the hub is still in the suspend state and to measure D+ and D- voltage (EL_39). The requirement of D+ voltage is between 2.7V and 3.6V, D- voltage is less than 0.7V.

- Click the [Update] button to update the image of waveform in the dialog box.
- When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.

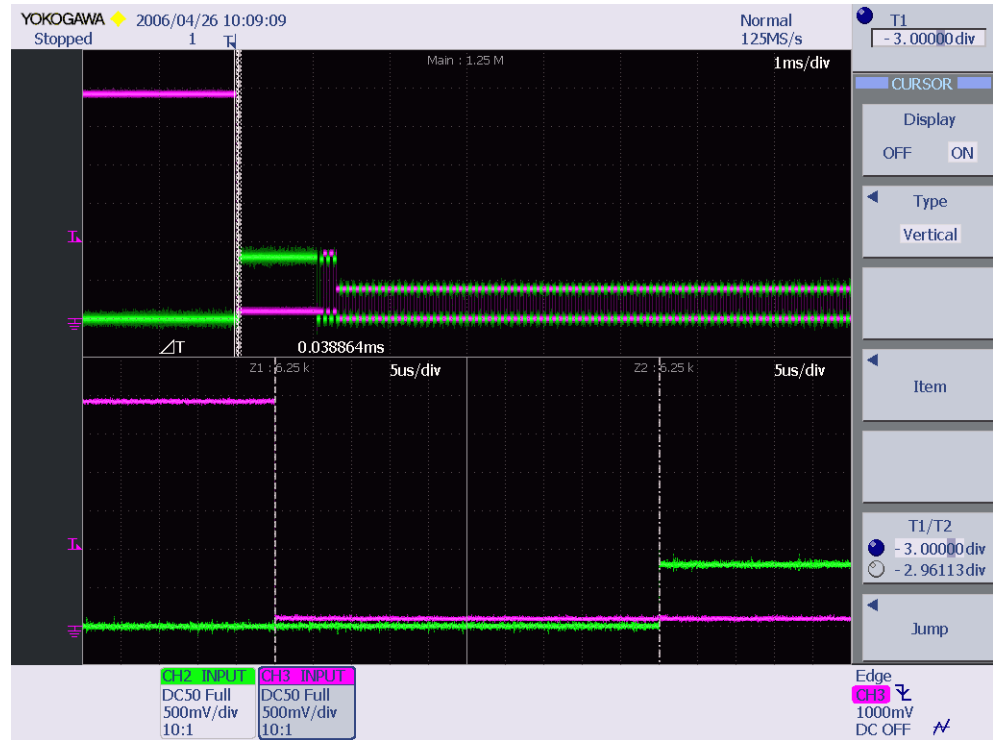


27. Click [Next] button in the dialog box of the busXplorer-USB, and then select RESET from Hub Command drop down menu in the HS Electrical Test Tool, then click the [EXECUTE] button.



28. Click the **[Next]** button in the dialog box of the busXplorer-USB, check the digital oscilloscope screen to confirm that a trigger activates and the CHIRP signal is displayed. Following a reset, the hub starts a CHIRP handshake. The time from the falling edge of D+ to the start of device's CHIRP-K is measured (EL_28). The requirement of the time is between 2.5us and 6.0ms.

- If the trigger does not activate, adjust the trigger level as needed.
- Click the [Update] button to update the image of waveform in the dialog box.
- When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



29. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box is displayed.

Hub HS Suspend/Resume/Reset Timing Test [16/17]

26. The HS Suspend/Resume/Reset Timing test executes.
Repeat steps 11-26, and execute the test the number of times specified in Number of Repetition.

Number of repetition: 1/1

Result

Pass 1

Fail 0

Parameter

	Min.	Max.	Result	
EL38:	3.0000m	3.1250m	3.0066m	s
EL39 (1st step):D+	2.7000	3.6000	2.9209	V
D-	***	700.00m	-1.1140m	V
EL40:	360.00m	440.00m	410.00m	V
EL27:	3.1000m	6.0000m	3.1091m	s
EL39 (2nd step):D+	2.7000	3.6000	2.9246	V
D-	***	700.00m	-2.3847m	V
EL28:	2.5000u	6.0000m	38.864u	s

Next >>

CANCEL

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30. Click the **[Next]** button in the dialog box of the busXplorer-USB, repeat steps 14-29, and execute the test the number of times specified in “Number of Repetition.”

- When the number of tests is complete, the test results dialog box as shown below is displayed.
- Click the **[Detail]** button to display the test results by Internet Explorer.
- Click the **[Image]** button to display an image of the digital oscilloscope screen.
- Click the **[Analyze]** button to start Xviewer and display the waveform data. Xviewer must already have been installed.

27. Record the test results in EL_27, EL_28, EL_38, EL_39, and EL_40.

28. Remove the Active probes from the test fixture.

Number of repetition: 1/1

Result:
 Pass: 1
 Fail: 0

Parameter	Min.	Max.	Result	Image	Analyze
EL38:	3.0000m	3.1250m	3.0066m	S	...
EL39 (1st step):D+	2.7000	3.6000	2.9209	V	...
D-	***	700.00m	-1.1140m	V	...
EL40:	360.00m	440.00m	410.00m	V	...
EL27:	3.1000m	6.0000m	3.1091m	S	...
EL39 (2nd step):D+	2.7000	3.6000	2.9246	V	...
D-	***	700.00m	-2.3847m	V	...
EL28:	2.5000u	6.0000m	38.864u	S	...

Detail

OK

31. Record the test results in EL_27, EL_28, EL_38, EL_39, and EL_40.

- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission.
- All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.

32. Remove the Active probes from the test fixture.

2.16. HS Test J/K, SE0_NAK, Upstream Facing Port (EL_8, EL_9)

- **USB 2.0 Electrical Test Specification**

- EL_8

When either D+ or D- are driven high, the output voltage must be 400 mV \pm 10% when terminated with precision 45 Ω resistors to ground.

- EL_9

When either D+ and D- are not being driven, the output voltage must be 0 V \pm 10 mV when terminated with precision 45 Ω resistors to ground.

- **Instruments Used**

Name	Quantity
Yokogawa Meter & Instrument 3 ½ Digital Multimeter 733/734	1
USB-IF compliant 1 m USB 2.0 cable	1
Test bed computer	1
USB compliance test fixture	1
5 V power supply for test fixture	1

- **Executing the Test**

1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



2. Click the **[HS Upstream Test J/K, SE0_NAK]** button.
The Hub HS Upstream J/K, SE0_NAK Test dialog box opens.

1. Enter the repeat number from 1(default) to 50 in the Number of Repetition input box.

2. If necessary, enter a comment for the test in Comment text box. The comment is saved together with test result and displayed in the Test Result Dialog box.

Number of repetition:

Parameter	Min.	Max.	Default
EL8:TestJ D+	360.00m	440.00m	<input type="checkbox"/>
TestJ D-	-10.000m	10.000m	<input type="checkbox"/>
EL8:TestK D+	-10.000m	10.000m	<input type="checkbox"/>
TestK D-	360.00m	440.00m	<input type="checkbox"/>
EL9:SE0_NAK D+	-10.000m	10.000m	<input type="checkbox"/>
SE0_NAK D-	-10.000m	10.000m	<input type="checkbox"/>

Comment:

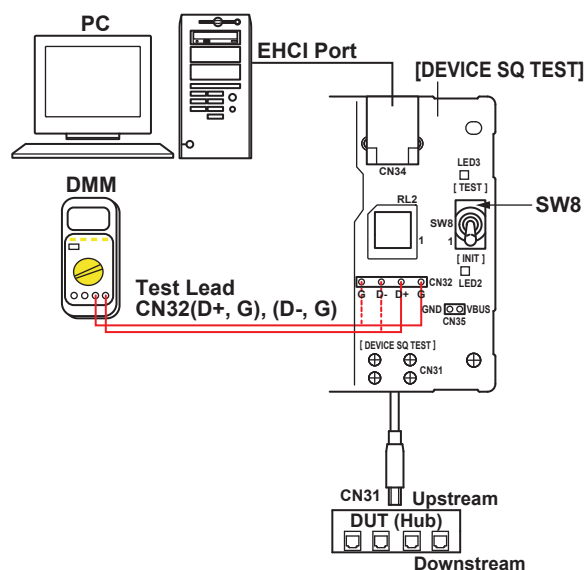
3. Enter the repeat number from 1(default) to 50 in the Number of Repetition input box.
4. If necessary, enter a comment for the test in Comment text box.
The comment is saved together with test result and displayed in the Test Result Dialog box.
5. If you wish to change the judgment range, you can edit the judgment criteria for EL_8 and EL_9.
Default values for the judgment criteria are as follows:
 - EL_8

Test J	D+ Min.: 360 mV, Max.: 440 mV
	D- Min.: -10.0 mV, Max.: 10.0 mV
Test K	D+ Min.: -10.0 mV, Max.: 10.0 mV
	D- Min.: 360 mV, Max.: 440 mV
 - EL_9

SE0_NAK	D+ Min.: -10.0 mV, Max.: 10.0 mV
SE0_NAK	D- Min.: -10.0 mV, Max.: 10.0 mV

If you click the [Default] button after changing the judgment range, the default values of the judgment range are restored.

-
6. Click the **[Next]** button in the dialog box of the busXplorer-USB.
A connection diagram as shown below is displayed.

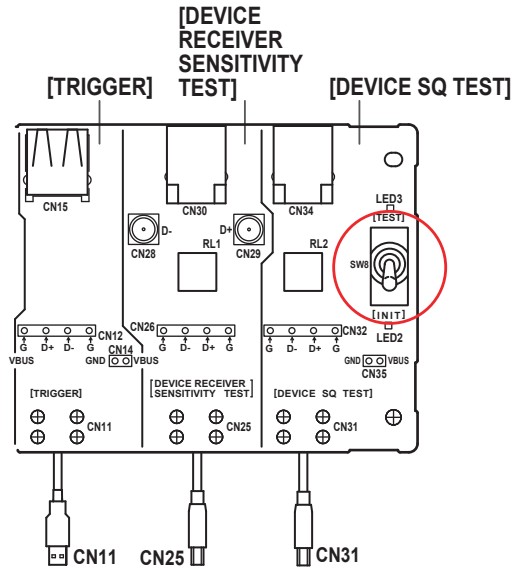


Note

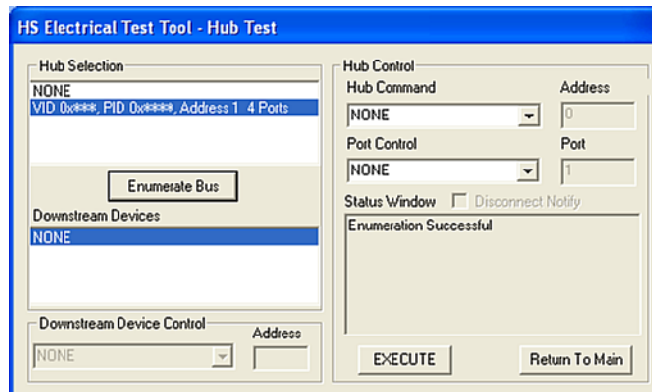
The digital oscilloscope is not necessary to perform this test.

7. Turn ON the power to the DUT.
8. Turn ON the power to the test fixture and confirm that the green power supply LED1 is lit.
9. Connect the CN31 connector of the DEVICE SQ TEST block to upstream port of the DUT.
10. Connect the test bed computer to the CN34 connector of the DEVICE SQ TEST block using a 1 m USB cable.

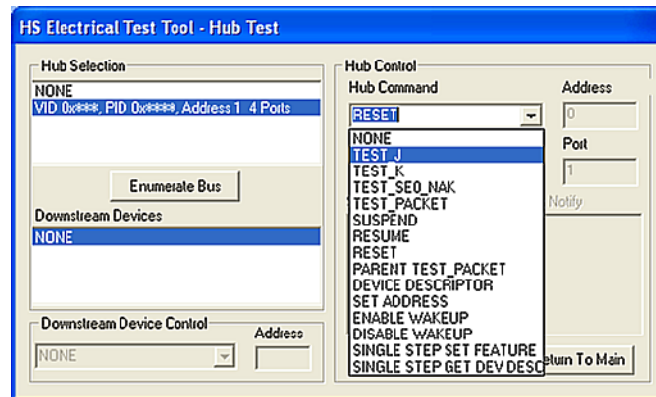
11. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, place SW8 of the test fixture to the INIT position.
Verify LED2 of the test fixture is lit.
Next, power cycle the DUT.



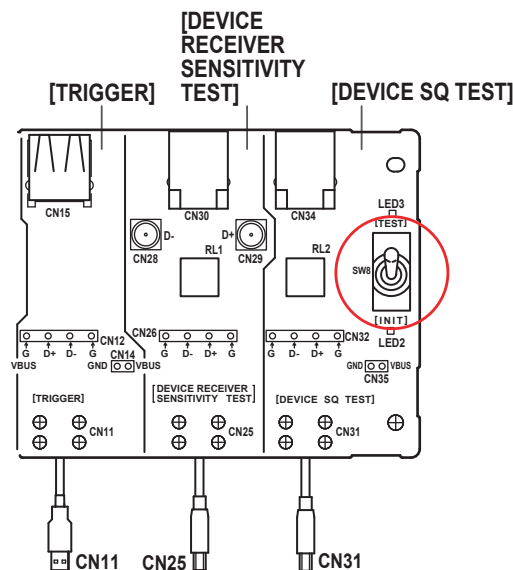
12. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, click the **[Enumerate Bus]** button in the HS Electrical Test Tool. Confirm that the VID, PID, connected address, and port of the DUT are displayed under Hub Selection .
If not already running, start the HS Electrical Test Tool. Select Hub under Select Type of Test, click the **[TEST]** button, then confirm the above.



13. Click **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, select TEST_J from the Hub Command drop down menu in the HS Electrical Test Tool, then click the **[EXECUTE]** button.



14. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, place SW8 of the test fixture to the TEST position.
Verify LED3 of the test fixture is lit.

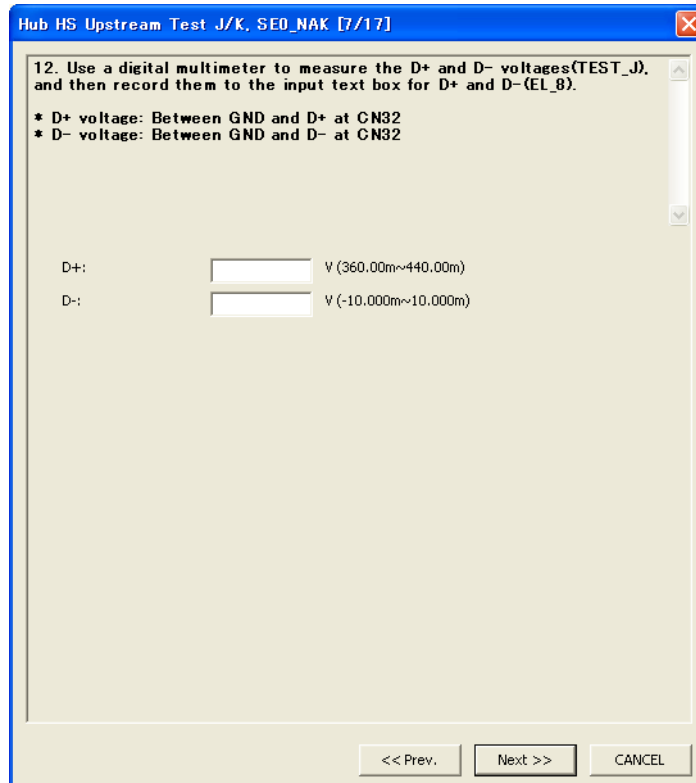


15. Click the **[Next]** button in the dialog box of the busXplorer-USB, use a digital multimeter to measure the D+ and D- voltages(TEST_J), and then record them to the input text box for D+ and D-(EL_8).

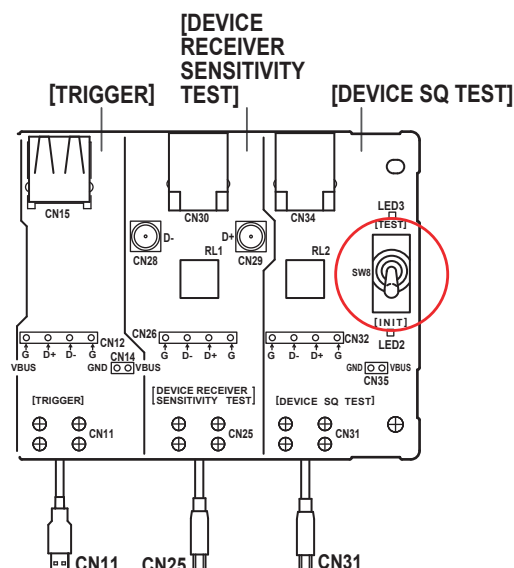
D+ voltage: Between GND and D+ at CN32

D- voltage: Between GND and D- at CN32

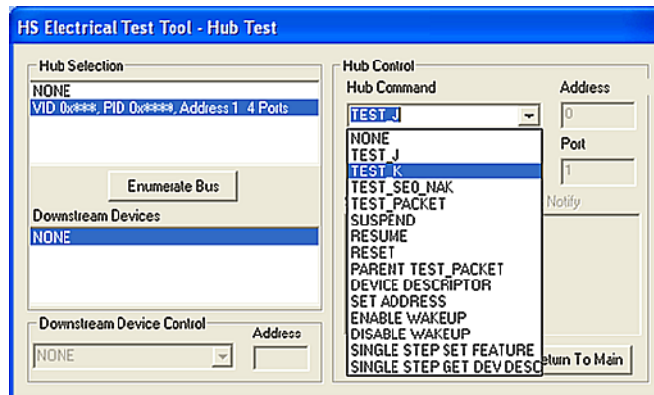
When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



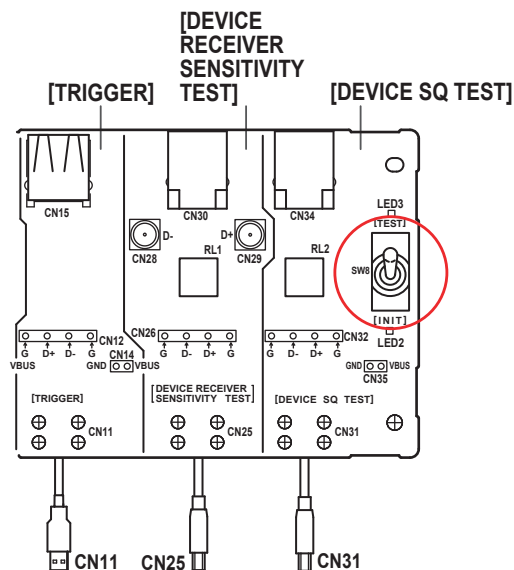
16. Click the **[Next]** button in the dialog box of the busXplorer-USB. Following the instructions in the dialog box, return SW8 of the test fixture to the INIT position. Verify LED2 of the test fixture is lit. Next, power cycle the DUT.



17. Click **[Next]** button in the dialog box of the busXplorer-USB.
Click the **[Enumerate Bus]** button in the HS Electrical Test Tool. Then select TEST_K from Hub Command drop down menu in the HS Electrical Test Tool, then click the **[EXECUTE]** button.



18. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, place SW8 of the test fixture to the TEST position.
Verify LED3 of the test fixture is lit.



19. Click the **[Next]** button in the dialog box of the busXplorer-USB, use a digital multimeter to measure the D+ and D- voltages (TEST_K), and then record them to the input text box for D+ and D-(EL_8).

D+ voltage: Between GND and D+ at CN32

D- voltage: Between GND and D- at CN32

Hub HS Upstream Test J/K, SE0_NAK [11/17]

16. Use a digital multimeter to measure the D+ and D- voltages (TEST_K), and then record them to the input text box for D+ and D-(EL_8).

* D+ voltage: Between GND and D+ at CN32
* D- voltage: Between GND and D- at CN32

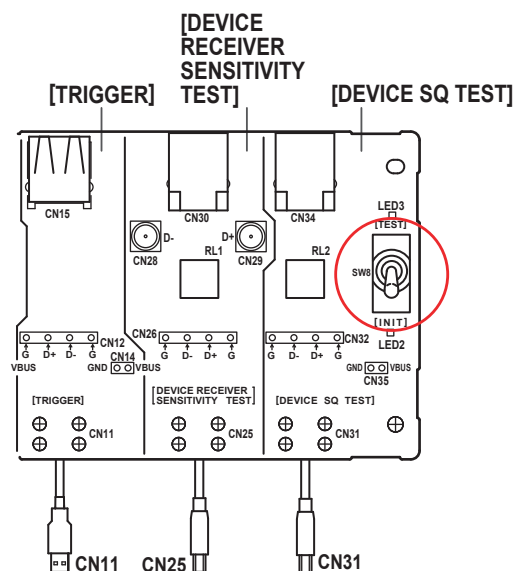
D+: V (-10.000m~10.000m)
D-: V (360.00m~440.00m)

<< Prev. Next >> CANCEL

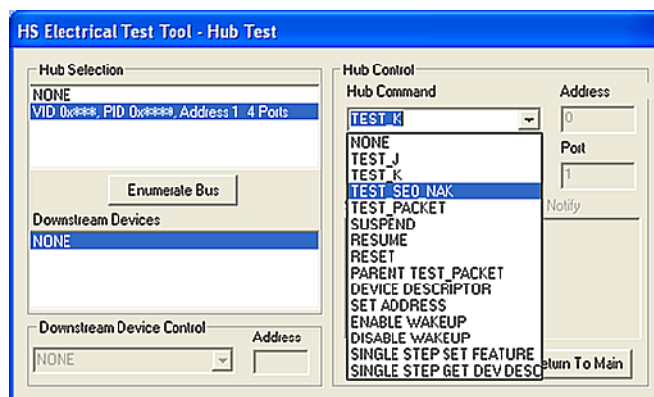
20. Click the **[Next]** button in the dialog box of the busXplorer-USB. Following the instructions in the dialog box, return SW8 of the test fixture to the INIT position.

Verify LED2 of the test fixture is lit.

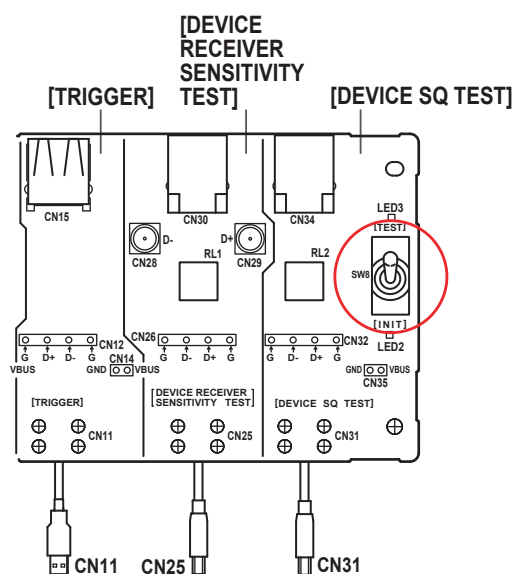
Next, power cycle the DUT.



21. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Click the **[Enumerate Bus]** button in the HS Electrical Tets Tool. Then select TEST_SE0_NAK from Hub Command drop down menu in the HS Electrical Test Tool, then click the **[EXECUTE]** button.



22. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, place SW8 of the test fixture to the TEST position.
Verify LED3 of the test fixture is lit.



- 23.** Click the **[Next]** button in the dialog box of the busXplorer-USB.
Use a digital multimeter to measure the D+ voltage and D- voltages (TEST_SE0_NAK), and then record them to the input text box for D+ and D-(EL_9).

D+ voltage: Between GND and D+ at CN32

D- voltage: Between GND and D- at CN32

When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.

Hub HS Upstream Test J/K, SE0_NAK [15/17]

20. Use a digital multimeter to measure the D+ voltage and D- voltages (TEST_SE0_NAK), and then record them to the input text box for D+ and D-(EL_9).

* D+ voltage: Between GND and D+ at CN32
* D- voltage: Between GND and D- at CN32

D+: V (-10.000m~10.000m)

D-: V (-10.000m~10.000m)

<< Prev. Next >> CANCEL

24. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box is displayed.

Hub HS Upstream Test J/K, SEO_NAK [16/17]

21. The HS Upstream JK and SEO_NAK tests execute.
Repeat steps 8-21, and execute the test the number of times specified in
Number Of Repetation.

Number of repetition: 1/1

Result

Pass 1

Fail 0

Parameter

	Min.	Max.	Result	
EL8:TestJ D+	360.00m	440.00m	393.00m	V
TestJ D-	-10.000m	10.000m	3.0000m	V
EL8:TestK D+	-10.000m	10.000m	3.0000m	V
TestK D-	360.00m	440.00m	395.00m	V
EL9:SEO_NAK D+	-10.000m	10.000m	2.0000m	V
SEO_NAK D-	-10.000m	10.000m	2.0000m	V

Next >>

CANCEL

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- 25.** Click the **[Next]** button in the dialog box of the busXplorer-USB, repeat steps 11-24, and execute the test the number of times specified in “Number Of Repetation”.
- When this number of tests is completed, the test results dialog box as shown below is displayed.
 - Click the Detail button to display the test results by Internet Explorer.

Hub HS Upstream Test J/K, SE0_NAK [17/17]

22. Record the test results in EL_8 and EL_9.

23. Return SW8 of the test fixture to the INIT position. LED2 of the test fixture is lit.

24. Since the DUT is in test mode.

Number of repetition: 1/1

Result:
 Pass: 1
 Fail: 0

Parameter	Min.	Max.	Result	
EL8:TestJ D+	360.00m	440.00m	393.00m	V
TestJ D-	-10.000m	10.000m	3.0000m	V
EL8:TestK D+	-10.000m	10.000m	3.0000m	V
TestK D-	360.00m	440.00m	395.00m	V
EL9:SE0_NAK D+	-10.000m	10.000m	2.0000m	V
SE0_NAK D-	-10.000m	10.000m	2.0000m	V

Detail

OK

- 26.** Record the test results in EL_8 and EL_9.
- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission.
 - All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.
- 27.** Return SW8 of the test fixture to the INIT position.
LED2 of the test fixture is lit.
- 28.** Since the DUT is in test mode, power cycle the DUT in preparation for subsequent tests.

2.17. HS Test J/K, SE0_NAK, Downstream Facing Port (EL_8, EL_9)

- **USB 2.0 Electrical Test Specification**

- EL_8

When either D+ or D- are driven high, the output voltage must be 400 mV \pm 10% when terminated with precision 45 Ω resistors to ground.

- EL_9

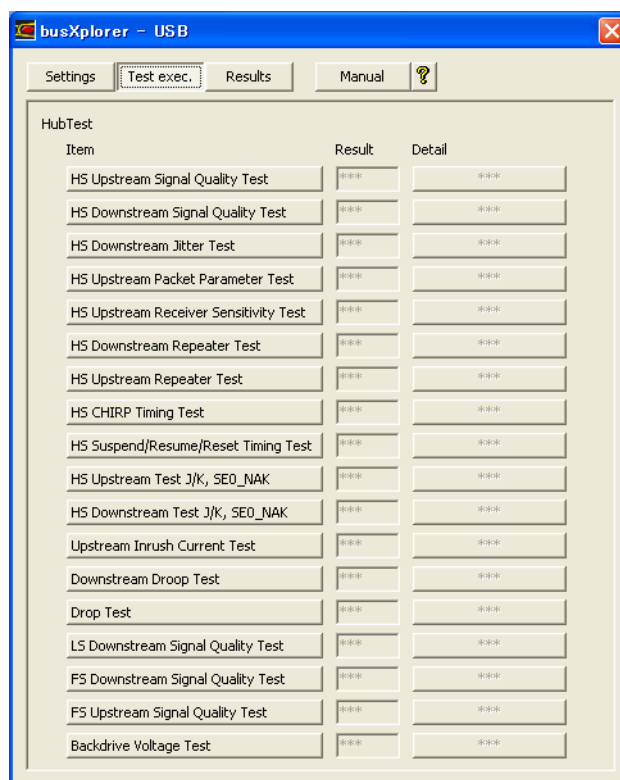
When either D+ and D- are not being driven, the output voltage must be 0 V \pm 10 mV when terminated with precision 45 Ω resistors to ground.

- **Instruments Used**

Name	Quantity
Yokogawa Meter & Instrument 3 ½ Digital Multimeter 733/734	1
USB-IF compliant 1 m USB 2.0 cable	1
Test bed computer	1
USB compliance test fixture	1
5 V power supply for test fixture	1

- **Executing the Test**

1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



2. Click the **[HS Downstream Test J/K, SE0_NAK]** button.
The Hub HS Downstream J/K, SE0_NAK Test dialog box opens.

1. Enter the repeat number from 1(default) to 50 in the Number of Repetition input box.

2. If necessary, enter a comment for the test in Comment text box. The comment is saved together with test result and displayed in the Test Result Dialog box.

Number of repetition:

Parameter	Min.	Max.	Default
EL8:TestJ D+	360.00m	440.00m	<input type="checkbox"/>
TestJ D-	-10.000m	10.000m	<input type="checkbox"/>
EL8:TestK D+	-10.000m	10.000m	<input type="checkbox"/>
TestK D-	360.00m	440.00m	<input type="checkbox"/>
EL9:SE0_NAK D+	-10.000m	10.000m	<input type="checkbox"/>
SE0_NAK D-	-10.000m	10.000m	<input type="checkbox"/>

Comment:

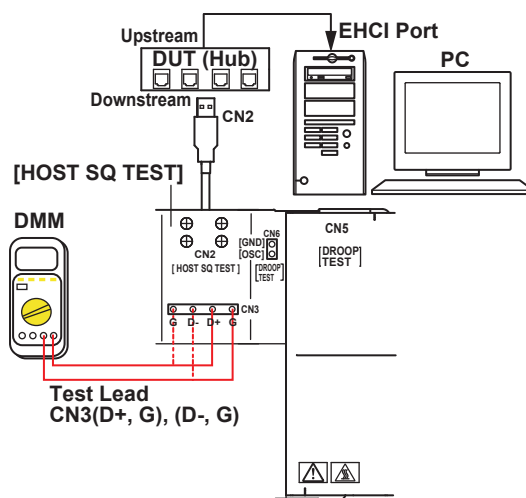
3. Enter the repeat number from 1(default) to 50 in the Number of Repetition input box.
4. If necessary, enter a comment for the test in Comment text box.
The comment is saved together with test result and displayed in the Test Result Dialog box.
5. If you wish to change the judgment range, you can edit the judgment criteria for EL_8 and EL_9.

Default values for the judgment criteria are as follows:

- EL_8
 - Test J D+ Min.: 360 mV, Max.: 440 mV
 - D- Min.: -10.0 mV, Max.: 10.0 mV
 - Test K D+ Min.: -10.0 mV, Max.: 10.0 mV
 - D- Min.: 360 mV, Max.: 440 mV
- EL_9
 - SE0_NAK D+ Min.: -10.0 mV, Max.: 10.0 mV
 - SE0_NAK D- Min.: -10.0 mV, Max.: 10.0 mV

If you click the [Default] button after changing the judgment range, the default values of the judgment range are restored.

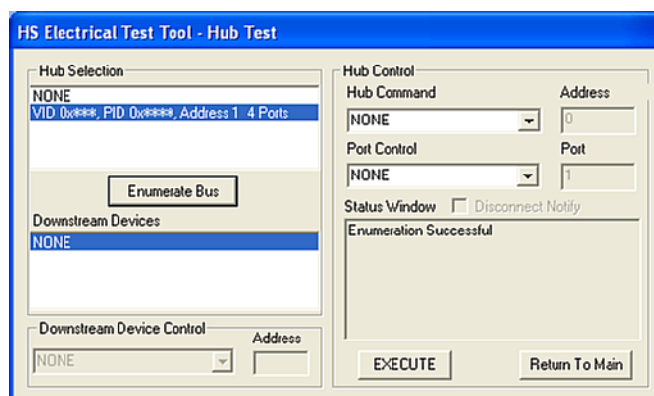
6. Click the **[Next]** button in the dialog box of the busXplorer-USB.
A connection diagram as shown below is displayed.



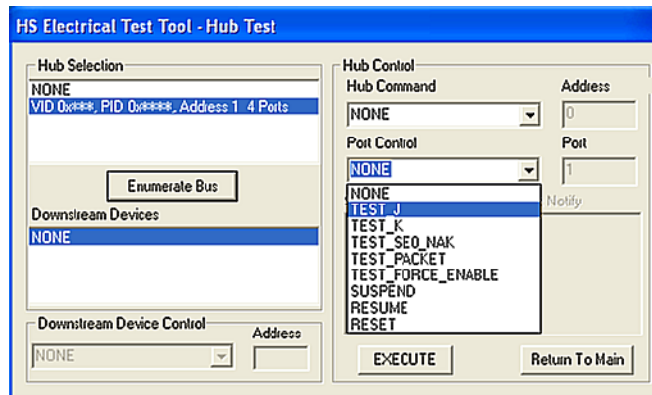
Note

The digital oscilloscope is not necessary to perform this test.

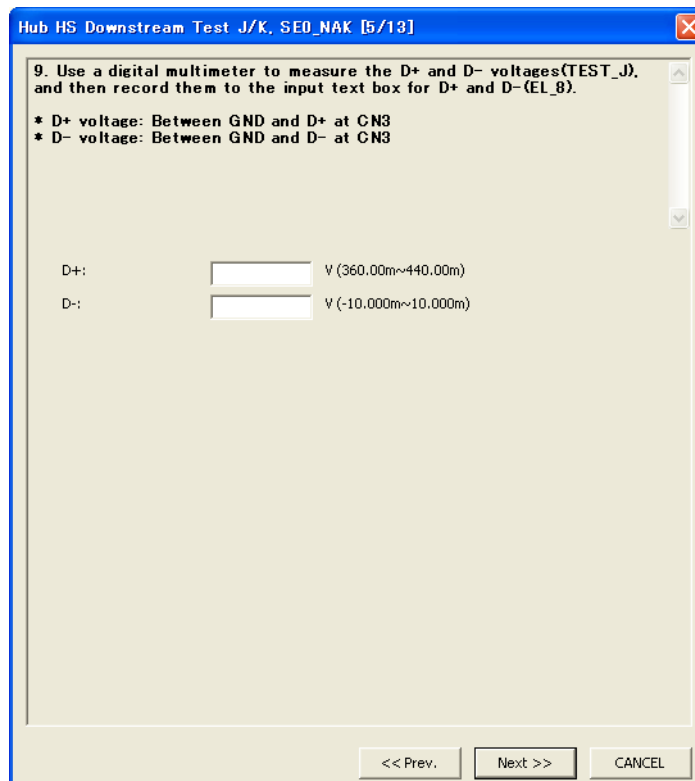
7. Turn ON the power to the DUT.
8. Connect the CN2 connector of the HOST SQ TEST block to the downstream port of the DUT.
9. Connect the test bed computer to the upstream port of the hub using a 1 m USB cable.
10. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, click the **[Enumerate Bus]** button in the HS Electrical Test Tool. Confirm that the VID, PID, connected address, and port of the DUT are displayed under Hub Selection .
If not already running, start the HS Electrical Test Tool. Select Hub under Select Type of Test, click the **[TEST]** button, then confirm the above.



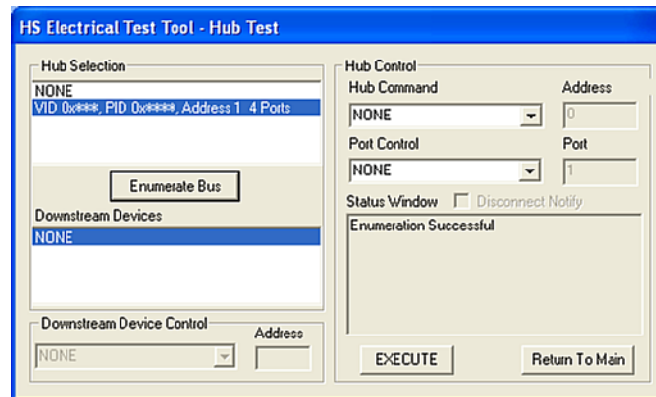
11. Click **[Next]** button in the dialog box of the busXplorer-USB. Following the instructions in the dialog box, select TEST_J from the Port Control drop down menu and set the target port number in the HS Electrical Test Tool, then click the **[EXECUTE]** button.



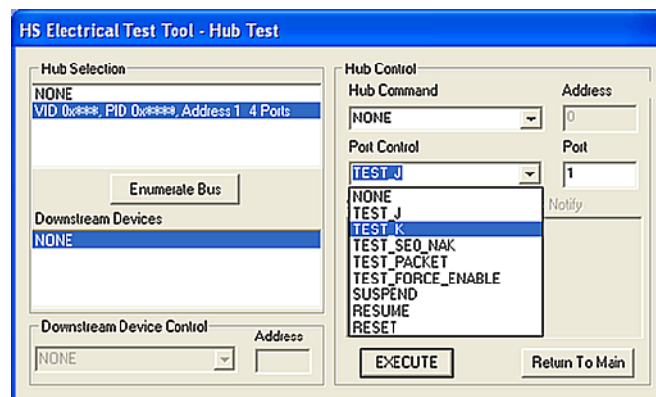
12. Click the **[Next]** button in the dialog box of the busXplorer-USB, use a digital multimeter to measure the D+ and D- voltages (TEST_J), and then record them to the input text box for D+ and D- (EL_8).
D+ voltage: Between GND and D+ at CN3
D- voltage: Between GND and D- at CN3
When **[Next]** button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



13. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, click the **[Enumerate Bus]** button in the HS Electrical Test Tool. Confirm that the VID, PID, connected address, and port of the DUT are displayed under Hub Selection .



14. Click **[Next]** button in the dialog box of the busXplorer-USB.
Select TEST_K from Port Control drop down menu and set the target port number in the HS Electrical Test Tool, then click the **[EXECUTE]** button.

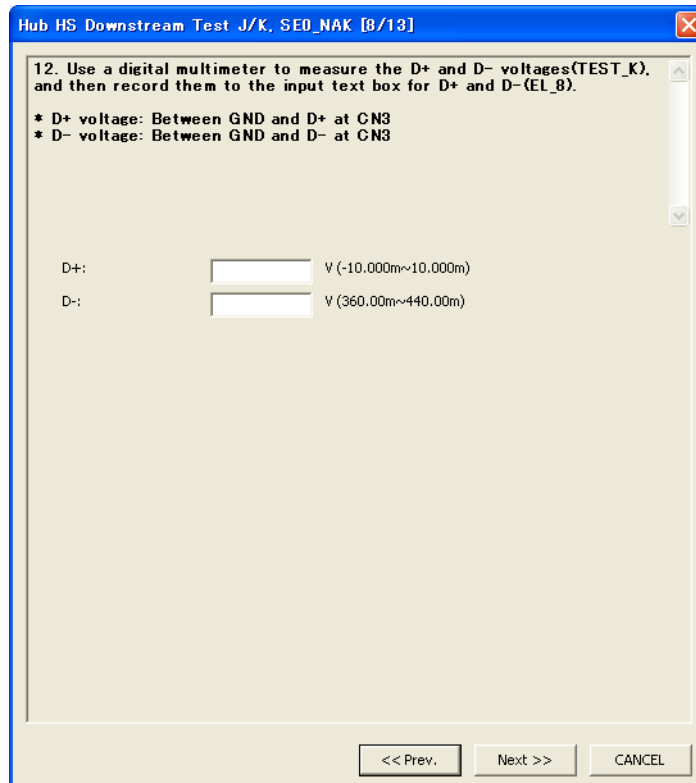


15. Click the **[Next]** button in the dialog box of the busXplorer-USB, use a digital multimeter to measure the D+ and D- voltages (TEST_K), and then record them to the input text box for D+ and D- (EL_8).

D+ voltage: Between GND and D+ at CN3

D- voltage: Between GND and D- at CN3

When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



Hub HS Downstream Test J/K, SED_NAK [8/13]

12. Use a digital multimeter to measure the D+ and D- voltages (TEST_K), and then record them to the input text box for D+ and D- (EL_8).

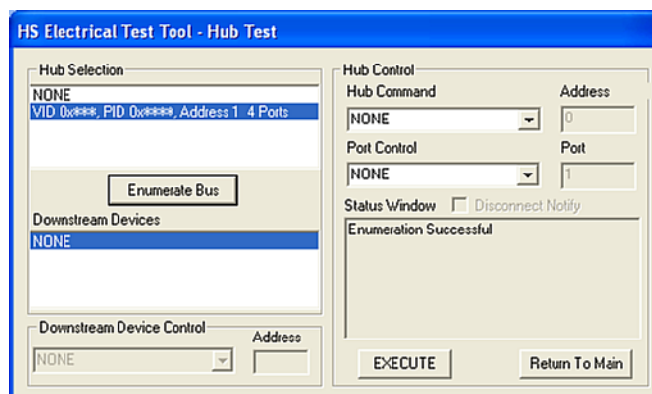
- * D+ voltage: Between GND and D+ at CN3
- * D- voltage: Between GND and D- at CN3

D+: V (-10.000m~10.000m)

D-: V (360.00m~440.00m)

<< Prev. Next >> CANCEL

16. Click the **[Next]** button in the dialog box of the busXplorer-USB. Following the instructions in the dialog box, click the **[Enumerate Bus]** button in the HS Electrical Test Tool. Confirm that the VID, PID, connected address, and port of the DUT are displayed under Hub Selection.



HS Electrical Test Tool - Hub Test

Hub Selection

NONE
VID 0x***, PID 0x***, Address 1 4 Ports

Enumerate Bus

Downstream Devices

NONE

Downstream Device Control

NONE Address

Hub Control

Hub Command Address

NONE 0

Port Control Port

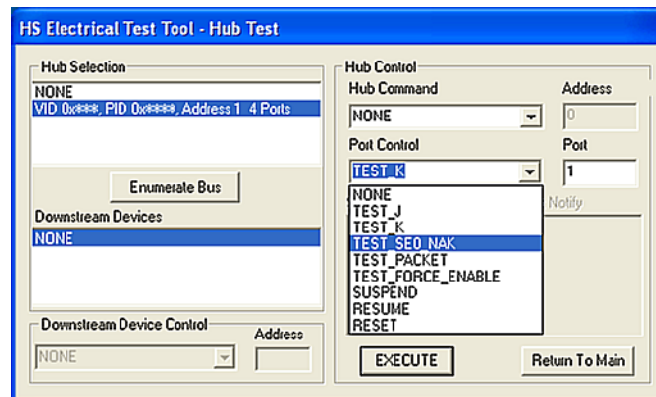
NONE 1

Status Window ☐ Disconnect Notify

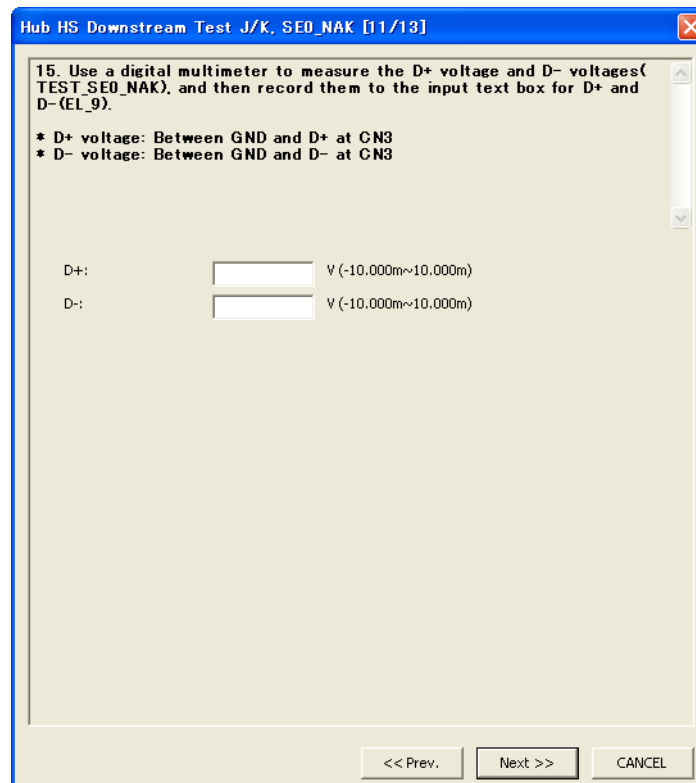
Enumeration Successful

EXECUTE Return To Main

17. Click **[Next]** button in the dialog box of the busXplorer-USB.
Select TEST_SE0_NAK from Port Control drop down menu and set the target port number in the HS Electrical Test Tool, then click the **[EXECUTE]** button.



18. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Use a digital multimeter to measure the D+ voltage and D- voltages (TEST_SE0_NAK), and then record them to the input text box for D+ and D- (EL_9).
D+ voltage: Between GND and D+ at CN3
D- voltage: Between GND and D- at CN3
When **[Next]** button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



19. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box is displayed.

Hub HS Downstream Test J/K, SE0_NAK [12/13]

16. The HS Downstream JK and SE0_NAK tests execute.
Repeat steps 7-16, and execute the test the number of times specified in
Number Of Repetation.

Number of repetition: 1/1

Result

Pass	1
Fail	0

Parameter

	Min.	Max.	Result	
EL8:TestJ D+	360.00m	440.00m	393.00m	V
TestJ D-	-10.000m	10.000m	3.0000m	V
EL8:TestK D+	-10.000m	10.000m	3.0000m	V
TestK D-	360.00m	440.00m	395.00m	V
EL9:SE0_NAK D+	-10.000m	10.000m	2.0000m	V
SE0_NAK D-	-10.000m	10.000m	2.0000m	V

Next >> CANCEL

20. Click the **[Next]** button in the dialog box of the busXplorer-USB, repeat steps 10-19, and execute the test the number of times specified in "Number Of Repetation".
- When this number of tests is completed, the test results dialog box as shown below is displayed.
 - Click the Detail button to display the test results by Internet Explorer.

Hub HS Downstream Test J/K, SE0_NAK [13/13]

17. Record the test results in EL_8 and EL_9.

18. Repeat steps 1-17 for all downstream ports of the DUT. Connect the CN2 connector of the Host SQ TEST block to the following downstream port of the DUT.

Number of repetition: 1/1

Result:
 Pass: 1
 Fail: 0

Parameter	Min.	Max.	Result	
EL8:TestJ D+	360.00m	440.00m	393.00m	V
TestJ D-	-10.000m	10.000m	3.0000m	V
EL8:TestK D+	-10.000m	10.000m	3.0000m	V
TestK D-	360.00m	440.00m	395.00m	V
EL9:SE0_NAK D+	-10.000m	10.000m	2.0000m	V
SE0_NAK D-	-10.000m	10.000m	2.0000m	V

Detail

OK

21. Record the test results in EL_8 and EL_9.
- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission.
 - All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.
22. Repeat steps 2-21 for all downstream ports of the DUT.
 Connect the CN2 connector of the Host SQ TEST block to the following downstream port of the DUT.

Note

A specific port fails to enter the specific test mode after test mode commands have been issued to the hub a number of times. Cycle power on the hub will alleviate this problem.

23. When all downstream ports have been tested, power cycle the DUT to prepare for the next test.

Appendix A Hub Hi-Speed Electrical Test Data

This section is for recording the actual test result. Please use a copy for each device to be tested.

App. A.1 Vendor and Product Information

	Please fill in all fields. Please contact your silicon supplier if you are unsure of the silicon information.
Test Date	
Vendor Name	
Vendor Complete Address	
Vendor Phone Number	
Vendor Contact, Title	
Test ID Number	
Product Name	
Product Model and Revision	
USB Silicon Vendor Name	
USB Silicon Model	
USB Silicon Part Marking	
USB Silicon Stepping	
Tested By	

App. A.2 Legacy USB Compliance Tests

Legacy USB Compliance Checklist

Legacy Test	Pass/Fail	Comments
LS SQ (Downstream)		
FS SQ (Upstream and Downstream)		
Inrush (Upstream)		
Drop/Droop (Downstream)		
Interop		
Backdrive		

P = PASS

F = FAIL

N/A = Not applicable

App. A.3 Hub High-speed Signal Quality — Upstream Facing Port (EL_2, EL_46, EL_6, EL_7)

EL_2 A USB 2.0 Hi-Speed transmitter data rate must be 480 Mb/s $\pm 0.05\%$.

Reference documents: *USB 2.0 Specification*, Section 7.1.11.

- ☐ PASS
- ☐ FAIL
- ☐ N/A

Comments:

EL_46 A hub upstream repeater must meet Template 1 transform waveform requirements measured at TP3.

Reference documents: *USB 2.0 Specification*, Section 7.1.2.2.

- ☐ PASS
- ☐ FAIL
- ☐ N/A

Comments:

EL_6 A USB 2.0 HS driver must have 10% to 90% differential rise and fall times of greater than 500 ps.

Reference documents: *USB 2.0 Specification*, Section 7.1.2.2.

- ☐ PASS
- ☐ FAIL
- ☐ N/A

Comments:

EL_7 A USB 2.0 HS driver must have monotonic data transitions over the vertical openings specified in the appropriate eye pattern template.

Reference documents: *USB 2.0 Specification*, Section 7.1.2.2.

- ☐ PASS
- ☐ FAIL
- ☐ N/A

Comments:

App. A.4 Hub High-speed Signal Quality — Downstream Facing Ports (EL_2, EL_3, EL_6, EL_7)

EL_2 A USB 2.0 Hi-Speed transmitter data rate must be 480 Mb/s $\pm 0.05\%$.

Reference documents: *USB 2.0 Specification*, Section 7.1.2.2.

Port	P1	P2	P3	P4	P5
PASS					
FAIL					
N/A					

Overall Result:

☐ PASS

☐ FAIL

☐ N/A

Comments:

EL_3 A USB 2.0 downstream facing port must meet Template 1 transform waveform requirements measured at TP2 (each hub downstream port).

Reference documents: *USB 2.0 Specification*, Section 7.1.2.2.

Port	P1	P2	P3	P4	P5
PASS					
FAIL					
N/A					

Overall Result:

☐ PASS

☐ FAIL

☐ N/A

Comments:

EL_6 A USB 2.0 HS driver must have 10% to 90% differential rise and fall times of greater than 500 ps.

Reference documents: *USB 2.0 Specification*, Section 7.1.2.2.

Port	P1	P2	P3	P4	P5
PASS					
FAIL					
N/A					

☐ PASS

☐ FAIL

☐ N/A

Comments:

EL_7 A USB 2.0 HS driver must have monotonic data transitions over the vertical openings specified in the appropriate eye pattern template.

Reference documents: *USB 2.0 Specification*, Section 7.1.2.2.

- ☐ PASS
☐ FAIL
☐ N/A

Comments:

Port	P1	P2	P3	P4	P5
PASS					
FAIL					
N/A					

App. A.5 Hub Jitter — Downstream Facing Ports (EL_47)

EL_47 A hub downstream facing repeater must meet Template 1 transform waveform requirements measured at TP2 (each hub downstream port).

Reference documents: *USB 2.0 Specification*, Section 7.1.14.2.

Port	P1	P2	P3	P4	P5
PASS					
FAIL					
N/A					

Overall Result:

- ☐ PASS
☐ FAIL
☐ N/A

Comments:

App. A.6 Hub Disconnect Detect (EL_36, EL37)

EL_37 AA USB 2.0 downstream facing port must not detect the high-speed disconnect state when the amplitude of the differential signal at the downstream facing driver's connector is ≤ 525 mV.

Reference documents: *USB 2.0 Specification*, Section 7.1.7.3.

Port	P1	P2	P3	P4	P5
PASS					
FAIL					
N/A					

Overall Result:

☐ PASS

☐ FAIL

☐ N/A

Comments:

EL_36 A USB 2.0 downstream facing port must detect the hi-speed disconnect state when the amplitude of the differential signal at the downstream facing driver's connector is ≥ 625 mV.

Reference documents: *USB 2.0 Specification*, Section 7.1.7.3.

Port	P1	P2	P3	P4	P5
PASS					
FAIL					
N/A					

Overall Result:

☐ PASS

☐ FAIL

☐ N/A

Comments:

App. A.7 Hub Packet Parameters — Upstream Facing Port (EL_21, EL_22, EL_25)

EL_21 The SYNC field for all transmitted packets (not repeated packets) must begin with a 32-bit SYNC field.

Reference documents: *USB 2.0 Specification*, Section 8.2.

Data Packet SYNC field

☐ PASS

☐ FAIL

☐ N/A

Comments:

EL_25 The EOP for all transmitted packets (except SOFs) must be an 8-bit NRZ byte of 01111111 without bit stuffing. (Note, that a longer EOP is waiverable)

Reference documents: *USB 2.0 Specification*, Section 7.1.13.2.

☐ PASS

☐ FAIL

☐ N/A

Comments:

EL_22 When transmitting after receiving a packet, hosts and devices must provide an inter-packet gap of at least 8 bit times and not more than 192 bit times.

Reference documents: *USB 2.0 Specification*, Section 7.1.18.2.

☐ PASS

☐ FAIL

☐ N/A

Comments:

App. A.8 Hub Receiver Sensitivity — Upstream Facing Port (EL_16, EL_17, EL_18)

EL_18 A high-speed capable device's Transmission Envelope Detector must be fast enough to allow the HS receiver to detect data transmission, achieve DLL lock, and detect the end of the SYNC field within 12 bit times.

Reference documents: *USB 2.0 Specification*, Section 7.1.

- ☐ PASS
- ☐ FAIL
- ☐ N/A

Comments:

EL_17 A hi-speed capable device must implement a transmission envelope detector that does not indicate squelch (i.e. reliably receives packets) when a receiver exceeds 150 mV differential amplitude.

Note: A waiver may be granted if the receiver does not indicate Squelch at ± 50 mV of 150 mV differential amplitude. This is to compensate for the oscilloscope probe point away from the receiver pins.

Reference documents: *USB 2.0 Specification*, Section 7.1.

- ☐ PASS
- ☐ FAIL
- ☐ N/A

Comments:

EL_16 A hi-speed capable device must implement a transmission envelope detector that indicates squelch (i.e. never receives packets) when a receiver's input falls below 100 mV differential amplitude.

Note: A waiver may be granted if the receiver does not indicate Squelch at ± 50 mV of 150 mV differential amplitude. This is to compensate for the oscilloscope probe point away from the receiver pins.

Reference documents: *USB 2.0 Specification*, Section 7.1.

- ☐ PASS
- ☐ FAIL
- ☐ N/A

Comments:

App. A.9 Hub Repeater Test — Downstream Facing Port (EL_42, EL_43, EL_44, EL_45, EL_48)

EL_48 A hub repeater may not delay packets for more than 36 bit times plus 4 ns.

Reference documents: *USB 2.0 Specification, 7.1.14.2.*

- ☐ PASS
- ☐ FAIL
- ☐ N/A

Comments:

EL_42 Hub repeaters must not truncate more than 4 bits from a repeated SYNC pattern.

Reference documents: *USB 2.0 Specification, 7.1.10.*

- ☐ PASS
- ☐ FAIL
- ☐ N/A

Comments:

EL_43 Hubs must not corrupt any repeated bits of the SYNC field.

Reference documents: *USB 2.0 Specification, 7.1.10.*

- ☐ PASS
- ☐ FAIL
- ☐ N/A

Comments:

EL_44 A hub may add at most 4 random bits to the end of the EOP field when repeating a packet.

Reference documents: *USB 2.0 Specification, 7.1.13.2.*

- ☐ PASS
- ☐ FAIL
- ☐ N/A

Comments:

EL_45 A hub must not corrupt any of the valid EOP bits when repeating a packet.

Reference documents: *USB 2.0 Specification, 7.1.13.2.*

- ☐ PASS
- ☐ FAIL
- ☐ N/A

Comments:

App. A.10 Hub Repeater Test — Upstream Facing Port (EL_42, EL_43, EL_44, EL_45)

EL_42 Hub repeaters must not truncate more than 4 bits from a repeated SYNC pattern.

Reference documents: *USB 2.0 Specification, 7.1.10.*

☐ PASS

☐ FAIL

☐ N/A

Comments:

EL_43 Hubs must not corrupt any repeated bits of the SYNC field.

Reference documents: *USB 2.0 Specification, 7.1.10.*

☐ PASS

☐ FAIL

☐ N/A

Comments:

EL_44 A hub may add at most 4 random bits to the end of the EOP field when repeating a packet.

Reference documents: *USB 2.0 Specification, 7.1.13.2.*

☐ PASS

☐ FAIL

☐ N/A

Comments:

EL_45 A hub must not corrupt any of the valid EOP bits when repeating a packet.

Reference documents: *USB 2.0 Specification, 7.1.13.2.*

☐ PASS

☐ FAIL

☐ N/A

Comments:

App. A.11 Hub CHIRP Timing — Upstream Facing Port (EL_28, EL_29, EL_31)

EL_28 Devices must transmit a CHIRP handshake no sooner than 2.5 μ s and no later than 6 ms when being reset from suspend or a full-speed state.

Reference documents: *USB 2.0 Specification*, Section 7.1.7.5.

☐ PASS

☐ FAIL

☐ N/A

Comments:

EL_29 The CHIRP handshake generated by a device must be at least 1 ms and not more than 6 ms in duration.

Reference documents: *USB 2.0 Specification*, Section 7.1.7.5.

☐ PASS

☐ FAIL

☐ N/A

Comments:

EL_31 During device speed detection, when a device detects a valid CHIRP K-J-K-J-K-J sequence, the device must disconnect its 1.5 k pull-up resistor and enable its hi-speed terminations within 500 μ s.

Reference documents: *USB 2.0 Specification*, Section 7.1.7.5.

☐ PASS

☐ FAIL

☐ N/A

Comments:

App. A.12 Hub Suspend/Resume/Reset Timing — Upstream Facing Port (EL_27, EL_28, EL_38, EL_39, EL_40)

EL_38 A device must revert to full-speed termination no later than 125 μ s after there is a 3ms idle period on the bus.

Reference documents: *USB 2.0 Specification*, Section 7.1.7.6.

☐ PASS

☐ FAIL

☐ N/A

Comments:

EL_39 A device must support the Suspend state.

Reference documents: *USB 2.0 Specification*, Section 7.1.7.6.

☐ PASS

☐ FAIL

☐ N/A

Comments:

EL_40 If a device is in the suspend state, and was operating in hi-speed before being suspended, then device must transition back to hi-speed operation within two bit times from the end of resume signaling.

Note: It is not feasible to measure the device transition back to hi-speed operation within two bit times from the end of the resume signaling. The presence of SOF at nominal 400 mV amplitude following the resume signaling is sufficient for this test.

Reference documents: *USB 2.0 Specification*, Section 7.1.7.7.

☐ PASS

☐ FAIL

☐ N/A

Comments:

EL_27 Devices must transmit a CHIRP handshake no sooner than 3.1ms and no later than 6ms when being reset from a non-suspended hi-speed mode. The timing is measured from the beginning of the last SOF transmitted before the reset begins.

Reference documents: *USB 2.0 Specification*, Section 7.1.7.5.

☐ PASS

☐ FAIL

☐ N/A

Comments:

EL_28 Devices must transmit a CHIRP handshake no sooner than 2.5 μ s and no later than 6 ms when being reset from suspend or a full-speed state.

Reference documents: *USB 2.0 Specification*, Section 7.1.7.5.

- ☐ PASS
☐ FAIL
☐ N/A

Comments:

App. A.13 Hub Test J/K, SE0_NAK — Upstream Facing Port (EL_8, EL_9)

EL_8 When either D+ or D- are driven high, the output voltage must be 400 mV \pm 10% when terminated with precision 45 Ω resistors to ground.

Reference documents: *USB 2.0 Specification*, Section 7.1.1.3.

Test	D+ Voltage (mV)	D+ Voltage (mV)
J		
K		

- ☐ PASS
☐ FAIL
☐ N/A

Comments:

EL_9 When either D+ and D- are not being driven, the output voltage must be 0 V \pm 10 mV when terminated with precision 45 Ω resistors to ground.

Reference documents: *USB 2.0 Specification*, Section 7.1.1.3.

	Voltage (mV)
D+	
D+	

- ☐ PASS
☐ FAIL
☐ N/A

Comments:

App. A.14 Hub Test J/K, SE0_NAK — Downstream Facing Ports (EL_8, EL_9)

EL_8 When either D+ or D- are driven high, the output voltage must be 400 mV $\pm 10\%$ when terminated with precision 45 Ω resistors to ground.

Reference documents: *USB 2.0 Specification*, Section 7.1.1.3.

Port	1		2		3		4		5	
Test	D+	D-	D+	D-	D+	D-	D+	D-	D+	D-
TEST_J										
TEST_K										

☐ PASS

☐ FAIL

☐ N/A

Comments:

EL_9 When either D+ and D- are not being driven, the output voltage must be 0 V ± 10 mV when terminated with precision 45 Ω resistors to ground.

Reference documents: *USB 2.0 Specification*, Section 7.1.1.3.

Port	1		2		3		4		5	
Signal	D+	D-	D+	D-	D+	D-	D+	D-	D+	D-
Measure WRT Ground (mV)										

☐ PASS

☐ FAIL

☐ N/A

Comments:

Appendix B Legacy USB Compliance Tests

App. B.1 Inrush Current Test

- **USB 2.0 Electrical Test Specification**

Inrush current test

Measure the inrush current flowing when the device is connected.

The following items are evaluated.

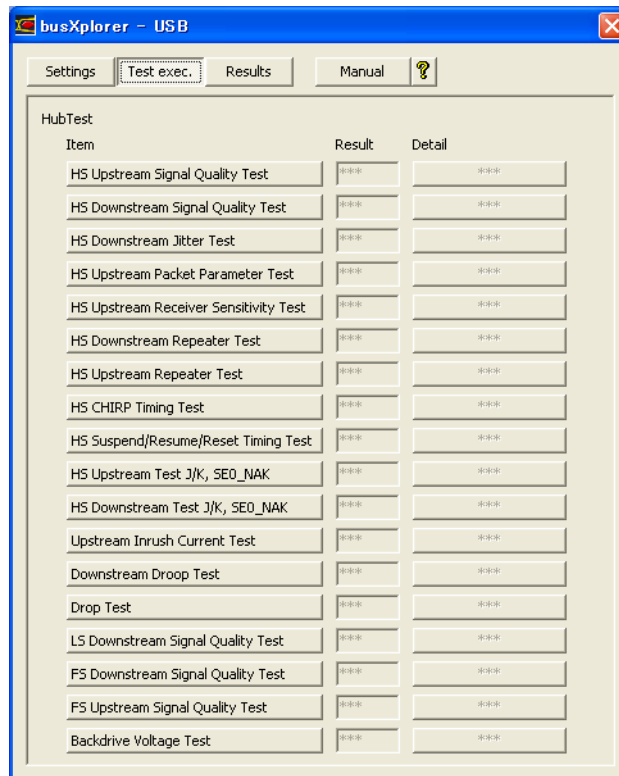
Inrush at 5.0 V: Max. 50.0uA

- **Instruments Used**

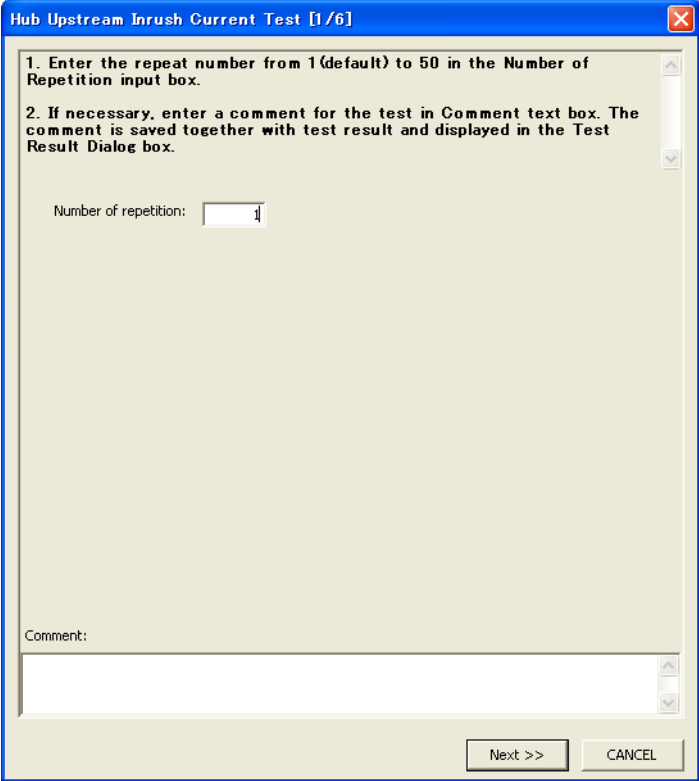
Name	Quantity
DL9240/DL9240L Digital Oscilloscope	1
701932/701933 Current Probe	1
USB-IF compliant 1 m USB 2.0 cable	1
Test bed computer	1
USB compliance test fixture	1
5 V power supply for test fixture	1

- **Executing the Test**

1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



2. Click the **[Inrush Current Test]** button in the dialog box.
The Hub Inrush Current Test dialog box is displayed.



The dialog box titled "Hub Upstream Inrush Current Test [1/6]" contains the following instructions and fields:

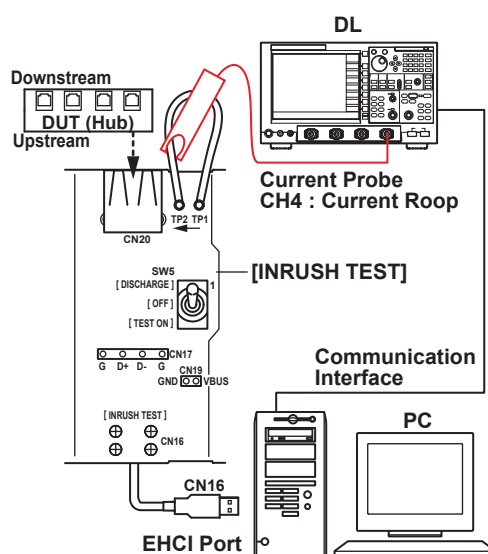
1. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.
2. If necessary, enter a comment for the test in Comment text box. The comment is saved together with test result and displayed in the Test Result Dialog box.

Number of repetition:

Comment:

Buttons: Next >> CANCEL

3. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.
4. If necessary, enter a comment for the test in Comment text box.
The comment is saved together with test result and displayed in the Test Result Dialog box.
5. Click the **[Next]** button in the dialog box of the busXplorer-USB.
A connection diagram as shown below is displayed.

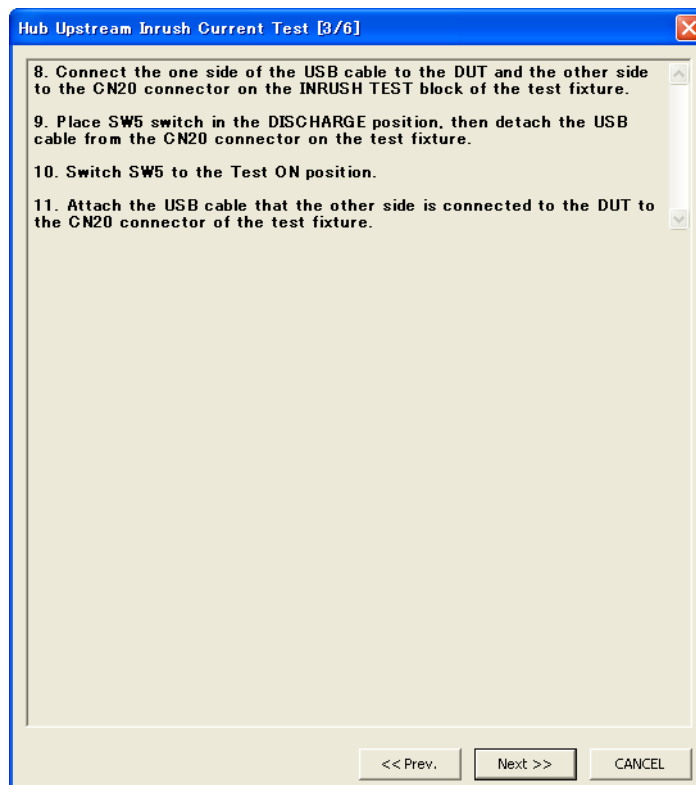


-
6. Turn ON the power to the DUT.
 7. Connect the test bed computer to the CN16 connector of the INRUSH TEST block on the test fixture.
 8. Connect a 1 m cable to the upstream port of the DUT.
When cable is connected, do not connect to the test fixture at the other side.
 9. Connect the current probe to CH4 of the digital oscilloscope.
 10. Place the tip of the current probe on the current loop of the INRUSH TEST block.
To power the current probe, use the power supply on the rear panel of the digital oscilloscope (the one installed with the /P2 option), or the model 701934 probe power supply (sold separately).

Note

After connecting the probe, heat emitted from the probe causes the offset voltage to drift. The probe should nearly stabilize about thirty minutes after applying power.

11. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box that is displayed, connect the one side of the USB cable to the DUT and the other side to the CN20 connector on the INRUSH TEST block of the test fixture.



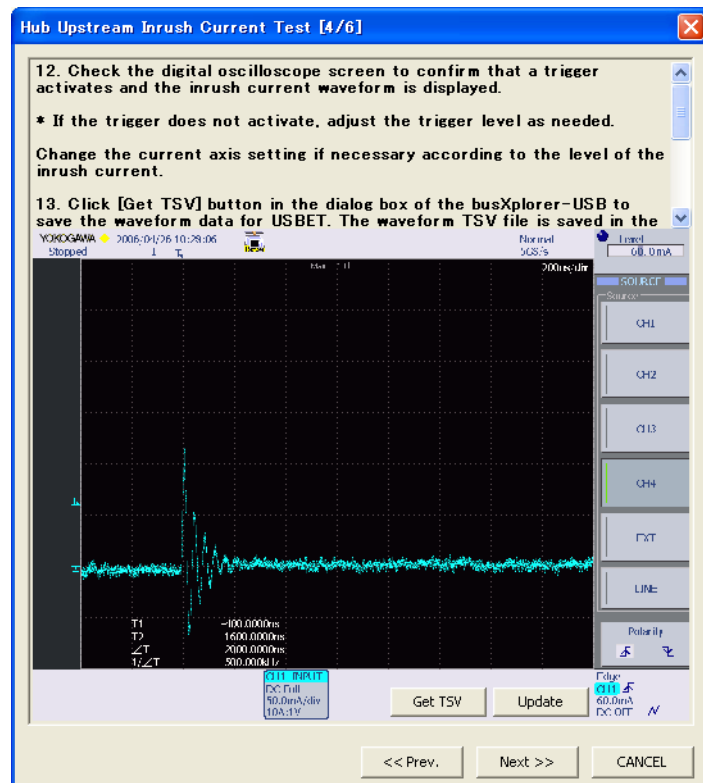
12. Place SW5 switch in the DISCHARGE position, then detach the USB cable from the CN20 connector on the test fixture.
13. Switch SW5 to the Test ON position.
14. Attach the USB cable that the other side is connected to the DUT to the CN20 connector of the test fixture.

15. Click the **[Next]** button in the dialog box of the busXplorer-USB, and then check the digital oscilloscope screen to confirm that a trigger activates and the inrush current waveform is displayed.

- If the trigger does not activate, adjust the trigger level as needed. Change the current axis setting if necessary according to the level of the inrush current.
- Click the **[Update]** button to update the image of waveform in the dialog box.

Note

If the waveform cannot be acquired until the inrush current becomes 100mA or lower, change the time/div setting of the oscilloscope and retry until it can be acquired.



16. Click **[Get TSV]** button in the dialog box of the busXplorer-USB to save the waveform data for USBET. The waveform TSV file is saved in the working folder.

17. Activate 'USB Electrical Analysis Tool (USBET)'.

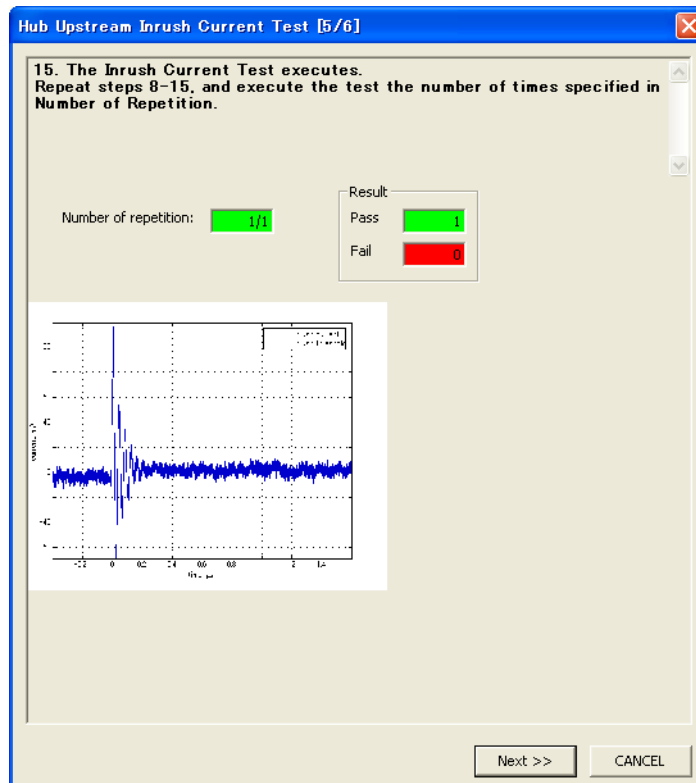
Select **[Inrush Current]** tab, click **[Browse]** button of USBET and specify the waveform data file (tsv file).

Then click **[TEST]** to start analysis. Check the test report generated by USBET and verify the result of the test.

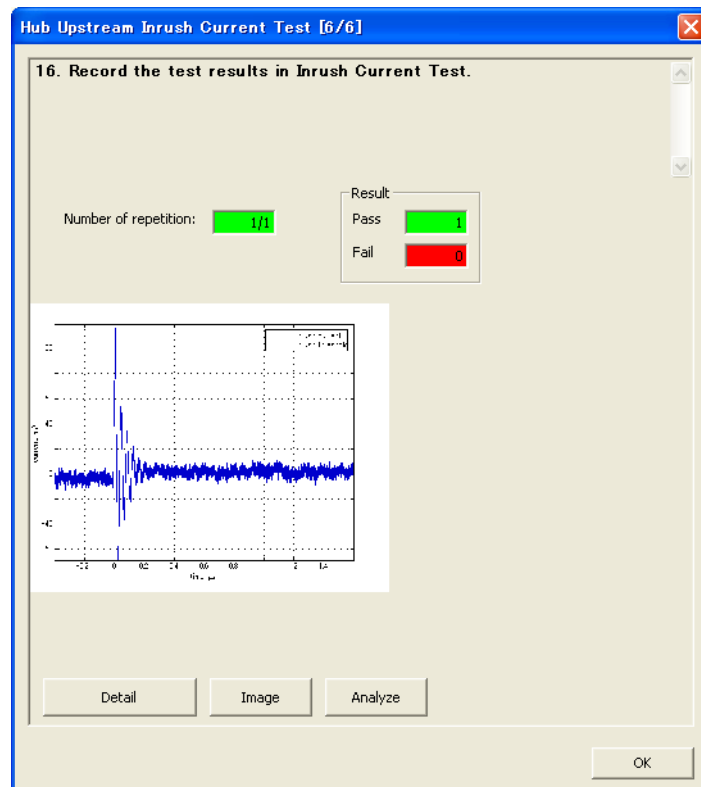
Note

For details about USBET, please refer to Appendix C of this document.

18. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box is displayed.



- 19.** Click the **[Next button]** in the dialog box of the busXplorer-USB, repeat steps 12-18, and execute the test the number of times specified in "Number of Repetition."
- When this number of tests is completed, the test results dialog box as shown below is displayed.
 - Click the [Detail] button to display the test results by Internet Explorer.
 - Click the [Image] button to display an image of the digital oscilloscope screen.
 - Click the [Analyze] button to start Xviewer and display the waveform data. Xviewer must already have been installed.



- 20.** Record the test results in Inrush Current Test.
- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission.
 - All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.

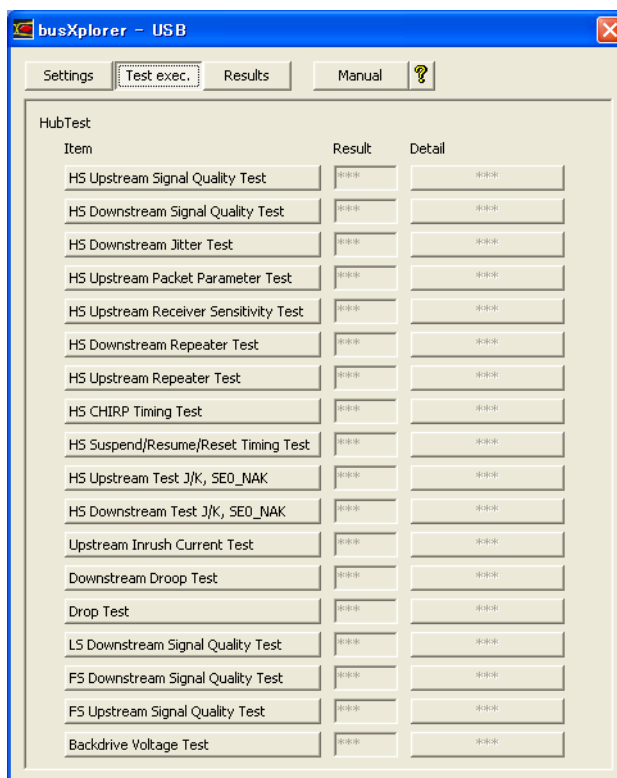
App. B.2 Downstream Droop Test

- Instruments Used

Name	Quantity
DL9240/DL9240L Digital Oscilloscope	1
PB500 Passive Probe	2
USB-IF Compliant 1m USB2.0 cable	5
Test bed computer	1
USB compliance test fixture	1
5 V power supply for test fixture	1

- Executing the Test

1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



2. Click the **[Downstream Droop Test]** button in the dialog box.
The Hub Downstream Droop Test dialog box is displayed.

Hub Downstream Droop Test [1/5]

1. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.

2. If necessary, enter a comment for the test in Comment text box. The comment is saved together with test result and displayed in the Test Result Dialog box.

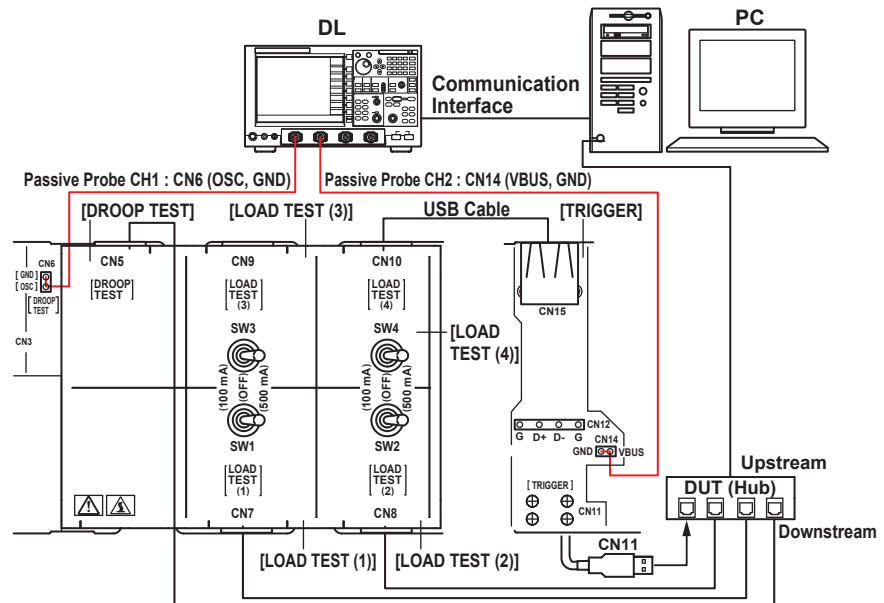
Number of repetition:

Parameter	Min.	Max.	Default
500mA:	***	330.00m V	<input type="button" value="Default"/>

Comment:

3. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.
4. If necessary, enter a comment for the test in Comment text box.
The comment is saved together with test result and displayed in the Test Result Dialog box.
5. If you wish to change the judgment range, you can edit the judgment criteria for Droop.
Default values for the judgment criteria are as follows:
VDroop
Max.: 330mV
If you click the [Default] button after changing the judgment range, the default values of the judgment range are restored.

6. Click the **[Next]** button in the dialog box of the busXplorer-USB.
A connection diagram as shown below is displayed.



7. Turn ON the power to the DUT.
8. Turn ON the power to the test fixture and confirm that the green power supply LED1 is lit.
9. Connect the test bed computer to the upstream port of the DUT with a 1m USB cable.
10. Connect the downstream port of the DUT to the CN11 connector of the TRIGGER block.
11. Connect the CN15 connector of the TRIGGER block to the CN10 connector of the LOAD TEST[4] block with a 1 m USB cable.
12. Connect CN5 of the DROOP TEST block to the other downstream port of the DUT with a 1m USB cable.
If the hub under test has two or more downstream ports, connect them to the CN7 connector on LOAD TEST[1], the CN8 connector on LOAD TEST[2], and CN9 on LOAD TEST[3].
13. Connect two PB500 passive probes, one to CH1 and the other to CH2 of the digital oscilloscope.
14. Connect the CH1 probe to OSC and GND of pin CN6 on the DROOP TEST block, and the CH2 probe to VBUS_ and GND at pin CN14 on the TRIGGER TEST block.
15. The settings for SW1 to SW4 are as follows.
Self-powered: 500 mA side
Bus-powered: 100 mA side



WARNING

- If you set SW1, SW2, SW3 and SW4 to the 500 mA position, the load resistances inside the top panel cover may become extremely hot. Do not touch them directly. After the test is finished, immediately turn them to the OFF position.
- Since the load resistance of the LOAD TEST part gets hot, after finishing this test, immediately remove the USB cable connected to connectors CN7 to CN10 and disconnect the Vbus supply from the Upstream port, or turn OFF SW1, SW2, SW3 and SW4.

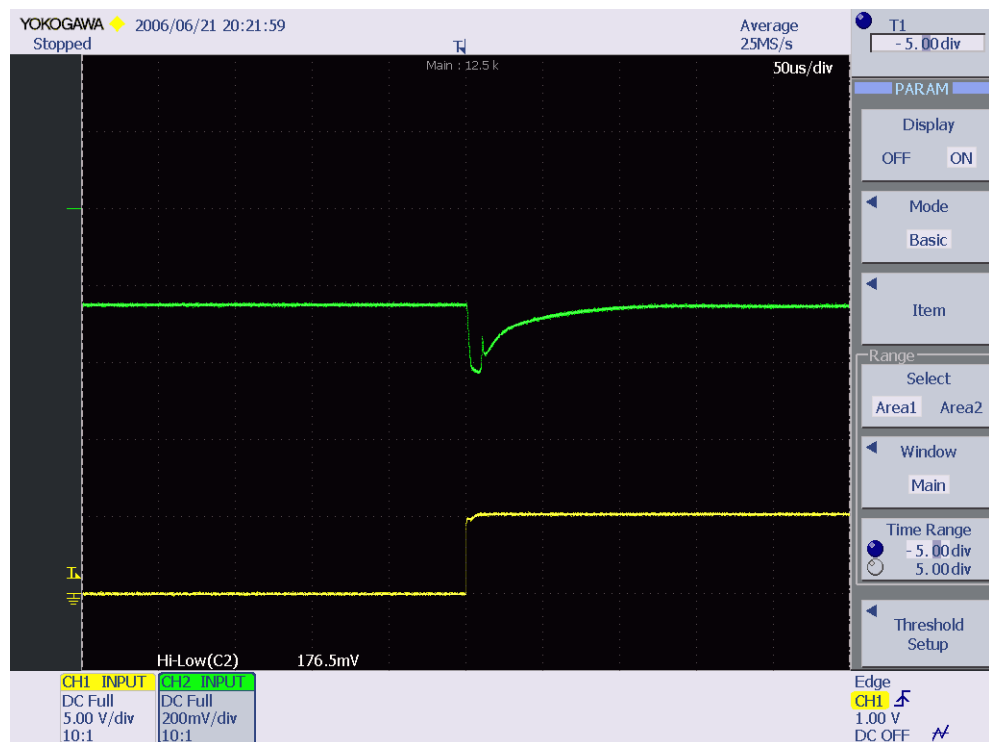
16. Click the **[Next]** button in the dialog box of the busXplorer-USB, and then check the digital oscilloscope screen to confirm that a trigger activates and that the Vbus waveform is displayed.

- If the trigger does not activate, adjust the trigger level as needed.
- Click the **[Update]** button to update the image of waveform in the dialog box of the busXplorer-USB.

17. The amplitude of the Vbus Droop voltage is measured.

The requirement is 330 mv or less.

When **[Next]** button is clicked, the measured between packets is judged and Fail message will be displayed if the result is failed.



-
- 18.** Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box is displayed.

The dialog box is titled "Hub Downstream Droop Test [4/5]". It contains the following information:

15. The Droop Test executes.
Repeat steps 13-15 and execute the test the number of times specified in Number of Repetition.

Number of repetition: 1/1

Result:

Pass	1
Fail	0

Parameter

	Min.	Max.	Result	
500mA:	***	330.00m	242.50m	V

Buttons: Next >> CANCEL

- 19.** Click the **[Next]** button in the dialog box of the busXplorer-USB, repeat steps 17-18 and execute the test the number of times specified in “Number of Repetition.”
- When this number of tests is completed, the test results dialog box as shown below is displayed.
 - Click the **[Detail]** button to display the test results by Internet Explorer.
 - Click the **[Image]** button to display an image of the digital oscilloscope screen.
 - Click the **[Analyze]** button to start Xviewer and display the waveform data. Xviewer must already have been installed.

Hub Downstream Droop Test [5/5]

16. Record the test results in Downstream Droop Test.
17. Repeat steps 1-16 for all downstream ports of the DUT.
18. Remove the passive probe from the test fixture.

Number of repetition: 1/1

Result
Pass: 1
Fail: 0

Parameter	Min.	Max.	Result	Image	Analyze
500mA:	***	330.00m	176.50m	V	...

Detail

OK

- 20.** Record the test results in Downstream Droop Test .
- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission.
 - All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.
- 21.** Repeat steps 2-20 for all downstream ports of the DUT.
- 22.** Remove the passive probe from the test fixture.

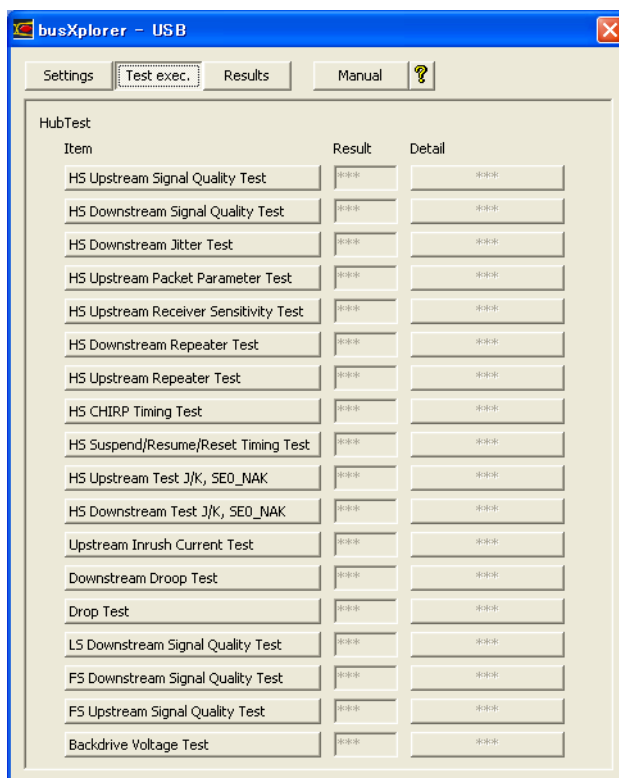
App. B.3 Drop Test

- **Instruments Used**

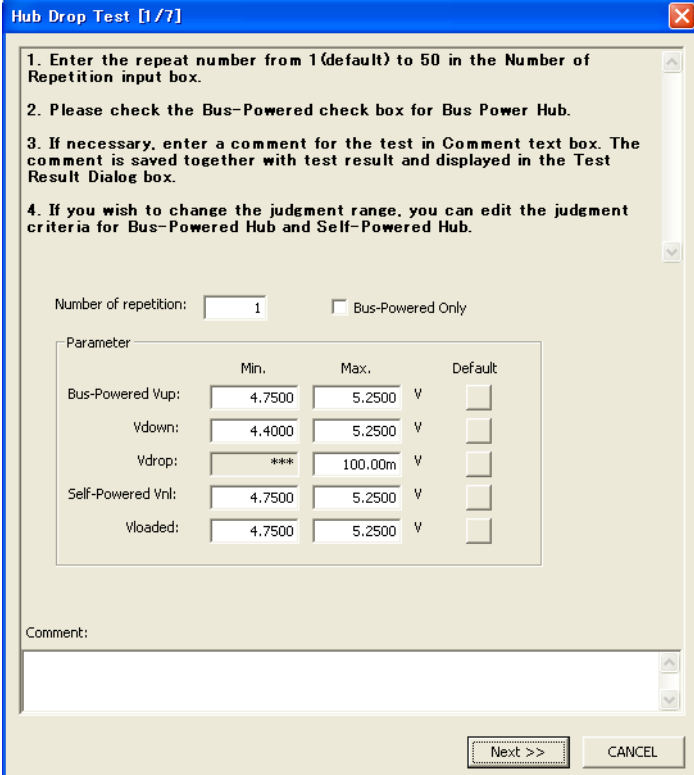
Name	Quantity
Yokogawa Meter & Instrument 3 ½ Digital Multimeter 733/734	1
USB-IF Compliant 1m USB2.0 cable	4
Test bed computer	1
USB compliance test fixture	1
5 V power supply for test fixture	1

- **Executing the Test**

1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



2. Click the **[Drop Test]** button in the dialog box.
The Hub Drop Test dialog box is displayed.



The dialog box titled "Hub Drop Test [1/7]" contains the following instructions and controls:

- 1. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.
- 2. Please check the Bus-Powered check box for Bus Power Hub.
- 3. If necessary, enter a comment for the test in Comment text box. The comment is saved together with test result and displayed in the Test Result Dialog box.
- 4. If you wish to change the judgment range, you can edit the judgment criteria for Bus-Powered Hub and Self-Powered Hub.

Number of repetition: ☐ Bus-Powered Only

Parameter	Min.	Max.	Default
Bus-Powered Vup:	<input type="text" value="4.7500"/>	<input type="text" value="5.2500"/>	<input type="checkbox"/>
Vdown:	<input type="text" value="4.4000"/>	<input type="text" value="5.2500"/>	<input type="checkbox"/>
Vdrop:	<input type="text" value="***"/>	<input type="text" value="100.00m"/>	<input type="checkbox"/>
Self-Powered Vnl:	<input type="text" value="4.7500"/>	<input type="text" value="5.2500"/>	<input type="checkbox"/>
Vloaded:	<input type="text" value="4.7500"/>	<input type="text" value="5.2500"/>	<input type="checkbox"/>

Comment:

Next >> CANCEL

3. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box
4. Please check the Bus-Powered check box for Bus Power Hub.
5. If necessary, enter a comment for the test in Comment text box.
The comment is saved together with test result and displayed in the Test Result Dialog box.

- Default values for the judgment criteria are as follows:

- ### Note

- If a cable is not fixed to the hub under test(DUT) (B plug connector installed)
Vdrop voltage: 100 mV or less
- If a cable is fixed to the hub under test(DUT) (B plug connector not installed)
Vdrop voltage: 350 mV or less

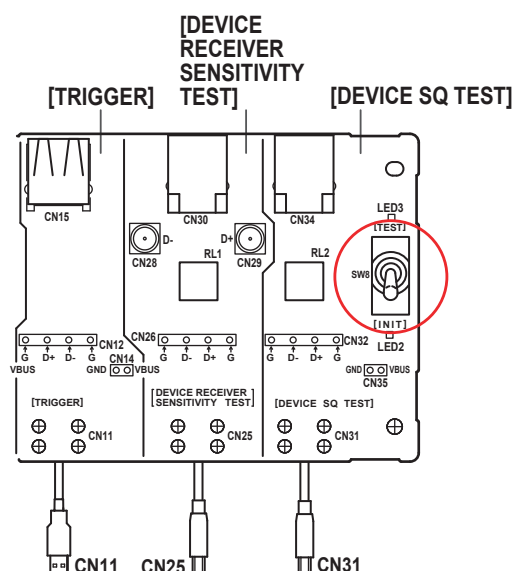
- If you click the [Default] button after changing the judgment range, the default values of the judgment range are restored.

-

Note

The digital oscilloscope is not necessary to perform this test.

8. Turn ON the power to the test fixture and confirm that the green power supply LED1 is lit.
9. Connect the test bed computer to the CN34 connector of the DEVICE SQ TEST block using a 1 m USB cable.
10. Connect the CN31 connector of the Device SQ TEST block to the upstream port of the DUT.
11. Connect the downstream port of the DUT to the CN11 connector of the TRIGGER block.
12. Connect the CN15 connector of the TRIGGER block to the CN10 connector of the LOAD TEST[4] block with a 1 m USB cable.
If the hub under test(DUT) has two or more downstream ports, connect them to the CN7 connector on LOAD TEST[1], the CN8 connector on LOAD TEST[2], and CN9 on LOAD TEST[3].
13. Click the **[Next]** button in the dialog box of the busXplorer-USB.
Following the instructions in the dialog box, place SW8 of the test fixture to the INIT position.
Verify LED2 of the test fixture is lit.



-
14. Click the **[Next]** button in the dialog box of the busXplorer-USB, use a digital multimeter to measure the Vupstream and Vdownstream voltages, and then record them to the input text box for Vupstream and Vdownstream .

[1] In case of Bus-Powered Hub, set SW1~SW4 to 100mA position.

- Vupstream voltage: Between GND and VBUS at CN35
- Vdownstream voltage: Between GND and VBUS at CN14

When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



WARNING

- If you set SW1, SW2, SW3 and SW4 to the 500 mA position, the load resistances inside the top panel cover may become extremely hot. Do not touch them directly. After the test is finished, immediately turn them to the OFF position.
 - Since the load resistance of the LOAD TEST part gets hot, after finishing this test, immediately remove the USB cable connected to connectors CN7 to CN10 and disconnect the Vbus supply from the Upstream port, or turn OFF SW1, SW2, SW3 and SW4.
-

Hub Drop Test [4/7]

11. Use a digital multimeter to measure the Vupstream and Vdownstream voltages, and then record them to the input text box for Vupstream and Vdownstream.

[1] In case of Bus-Powered Hub

Set SW1~SW4 to 100mA position.

* Vupstream voltage: Between GND and VBUS at CN35
* Vdownstream voltage: Between GND and VBUS at CN14

Vupstream: V (4.7500~5.2500)

Vdownstream: V (4.4000~5.2500)

<< Prev. Next >> CANCEL

15. Click the **[Next]** button in the dialog box of the busXplorer-USB, use a digital multimeter to measure the Vnl and Vloaded voltage, and then record them to the input text box for Vnl and Vloaded.

[2] In case of Self-Powered Hub (Turn ON the power to the DUT)

- Set SW1 to SW4 to OFF(no load) position.
Vnl voltage: Between GND and VBUS at CN14
- Then, set SW1 to SW4 to 500 mA position.
Vloaded voltage: Between GND and VBUS at CN14

Note

This test is not executed Bus-Powered only hub.

When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.



WARNING

- If you set SW1, SW2, SW3 and SW4 to the 500 mA position, the load resistances inside the top panel cover may become extremely hot. Do not touch them directly. After the test is finished, immediately turn them to the OFF position.
- Since the load resistance of the LOAD TEST part gets hot, after finishing this test, immediately remove the USB cable connected to connectors CN7 to CN10 and disconnect the Vbus supply from the Upstream port, or turn OFF SW1, SW2, SW3 and SW4.

Hub Drop Test [5/7]

12. Use a digital multimeter to measure the Vnl and Vloaded voltage, and then record them to the input text box for Vnl and Vloaded.

[2] In case of Self-Powered Hub

- * Set SW1-SW4 to OFF(no load) position.
- * Vnl voltage: Between GND and VBUS at CN14
- * Then, set SW1-SW4 to 500mA position.
- * Vloaded voltage: Between GND and Vbus at CN14

Vnl: V (4.7500~5.2500)

Vloaded: V (4.7500~5.2500)

Next >> CANCEL

16. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box is displayed.

Hub Drop Test [6/7]

13. The Drop Test executes.
Repeat steps 11-13 and execute the test the number of times specified in Number of Repetition.

Number of repetition: 1/1

Result:
Pass: 1
Fail: 0

Parameter	Min.	Max.	Result	
Bus-Powered Vup:	4.7500	5.2500	4.9100	V
Vdown:	4.4000	5.2500	4.8200	V
Vdrop:	***	100.00m	90.000m	V
Self-Powered Vnl:	4.7500	5.2500	5.0800	V
Vloaded:	4.7500	5.2500	4.8000	V

Next >> CANCEL

- 17.** Click the **[Next]** button in the dialog box of the busXplorer-USB, repeat steps 14-16 and execute the test the number of times specified in “Number of Repetition.”
- When this number of tests is completed, the test results dialog box as shown below is displayed.
 - Click the **[Detail]** button to display the test results by Internet Explorer.

The dialog box titled "Hub Drop Test [7/7]" displays the following information:

14. Record the test results in Drop Test.
15. Repeat steps 1-15 for all downstream ports of the DUT.

Number of repetition: 1/1

Result:
Pass: 1
Fail: 0

Parameter	Min.	Max.	Result	
Bus-Powered Vup:	4.7500	5.2500	4.9100	V
Vdown:	4.4000	5.2500	4.8200	V
Vdrop:	***	100.00m	90.000m	V
Self-Powered Vnl:	4.7500	5.2500	5.0800	V
Vloaded:	4.7500	5.2500	4.8000	V

Buttons: Detail, OK

- 18.** Record the test results in Drop Test .
- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission.
 - All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.
- 19.** Repeat steps 2-18 for all downstream ports of the DUT.

App. B.4 LS Downstream Signal Quality Test

- **Instruments Used**

Name	Quantity
DL9240/DL9240L Digital Oscilloscope	1
PBA2500 Active Probe	2
PBA2500 Probe Attachment	2 sets
USB-IF Compliant FS-Hub	1
USB-IF Compliant HS-Hub	3
USB-IF Compliant 5m USB2.0 cable	5
USB-IF Compliant LS Device (Mouse)	1
Test bed computer	1
USB compliance test fixture	1
5 V power supply for test fixture	1

- **Executing the Test**

1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



2. Click the **[LS Downstream Signal Quality Test]** button in the dialog box.
The Hub LS Downstream Signal Quality Test dialog box is displayed.

Hub LS Downstream Signal Quality Test [1/5]

1. Set appropriate Tier number in the Tier text box of the dialog..
Note:
* Normally, leave the Tier setting as 6.

2. Enter the repeat number from 1 (default) to 50 in the Number of

Number of repetition:

Tier

Test Point
☐ Far End
☒ Near End

Comment:

Next >> CANCEL

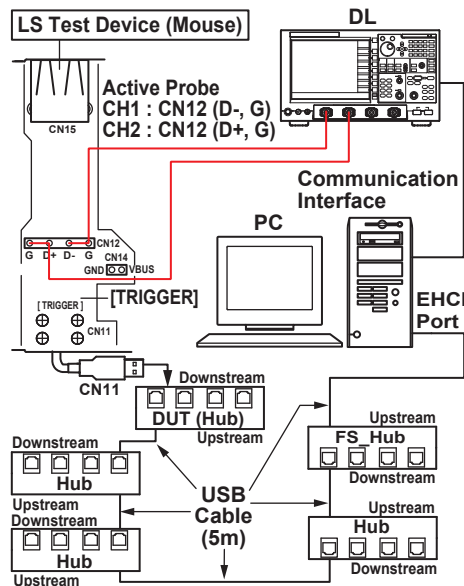
3. Set appropriate Tier number in the Tier text box of the dialog.

Note

Normally, leave the Tier setting as 6.

4. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box
5. If necessary, enter a comment for the test in Comment text box.
The comment is saved together with test result and displayed in the Test Result Dialog box.

6. Click the **[Next]** button in the dialog box of the busXplorer-USB.
A connection diagram as shown below is displayed.

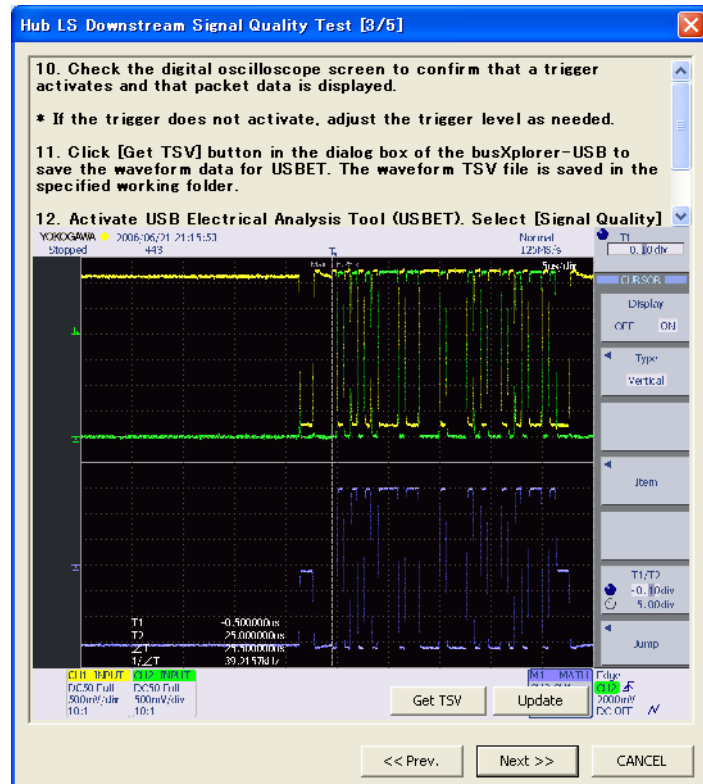


7. Turn ON the power to the DUT.
8. Link the 5 hubs together in a row using 5 m USB cables and connect one end to the test bed computer.
Connect 4 HS-hubs starting from the host controller, then connect the DUT as the fifth hub. (If the host controller uses an EHCI port, use an FS-HUB to connect to the host controller.)
9. Connect the CN11 connector of the TRIGGER block to the downstream ports of the DUT(the fifth hub).
10. Connect the LS device (mouse) to the CN15 connector.
11. Connect two PBA2500 active probes to CH1 and CH2 of the digital oscilloscope.
12. Attach the attachments on the tips of the active probes, then connect the CH1 probe to GND and D- of CN12, the CH2 probe to GND and D+ of CN12.

Note

After connecting the probe, heat emitted from the probe causes the offset voltage to drift. The probe should nearly stabilize about thirty minutes after applying power.

13. Click the **[Next]** button in the dialog box of the busXplorer-USB, and then check the digital oscilloscope screen to confirm that a trigger activates and that packet data is displayed.
- If the trigger does not activate, adjust the trigger level as needed.
 - Click the **[Update]** button to update the image of waveform in the dialog box of the busXplorer-USB.

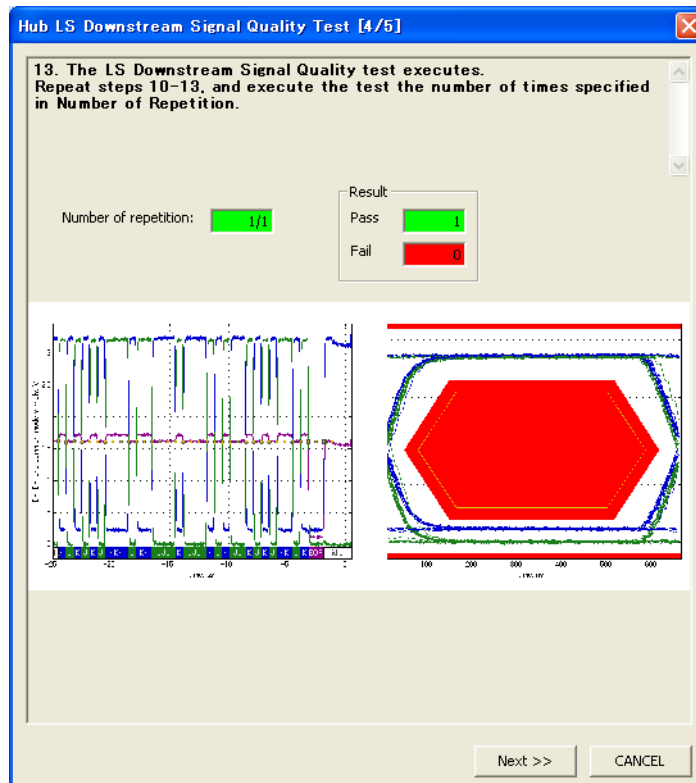


14. Click **[Get TSV]** button in the dialog box of the busXplorer-USB to save the waveform data for USBET. The waveform TSV file is saved in the specified working folder.
15. Activate 'USB Electrical Analysis Tool (USBET)'.
Select **[Signal Quality]** tab, click **[Browse]** button of USBET and specify the waveform data file (tsv file).
Set appropriate Test Type (LSNE) then click **[TEST]** to start analysis.
Check the test report generated by USBET and verify the result of the test.

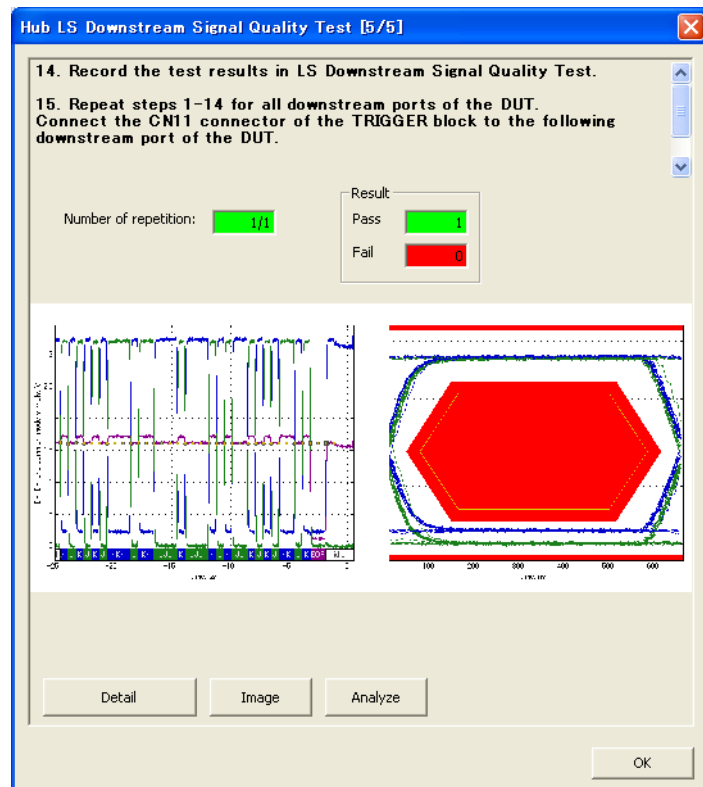
Note

For details about USBET, please refer to Appendix C of this document.

16. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box is displayed.



- 17.** Click the **[Next]** button in the dialog box of the busXplorer-USB, repeat steps 13-16, and execute the test the number of times specified in "Number of Repetition."
- When this number of tests is completed, the test results dialog box as shown below is displayed.
 - Click the **[Detail]** button to display the test results by Internet Explorer.
 - Click the **[Image]** button to display an image of the digital oscilloscope screen.
 - Click the **[Analyze]** button to start Xviewer and display the waveform data. Xviewer must already have been installed.



- 18.** Record the test results in LS Downstream Signal Quality Test.
- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission.
 - All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.
- 19.** Repeat steps 2-18 for all downstream ports of the DUT.
Connect the CN11 connector of the TRIGGER block to the following downstream port of the DUT.

App. B.5 FS Downstream Signal Quality Test

- **Instruments Used**

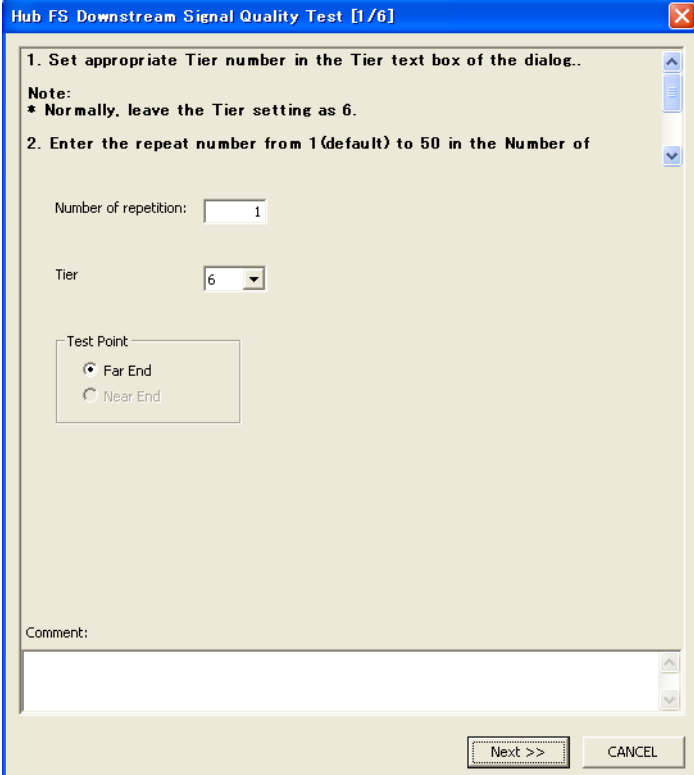
Name	Quantity
DL9240/DL9240L Digital Oscilloscope	1
PBA2500 Active Probe	2
PBA2500 Probe Attachment	2 sets
USB-IF Compliant FS-Hub	1
USB-IF Compliant HS-Hub	3
5m USB2.0 cable	6
USB-IF Compliant FS Device (Full-Speed PC Camera)	1
Test bed computer	1
USB compliance test fixture	1
5 V power supply for test fixture1	

- **Executing the Test**

1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



2. Click the **[FS Downstream Signal Quality Test]** button in the dialog box. The Hub FS Downstream Signal Quality Test dialog box is displayed.



The image shows a software dialog box titled "Hub FS Downstream Signal Quality Test [1/6]". It contains the following elements:

- Instruction 1: "1. Set appropriate Tier number in the Tier text box of the dialog.."
- Note: "Note: * Normally, leave the Tier setting as 6."
- Instruction 2: "2. Enter the repeat number from 1 (default) to 50 in the Number of"
- Input fields: "Number of repetition:" with a text box containing "1", and "Tier" with a dropdown menu showing "6".
- Test Point section: A group box containing two radio buttons, "Far End" (selected) and "Near End".
- Comment section: A label "Comment:" followed by a large empty text area.
- Buttons: "Next >>" and "CANCEL" at the bottom right.

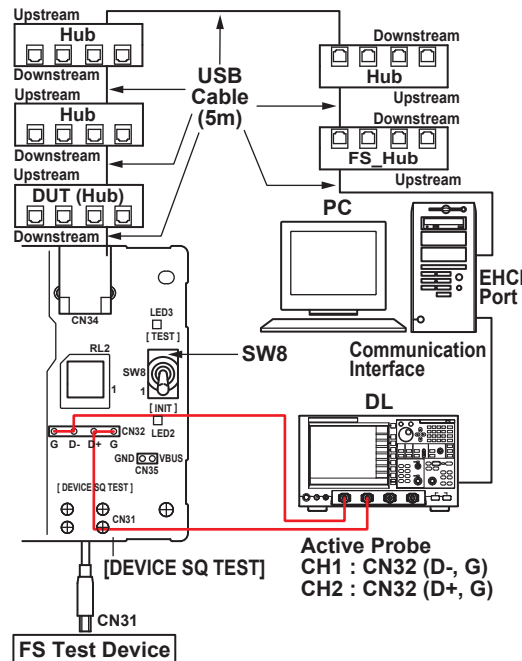
3. Set appropriate Tier number in the Tier text box of the dialog.

Note

Normally, leave the Tier setting as 6.

4. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.
5. If necessary, enter a comment for the test in Comment text box. The comment is saved together with test result and displayed in the Test Result Dialog box.

6. Click the **[Next]** button in the dialog box of the busXplorer-USB.
A connection diagram as shown below is displayed.

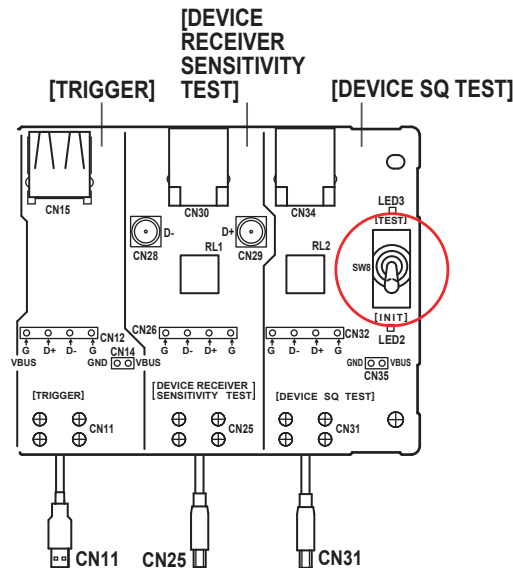


7. Turn ON the power to the DUT.
8. Turn ON the power to the test fixture and confirm that the green power supply LED1 is lit.
9. Link the 5 hubs together in a row using 5 m USB cables and connect one end to the test bed computer.
Connect 4 HS-hubs starting from the host controller, then connect the hub under test(DUT) as the fifth hub. (If the host controller uses an EHCI port, use an FS-HUB to connect to the host controller.)
10. Connect the downstream port of the DUT (the fifth hub) to the CN34 connector of the DEVICE SQ TEST block using a 5m USB cable.
11. Connect the FS device (PC Camera) to the CN34 connector.
12. Connect two PBA2500 active probes to CH1 and CH2 of the digital oscilloscope.
13. Attach the attachments on the tips of the active probes, then connect the CH1 probe to GND and D- of CN32, the CH2 probe to GND and D+ of CN32.

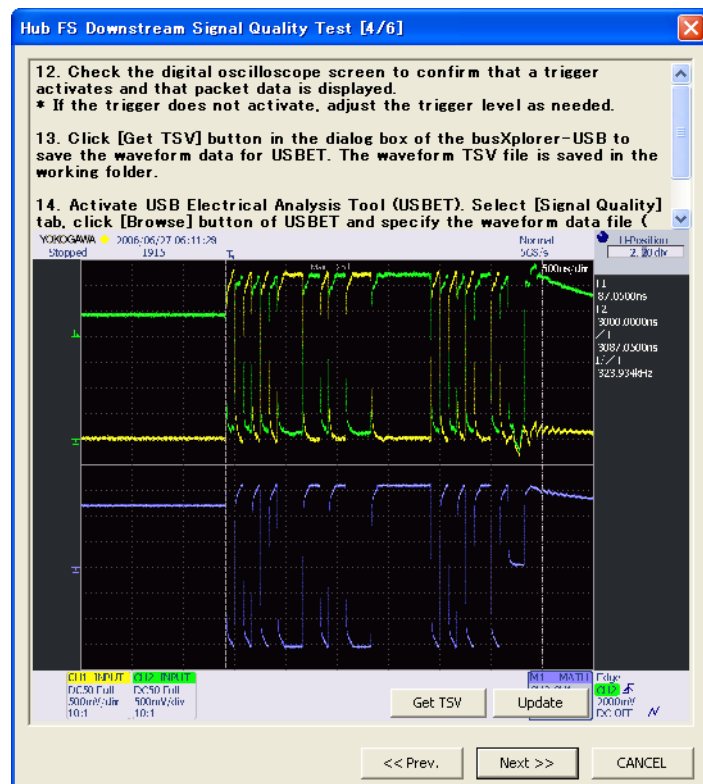
Note

After connecting the probe, heat emitted from the probe causes the offset voltage to drift. The probe should nearly stabilize about thirty minutes after applying power.

14. Click the **[Next]** button in the dialog box of the busXplorer-USB.
- Following the instructions displayed in the dialog box, place SW8 of the test fixture to the INIT position.
- Verify LED2 of the test fixture is lit.



15. Click the **[Next]** button in the dialog box of the busXplorer-USB, and then check the digital oscilloscope screen to confirm that a trigger activates and that packet data is displayed.
- If the trigger does not activate, adjust the trigger level as needed.
 - Click the [Update] button to update the image of waveform in the dialog box.

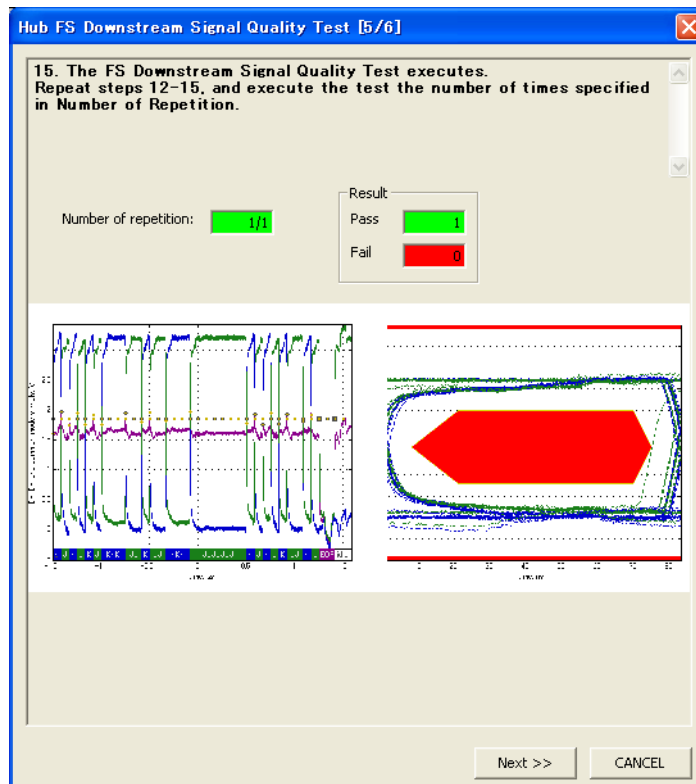


16. Click **[Get TSV]** button in the dialog box of the busXplorer-USB to save the waveform data for USBET. The waveform TSV file is saved in the working folder.
17. Activate 'USB Electrical Analysis Tool (USBET)'.
Select **[Signal Quality]** tab, click **[Browse]** button of USBET and specify the waveform data file (tsv file).
Set appropriate Test Type (FSFE) then click **[TEST]** to start analysis.
Check the test report generated by USBET and verify the result of the test.

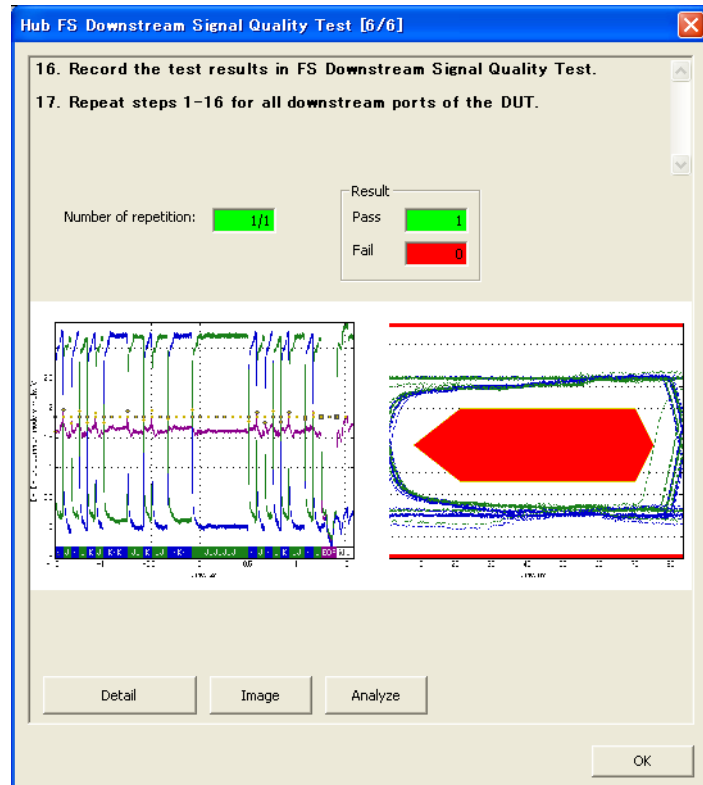
Note

For details about USBET, please refer to Appendix C of this document.

18. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box is displayed.



- 19.** Click the **[Next]** button in the dialog box of the busXplorer-USB, repeat steps 15-18, and execute the test the number of times specified in "Number of Repetition."
- When the number of tests is completed, the test results dialog box as shown below is displayed.
 - Click the **[Detail]** button to display the test results by Internet Explorer.
 - Click the **[Image]** button to display an image of the digital oscilloscope screen.
 - Click the **[Analyze]** button to start Xviewer and display the waveform data. Xviewer must already have been installed.



- 20.** Record the test results in FS Downstream Signal Quality Test.
- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission.
 - All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.
- 21.** Repeat steps 2-20 for all downstream ports of the DUT.
Connect the CN34 connector of the DEVICE SQ TEST block to the following downstream port of the DUT.

App. B.6 FS Upstream Signal Quality Test

- **Instruments Used**

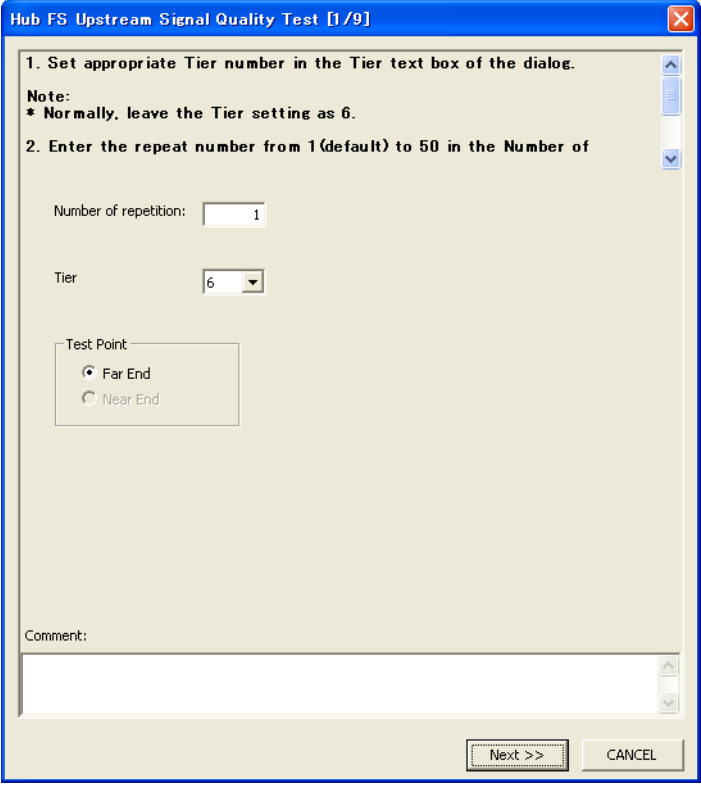
Name	Quantity
DL9240/DL9240L Digital Oscilloscope	1
PBA2500 Active Probe	3
PBA2500 Probe Attachment	3 sets
USB-IF Compliant FS-Hub	1
USB-IF Compliant HS-Hub	3
USB-IF Compliant 5m USB2.0 cable	5
USB-IF Compliant FS Device (Full-Speed PC Camera)	1
Test bed computer	1
USB compliance test fixture	1
5 V power supply for test fixture	1

- **Executing the Test**

1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



2. Click the **[FS Upstream Signal Quality Test]** button in the dialog box.
The Hub FS Upstream Signal Quality Test dialog box is displayed.



The image shows a software dialog box titled "Hub FS Upstream Signal Quality Test [1/9]". It contains the following elements:

- Instructions: "1. Set appropriate Tier number in the Tier text box of the dialog." and "2. Enter the repeat number from 1 (default) to 50 in the Number of".
- Note: "Note: * Normally, leave the Tier setting as 6."
- Input fields: "Number of repetition:" with a text box containing "1", and "Tier" with a dropdown menu showing "6".
- Test Point section: A group box containing two radio buttons, "Far End" (selected) and "Near End".
- Comment: A text area labeled "Comment:".
- Buttons: "Next >>" and "CANCEL" at the bottom right.

3. Set appropriate Tier number in the Tier text box of the dialog.

Note

Normally, leave the Tier setting as 6.

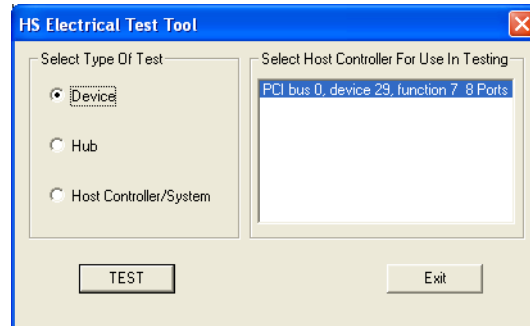
4. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.
5. If necessary, enter a comment for the test in Comment text box.
The comment is saved together with test result and displayed in the Test Result Dialog box.

- Click the **[Next]** button in the dialog box of the busXplorer-USB. A connection diagram as shown below is displayed.

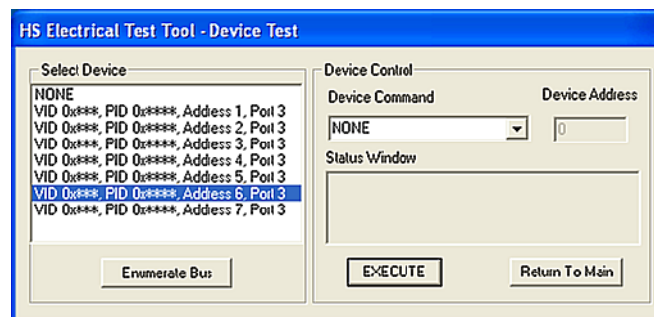
- 7.** Turn ON the power to the DUT.
- 8.** Link the 5 hubs together in a row using 5 m USB cables and connect one end to the test bed computer.
Connect the hubs in the order Hi-Speed hub, Full-Speed hub, then three Hi-Speed hubs with the first Hi-Speed hub closest to the test bed computer.
- 9.** Connect the CN16 connector of the test fixture's INRUSH block and CN11 of the TRIGGER block to the 4th HUB's downstream ports.
- 10.** Connect the upstream port of the DUT to the CN20 connector using a 5 m USB cable and the FS device (PC Camera) to the CN15 connector.
- 11.** Connect three PBA2500 active probes to CH1, CH2 and CH3 of the digital oscilloscope.
- 12.** Attach the attachments on the tips of the active probes, then connect the CH1 probe to D- and G of CN17, the CH2 probe to D+ and G of CN17, and the CH3 probe to D+ and G of the connector at CN12.

- 13.** Place SW5 to the Test ON position.

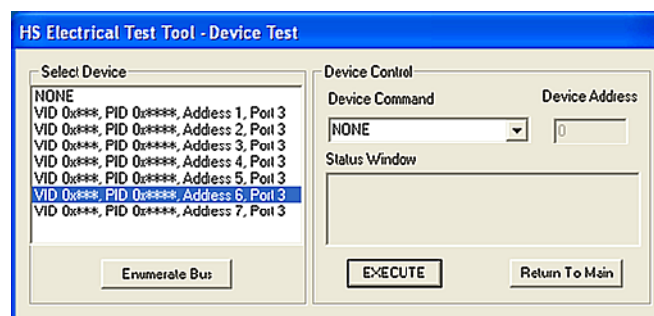
14. Click the **[Next]** button in the dialog box of the busXplorer-USB.
- Following the instructions in the dialog box of the busXplorer-USB, invoke the HS Electrical Test Tool on the test bed computer.
- Select Device under Select Type Of Test in the HS Electrical Test Tool, and click the **[TEST]** button.



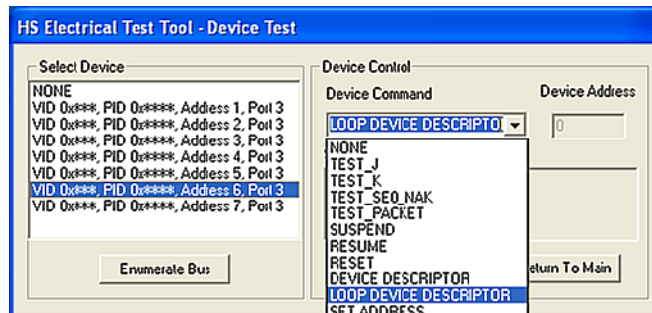
15. Click the **[Next]** button in the dialog box of the busXplorer-USB.
- Following the instructions in the dialog box that is displayed, start the HS Electrical Test Tool, and then confirm that the VID, PID, connected address, and port of the DUT are displayed under Select Device.
- If not already running, start the HS Electrical Test Tool. Select Device under Select Type of Test, click the TEST button, then confirm the above.



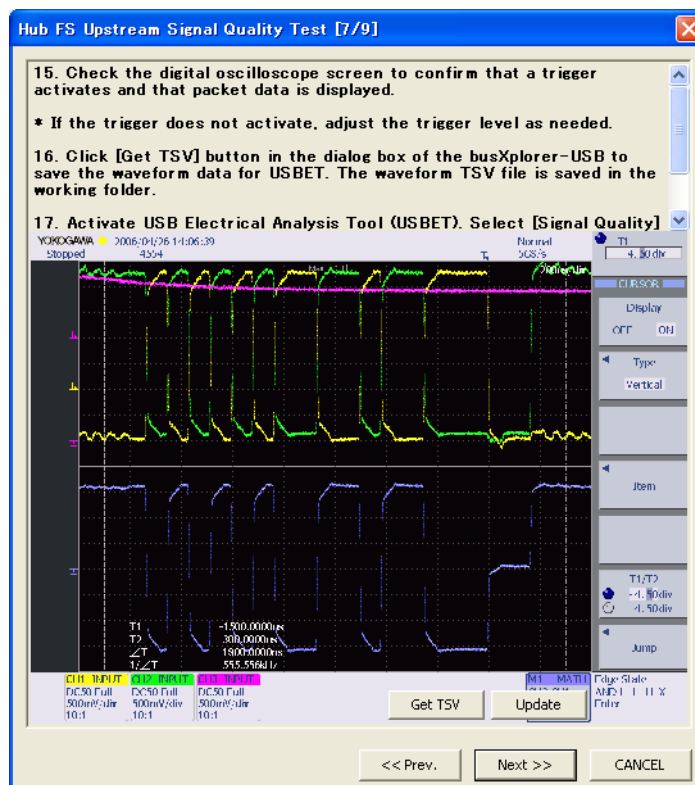
16. Click the **[Next]** button in the dialog box of the busXplorer-USB.
- Following the instructions in the dialog box that is displayed, click the **[Enumerate Bus]** button of HS Electrical Test Tool.



17. Click the **[Next]** button in the dialog box of the busXplorer-USB, select VID of DUT from the Select Device list then select LOOP DEVICE DESCRIPTOR from the Device Command drop down menu in the HS Electrical Test Tool, then click the **[EXECUTE]** button.



18. Click the **[Next]** button in the dialog box of the busXplorer-USB, and then check the digital oscilloscope screen to confirm that a trigger activates and that packet data is displayed.
 - If the trigger does not activate, adjust the trigger level as needed.
 - Click the [Update] button to update the image of waveform in the dialog box.



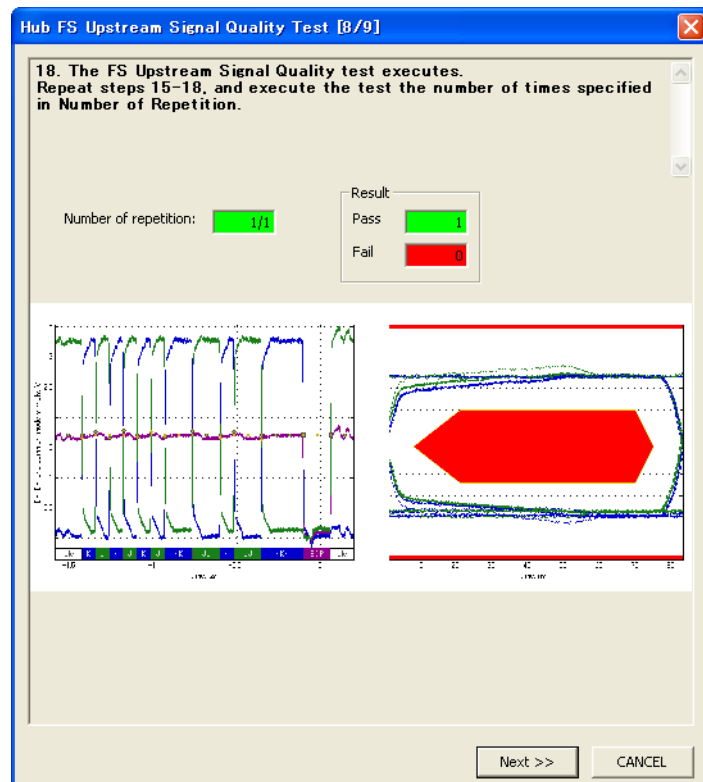
19. Click **[Get TSV]** button in the dialog box of the busXplorer-USB to save the waveform data for USBET. The waveform TSV file is saved in the working folder.

-
- 20.** Activate 'USB Electrical Analysis Tool (USBET)'.
Select [Signal Quality] tab, click **[Browse]** button of USBET and specify the waveform data file (tsv file).
Set appropriate Test Type (FSFE) then click **[TEST]** to start analysis.
Check the test report generated by USBET and verify the result of the test.

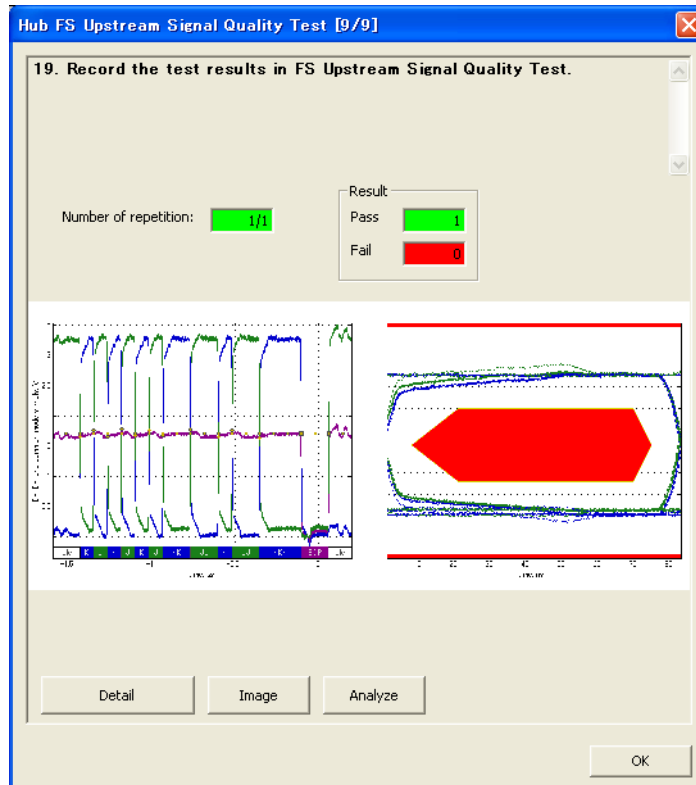
Note

For details about USBET, please refer to Appendix C of this document.

- 21.** Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box is displayed.



- 22.** Click the **[Next]** button in the dialog box of the busXplorer-USB, repeat steps 18-21, and execute the test the number of times specified in “Number of Repetition.”
- When the number of tests is completed, the test results dialog box as shown below is displayed.
 - Click the [Detail] button to display the test results by Internet Explorer.
 - Click the [Image] button to display an image of the digital oscilloscope screen.
 - Click the [Analyze] button to start Xviewer and display the waveform data. Xviewer must already have been installed.



- 23.** Record the test results in FS Upstream Signal Quality Test.
- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission
 - All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.

App. B.7 Backdrive Voltage Test

- Instruments Used

Name	Quantity
Yokogawa Meter & Instrument 3 ½ Digital Multimeter 733/734	1
USB-IF Compliant 1m USB2.0 cable	1
Test bed computer	1
USB compliance test fixture1	
5 V power supply for test fixture	1

- Executing the Test

1. Click the **[Test exec.]** button in the busXplorer-USB to display the Hub Test selection dialog box.



2. Click the **[Backdrive Voltage Test]** button in the dialog box.
The Hub Backdrive Voltage Test dialog box is displayed.

Hub Backdrive Voltage Test [1/7]

1. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.

2. If necessary, enter a comment for the test in Comment text box. The comment is saved together with test result and displayed in the Test Result Dialog box.

Number of repetition:

Parameter	Min.	Max.	Default
Before enum.: Vbus	<input type="text" value="***"/>	<input type="text" value="400.00m"/>	<input type="checkbox"/>
D+	<input type="text" value="***"/>	<input type="text" value="400.00m"/>	<input type="checkbox"/>
D-	<input type="text" value="***"/>	<input type="text" value="400.00m"/>	<input type="checkbox"/>
After enum.: Vbus	<input type="text" value="***"/>	<input type="text" value="400.00m"/>	<input type="checkbox"/>
D+	<input type="text" value="***"/>	<input type="text" value="400.00m"/>	<input type="checkbox"/>
D-	<input type="text" value="***"/>	<input type="text" value="400.00m"/>	<input type="checkbox"/>

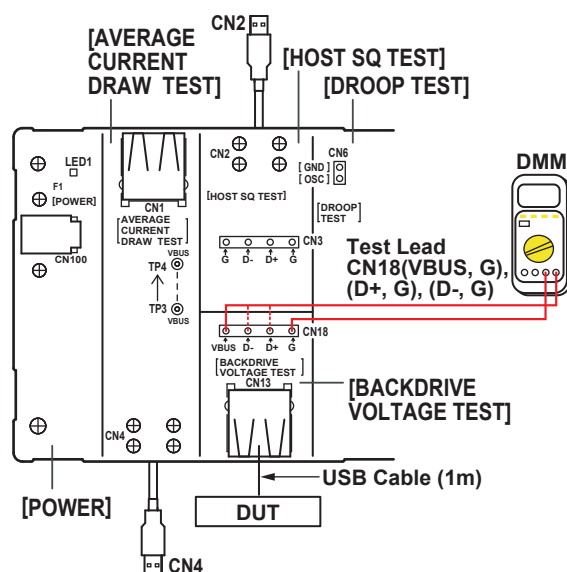
Comment:

Next >> CANCEL

3. Enter the repeat number from 1 (default) to 50 in the Number of Repetition input box.
4. If necessary, enter a comment for the test in Comment text box.
The comment is saved together with test result and displayed in the Test Result Dialog box.
5. If you wish to change the judgment range, you can edit the judgment criteria.
Default values for the judgment criteria are as follows:
 - Before Enumerate
Vbus Max.: 400 mV
D+ Max.: 400 mV
D- Max.: 400 mV
 - After Enumerate
Vbus Max.: 400 mV
D+ Max.: 400 mV
D- Max.: 400 mV

If you click the [Default] button after changing the judgment range, the default values of the judgment range are restored.

6. Click the **[Next]** button in the dialog box of the busXplorer-USB.
A connection diagram as shown below is displayed.



Note

Digital oscilloscope is not necessary to perform this test.

7. Connect the upstream port of the DUT to the CN13 connector of the BACKDRIVE VOLTAGE TEST block using a 1 m USB cable.

Note

Do not connect the test bed computer to upstream port of the DUT at present.

8. Click the **[Next]** button in the dialog box of the busXplorer-USB, and then use a digital multimeter to measure the Vbus, D+ and D- voltages before Enumerate, and then enter the measured values in the text boxes. All voltages must be less than or equal to 400mV.

Vbus voltage: Between GND and Vbus at CN18

D+ voltage: Between GND and D+ at CN18

D-voltage: Between GND and D- at CN18

When [Next] button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.

Hub Backdrive Voltage Test [3/7]

5. Use a digital multimeter to measure the Vbus, D+ and D- voltages before Enumerate, and then enter the measured values in the text boxes. All voltages must be less than or equal to 400mV.

- * Vbus voltage: Between GND and Vbus at CN18
- * D+ voltage: Between GND and D+ at CN18
- * D-voltage: Between GND and D- at CN18

Vbus V (Max. 400.00mV)

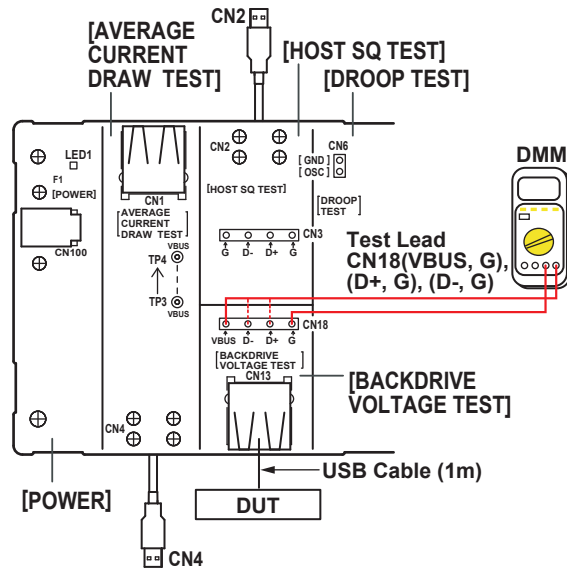
D+ V (Max. 400.00mV)

D- V (Max. 400.00mV)

<< Prev. Next >> CANCEL

9. Detach the USB cable that is connected to CN13 of the BACKDRIVE VOLTAGE TEST block.
10. Connect the test bed computer to the upstream port of the DUT using a USB cable.

11. After Enumeration, detach the USB cable that is connected to the test bed computer, and connect it to the CN13 of the BACKDRIVE VOLTAGE TEST block.



12. Click the **[Next]** button in the dialog box of the busXplorer-USB. Using a digital multimeter, measure the Vbus, D+ and D- voltage after Enumeration. Then input them to the text boxes in the dialog box. All voltages must be less than or equal to 400mV.

Vbus voltage: Between GND and Vbus at CN18

D+ voltage: Between GND and D+ at CN18

D-voltage: Between GND and D- at CN18

When **[Next]** button is clicked, the measured value is judged and Fail message will be displayed if the result is failed.

Hub Backdrive Voltage Test [5/7]
✖

7. Detach the USB cable that is connected to CN13 of the Backdrive Voltage Test block.

8. Connect the test bed computer to the upstream port of the DUT using a USB cable.

9. After Enumeration, detach the USB cable that is connected to the test bed computer, and connect it to the CN13 of the Backdrive Voltage Test block.

Vbus

V (Max. 400.00mV)

D+

V (Max. 400.00mV)

D-

V (Max. 400.00mV)

<< Prev.
Next >>
CANCEL

13. Click the **[Next]** button in the dialog box of the busXplorer-USB.
The test results dialog box is displayed.

Hub Backdrive Voltage Test [6/7]

10. The Backdrive Voltage Test executes.
Repeat steps 4-10, and execute the test the number of times specified in Number of Repetition.

* If the repeat number is set to 2 or more, power cycle the hub under test(DUT) after the each test is completed.

Number of repetition: 1/1

Result:
Pass: 1
Fail: 0

Parameter	Min.	Max.	Result
Before enum.: Vbus	***	400.00m	1.2000m V
D+	***	400.00m	0.0000 V
D-	***	400.00m	0.0000 V
After enum.: Vbus	***	400.00m	17.600m V
D+	***	400.00m	0.0000 V
D-	***	400.00m	0.0000 V

Next >> CANCEL

14. Click the **[Next]** button in the dialog box, repeat steps 6-13, and execute the test the number of times specified in “Number of Repetition.”

- If the repeat number is set to 2 or more, power cycle the hub under test(DUT) after the each test is completed.
- When this number of tests is complete, the test results dialog as below is displayed.
- Click the Detail button to display the test results by Internet Explorer.

Hub Backdrive Voltage Test [7/7]

11. Record the test results in Backdrive Voltage Test.

Number of repetition: 1/1

Result

Pass 1

Fail 0

Parameter	Min.	Max.	Result
Before enum.: Vbus	***	400.00m	1.2000m V
D+	***	400.00m	0.0000 V
D-	***	400.00m	0.0000 V
After enum.: Vbus	***	400.00m	17.600m V
D+	***	400.00m	0.0000 V
D-	***	400.00m	0.0000 V

Detail

OK

15. Record the test results in Backdrive Voltage Test.

- Appendix A contains the test result entry form for this test procedure. If necessary, please make copies of Appendix A for use as test record documentation for compliance test submission.
- All files created during tests are saved in the directory specified as the working folder for the busXplorer-USB.

Appendix C USB Electrical Analysis Tool (USBET)

App. C.1 About USBET

In this document, USB Electrical Analysis Tool (USBET) is used to perform Low-Speed/ Full-Speed/Hi-Speed Signal Quality Test and Inrush Current Test.

USBET is official analysis tool of USB-IF and downloadable from the following USB-IF site.

<http://www.usb.org/members/compliance>

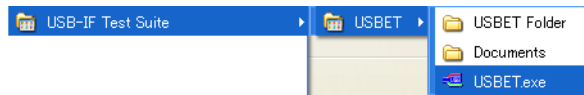
(USBET is available only for Member of USB-IF.)

Please refer to the 'USBET Installation.rtf' of USBET software package to install the software.

App. C.2 How to start USBET

USBET can be started by either way of the following operations.

1. Execute (Installed Directory)\USBET.EXE
2. From start menu, click and execute USBET.exe



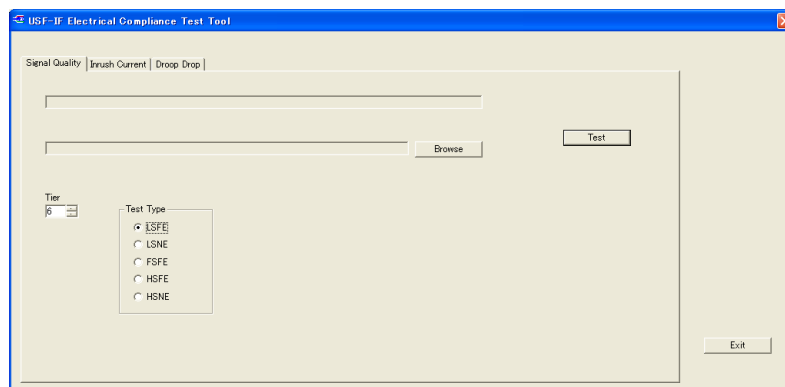
App. C.3 Low-Speed/Full-Speed/Hi-Speed Signal Quality Test

1. Click and select 'Signal Quality' tab and check the appropriate Test Type.

Test Type	Description	Tier
LSFE	Low Speed Signal Quality Test Test Point Far End	(6)
LSNE	Low Speed Signal Quality Test Test Point Near End	(6)
FSFE	Full Speed Signal Quality Test Test Point Far End	(6)
HSFE	High Speed Signal Quality Test Test Point Far End	NA
HSNE	High Speed Signal Quality Test Test Point Near End	NA

2. Setting the Hub Tier number

Unlike FS electrical tests, the HS electrical test are not performed behind the maximum number of nested hubs. So the tier level is not applicable for HS tests. For FS/LS tests, set the appropriate number (normally, 6 is specified).



3. Click **[Browse]** button and select the target tsv file.
4. Click **[Test]** button and execute signal quality analysis.
After several seconds, test report in html format will be automatically displayed on the screen. Generated report and related files are saved at the same folder where tsv file is located.

App. C.4 Inrush Current Test

1. Click and select 'Inrush Current' tab.
2. Click **[Browse]** button and select the target tsv file
3. Click **[Test]** button and execute inrush current analysis.
After several seconds, test report in html format will be automatically displayed on the screen. Generated report and related files are saved at the same folder where tsv file is located.